

**A LOW COST TELLUROMETER**

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of Cape Town in fulfilment  
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## ABSTRACT

This thesis describes the development of a low-cost microwave electronic distance measurement instrument using the Tellurometer phase-measurement principle. In a simplified form the instrument can be configured as a full-duplex 9 600 Baud datalink.

The Tellurometer was invented in 1957 by the late Dr. Trevor Wadley of the National Institute of Telecommunications Research. Since then there has been a continuous development of Tellurometers that are used world-wide in the surveying profession. Sophisticated instruments are now available, but this development has been accompanied by increased costs and complexity.

There is a growing need in underdeveloped countries for a simple low-cost microwave Tellurometer with good performance and maintainability. These countries survey with low budgets, cannot afford expensive equipment and do not necessarily require all the features and performance of today's instruments.

To meet this need it has been the objective of this work to develop a Tellurometer with a range of 10 m to 15 km, with an accuracy in the order of 3 cm, and to keep the materials cost to within R700 per instrument. This has been reached by reducing circuit complexity, current consumption, and cost to a minimum, without compromising the required performance. Only essential features have been included, except where their inclusion has not compromised the cost.

The use of a single-chip microprocessor, a simple narrow-band pattern-synthesiser, a low-cost microwave source, low-power technology and a very simple mechanical arrangement has resulted in a cheap simple instrument. Built-in test features of the software allow sophisticated maintenance with a minimum of test equipment.

**To My Father  
Dr. John Paul Marsden  
(for my education)**

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## CONTENTS

Declaration	i
Abstract	ii
Dedication	iii
Acknowledgements	iv
Contents	v
List of Illustrations	viii
List of Abbreviations and Symbols	x

### CHAPTER 1 Introduction

Subdivision of the Thesis	1
History of the Project	3
Instrument Cost	5
Instrument Specification	5

### CHAPTER 2 General Description

The Tellurometer Principle	6
Mechanical Arrangement of the Micromin	10
The Micromin in the Tellurometer Configuration	11
Instrument Operation	14
Built in Test Features	14
- Instrument Alignment	14
- Phase Measurement of one Pattern at a time	15

## **CHAPTER 3            Datalink Configuration**

The Micromin in the Datalink Configuration	16
Development of the Microwave Source	17
The Mixer Mount	20
The Gain of the Horn Antenna	23
Noise Figure of the Receiver	24
Impedance Matching of the Microwave Source Assembly	25
Maximum Range of the Micromin	27
Dynamic Range of the Receiver	28
Intermediate-Frequency Stage	29
The Autotune	32
The Modem and Speech Circuits	36
Microwave Source Power Supply	43
References for the Formulae	44

## **CHAPTER 4            Modulator and Synthesiser**

The Modusynth	45
The Loading Sequence of the Synthesiser	48
The Sample-and-Hold Phase Detector	49
The Notch Filter	52
Synthesiser Locking Time	53
The Output Spectrum	54
The Modulator	55
The Pattern Set	59

## **CHAPTER 5            Microprocessor and Phase Counter**

The Microprocessor	62
TCXO Locking	65
The Phase Counter	67
The Software	70
Program Timing	73
Data Transmission and Reception	74
The Measurement Frame	75

## **CHAPTER 6            Parameters Affecting Performance**

Antenna Swing	77
Ground Swing	82
Contamination	88
Cyclic Error	88
Synthesiser Noise	89
Microprocessor Noise	90
Data and Speech	91
Measurement of Phase Noise on the Comparison Signal	91
References for the Formulae	92
<b>CONCLUSION</b>	<b>93</b>
<b>BIBLIOGRAPHY</b>	<b>94</b>
<b>APPENDIX A            Mathematical Analysis</b>	
Mathematical Analysis of the Measurement Process	97
Absolute Pattern Pairs	99
Difference Pattern Pairs	104
Compensating for $\delta t$ Errors by Straddling	108
<b>APPENDIX B            Meteorological Formulae</b>	
Meteorological Formulae	110
Met. Calculation Program for the HP41C Calculator	111
Constants and Conversions for use with the Micromin	113
References for the Formulae	114
<b>APPENDIX C            Field-Trial Results</b>	
Cyclic Error	115
Accuracy	117
Range Performance	123
<b>APPENDIX D            Software Listing</b>	<b>126</b>

## List of Illustrations

2-1	Transit Path Time and Phase Measurement	7
2-2	Mechanical Arrangement of the Micromin	10
2-3	Block diagram of the Tellurometer Configuration	11
3-1	Block diagram of the Datalink Configuration	16
3-2	Tuning Curve of Source #1378	18
3-3	Tuning Curve of Source #1379	19
3-4	The Mixer Waveguide Mount	20
3-5	The Microwave Source and Mixer Assembly	21
3-6	The Tuning and Power Curves of the Microwave Assemblies	22
3-7	Measurement of the Mixer Mount Impedance Matching	25
3-8	Gain Distribution in the IF front-end	29
3-9	Intermediate-Frequency Stage, circuit diagram	30
3-10	Output Configuration and Waveform of the Squarer	31
3-11	The Autotune, circuit diagram	33
3-12	Circuits and Frequency Response of Modem Filters	37
3-13	Modem and Speech, Circuit Diagram	38
3-14	Microwave Source Power Supply, circuit diagram	43
4-1	Modusynth, circuit diagram	47
4-2	The Loading Sequence of the Synthesiser	48
4-3	The Sample-and-Hold Timing Diagram	49
4-4	Notch Filter Circuit and Frequency Response	52
4-5	Synthesiser Locking Time	53
4-6	Modusynth Output Spectrum	54
4-7	Modulator Filter Frequency Response	56
5-1	Microprocessor and Phase Counter, circuit diagram	63
5-2	TCXO Configuration in Master and Remote	66
5-3	Phase Counter Circuit and Timing Diagram	68
5-4	Software Operation and Stack Depth	71
5-5	The Measurement Frame Cycle	75

## List of Illustrations, continued

6-1	Phase Centre of the Horn Antenna	79
6-2	Excess Path Length of the Horn Antenna	80
6-3	Ground Reflection Geometry	82
6-4	Ground Reflection Error vs. Excess Path Length	84
6-5	Envelope of Ground Reflection Error	84
6-6	Excess Path Length and Ground Illumination	86
6-7	Error due to Instruments Aligned on a Reflection	87
6-8	"Star" Power Supply Distribution	90
6-9	Phase Noise on the 39 KHz Phase Comparison Signal	91
C-1	Cyclic Contamination	116
C-2	Zero-Correction	118
C-3	Pointing Error	120
C-4	Pattern Analysis	122
C-5	Range Performance	124
D-1	Memory Map of the Microprocessor	126

## List of Abbreviations and Symbols

$A_e$	Horn aperture in the E-field
$A_h$	Horn aperture in the H-field
$A_{e\lambda}$	Horn aperture in the E-field in free-space wavelengths
$A_{h\lambda}$	Horn aperture in the H-field in free-space wavelengths
AGC	Automatic Gain Control
AFC	Automatic Frequency Control
AM	Amplitude Modulation
AT	Autotune
B	IF Bandwidth
C	Speed of light in a vacuum
CMOS	Complementary Metal Oxide Semiconductor
$\delta$	Excess path length in a horn antenna
$\delta t$	Time between measurement of straddle and centre patterns
d	Excess path length of an indirect beam causing ground-swing
dB	Decibel, a logarithmic power ratio
dBc	dB ratio of a sideband level with respect to a carrier
dBm	dB ratio of a power level with respect to 1 mW
dec	Decimal, number system to the base 10
D	Distance between two instruments
e	Error in apparent measured distance due to ground-swing
E	Partial pressure in millibars
EPROM	Erasable Programmable Read-Only Memory
F	Noise factor (a ratio)
F'	Noise figure (in decibels)
FET	Field Effect Transistor
FM	Frequency Modulation
FSK	Frequency-Shift Keying
$G_r$	Gain of receiving antenna
$G_t$	Gain of transmitting antenna
h	Instrument Height (in particular the height of the direct beam over the point of reflection of the indirect beam)
hex, h	Hexadecimal, number system to the base 16

## List of Abbreviations and Symbols, continued

HPF	High Pass Filter
IF	Intermediate Frequency (amplifier stage)
K	Boltzmann's Constant
$\lambda_c$	Wavelength of microwave carrier signal
$\lambda_m$	Wavelength of modulating pattern signal
LCD	Liquid Crystal Display
LED	Light Emitting Diode
Lo	Locally generated pattern signal
LPF	Low Pass Filter
M	Integer multiplying factor
N	Integer multiplying factor
NAND	Not-AND, a logic gate with an inverting AND function
$\phi_{cm}$	Phase error term in Master centre pattern
$\phi_{cr}$	Phase error term in Remote centre pattern
$\phi_{sm}$	Phase error term in Master straddle pattern
$\phi_{sr}$	Phase error term in Remote straddle pattern
P	Atmospheric Pressure in millibars
PCB	Printed Circuit Board
RAM	Random Access Memory
RI	Atmospheric Refractive Index
Rx	Received pattern signal from far instrument
S	Relative Speed between two instruments
$T_d$	Temperature ( $^{\circ}$ C) measured by the dry-bulb of a psychrometer
$T_k$	Dry-bulb temperature in Kelvin
$T_w$	Temperature ( $^{\circ}$ C) measured by the wet-bulb of a psychrometer
TCXO	Temperature-Compensated Crystal Oscillator
Vg	Group Velocity
Vp	Phase Velocity
VCO	Voltage Controlled Oscillator
VSWR	Voltage Standing Wave Ratio
$\omega_m$	Reference frequency for pattern generation in Master
$\omega_r$	Reference frequency for pattern generation in Remote

## CHAPTER 1

### Subdivision of the Thesis

This thesis is divided into six Chapters, a Conclusion, a Bibliography and four Appendices.

Chapter 1 introduces the history of this project, what the objectives of the development have been and outlines the provisional specification of the instrument.

Chapter 2 gives an overview of the modules and their different configurations. The instrument's operation and built in test features of the software are described. The Tellurometer Principle and Digital Phase-Return technique of distance measurement are described.

Chapter 3 describes the Datalink configuration of the instrument including the development of the microwave source, the IF stage, the Autotune, and the Speech and Modem circuits.

Chapter 4 describes the modulator and synthesiser (the Modusynth), and the pattern set used for the evaluation of distance.

Chapter 5 describes the Microprocessor and Phase Counter section, and gives an overview of the software.

Chapter 6 is a discussion of subjects relevant to Tellurometers and surveying in general, and in particular to what extent these factors affect the Micromin.

The Conclusion describes what the author believes has been accomplished by this work.

The Bibliography lists related works and databooks that have been referred to for this work.

Appendix A is a mathematical treatment of the Tellurometer principle as used in this instrument.

Appendix B is a summary of relevant meteorological formulae and unit conversion constants for use at microwave frequencies and are appropriate to this instrument.

Appendix C is a summary of the results of field-trials performed to evaluate the cyclic contamination, accuracy and range performance of the prototype instruments.

Appendix D is an assembled software listing of the latest version of the Micromin program.

## INTRODUCTION

### History of the Project

The concept of a very low cost Tellurometer has long been discussed in the development laboratory of Plessey. It was the opinion of the late Dr. Trevor Wadley (the inventor of the Tellurometer) that Tellurometers were being made too complex and expensive for their full market potential to be realised. During one discussion with Mr. Bob Evans, Dr. Wadley asked quite seriously why Tellurometers were not being sold in supermarkets.

It was this background that inspired Mr. Evans to lay the foundation of an instrument with this concept, and in April 1984 invited the author to join him in a private development of a **MINIMUM MICROWAVE** measuring system that became known as the **MICROMIN**. The mechanical arrangement of the horn, the front panel and the battery compartment were designed by Mr. Evans, and the author designed the electronic circuitry, wrote the software and developed the microwave source.

What followed was a year of homework in which a prototype measurement system was constructed, and in May 1985 it was presented to the management of the Plessey company as a potential new product.

In April 1985 the author registered this work for fulfilment of the requirements of an M.Sc. degree at the University of Cape Town. Work then continued on the instruments and major modifications and improvements to the original design were made.

This design concept gained joint second prize in the Overseas Category of the International Plessey Design Competition in November 1985, and in that same year Mr. Bob Evans and the author were awarded the "Managing Director's Award for Innovation and Achievement", a prize awarded annually within the Plessey Company.

The main features that have contributed to the design aim being met are;

- Dedicated Master and Remote instruments. This removes the extra circuitry required to make both instruments perform the Master or Remote function.
- The microprocessor is a single-chip processor with all the memory and port requirements on one chip.
- The Modusynth has a fine pattern of 20 MHz thus allowing the design to be realised entirely in CMOS, cutting down on complexity, cost and current consumption.
- The datalink has been changed from simplex to full-duplex and the speed increased from 2 400 to 9 600 Baud.
- The microwave source, originally configured as a self-oscillating mixer, is now a separate mixer configuration. This reduced the noise figure of the receiver and has increased the range of the instrument.
- Integral batteries, either rechargable or Alkaline cells, can be fitted into the instrument. Survey instruments often do not contain the batteries they use, thus requiring another item to be carried into the field.

At the time of writing there are only two Micromin instruments in existence, the two prototypes. There are no plans (yet) to produce any more. The status of these instruments is that they are ready for introduction into a pre-production manufacturing environment.

Tooling-up costs are minimal, the design is mature, tested and the performance is expected to be reproducible.

## **Instrument Cost**

The costs of all the materials contained in the instruments have been calculated from the latest industry price lists available at the time of writing (August 1987). Assuming that components for 100 instruments are procured their cost per instrument will be:

### **Micromin in the Tellurometer Configuration:**

**Master R678, Remote R651,**

### **and in the Datalink Configuration:**

**Master R337, Remote R352.**

## **Instrument Specification**

The instrument specification is as follows:

Configuration	Dedicated Master and Remote instruments
Range	10 m to 15 Km
Accuracy	approximately $\pm 3$ cm under favourable conditions of ground-swing
Carrier Frequency	10 300 MHz $\pm$ 10 MHz
Dynamic Operation	"Track Mode", range update once per second
Data Link	FSK 9 600 Baud Duplex
Speech Link	Push-to-talk
Power Requirements	12 Volts DC, 340 mA
Temperature	Operating ambient range 0 to 55 °C
Radiated Power	8 mW, vertically polarised
Antenna Beamwidth	14,05 deg vertical, 15,6 deg horizontal
Size	300 mm (L), 116 mm (H), 125 mm (W)
Weight	2,4 kg including batteries
Carrying case	Provided

## CHAPTER 2

### General Description

#### The Tellurometer Principle

The Micromin uses the Tellurometer Principle of distance measurement invented by the late Dr. Trevor Wadley at the National Institute of Telecommunications Research of South Africa in 1957.

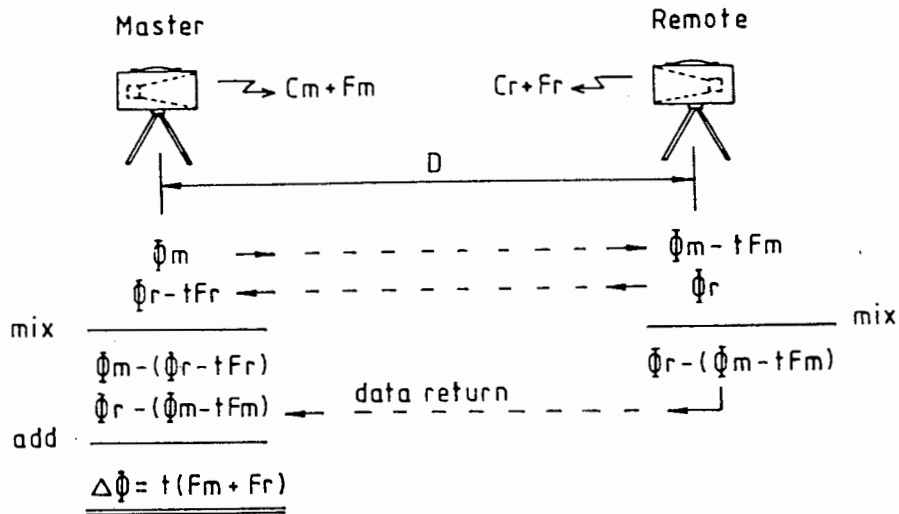
In particular this instrument uses a technique called "digital phase-return" involving the measurement and storage of simultaneous measurements in both the Master and Remote instruments, and the subsequent comparison of these results.

Microwave carriers radiated from both the Master and the Remote instruments are mixed in both instruments to produce 10,76 MHz IF signals. The frequency discriminator in the Remote's IF produces a voltage output which is dependent on the frequency of the incoming signal. This is used to keep the instruments in tune.

The carrier waves are modulated with measurement frequencies (patterns) in the range of 10 to 21,25 MHz. These patterns are frequency-locked to a reference standard (5 MHz TCXO) in each instrument.

The modulation at the Master is mixed with the received modulation from the Remote and this difference is compared in phase with the reference. Likewise the modulation at the Remote is mixed with the received modulation from the Master and this difference is compared in phase with the reference in the Remote.

Consider the transmission of these signals as shown in Fig.2-1.



**Fig.2-1, Transit Path Time and Phase Measurement**

The signal transmitted from the Master is a carrier wave of frequency  $C_m$ , frequency modulated by pattern frequency  $F_m$ . Similarly the signal transmitted from the Remote instrument is a carrier wave of frequency  $C_r$ , frequency modulated by pattern frequency  $F_r$ .

If the pattern frequency  $F_m$  has at some instant a phase value of  $\phi_m$ , then this signal received at the Remote, at that same moment, will have a phase value of  $(\phi_m - tF_m)$ , where  $t$  is the time that the wave took to travel the distance  $D$  from the Master to the Remote. Similarly if the pattern frequency  $F_r$  has (at the same time) a phase value of  $\phi_r$ , then this signal received at the Master will have a phase value of  $(\phi_r - tF_r)$ , owing to the transit path delay  $t$  over the path  $D$ .

The carriers mix to produce the 10,76 MHz IFs, and the pattern modulations mix to produce beat frequencies that are used in the phase measurements process. The phases of the carriers play no part in the phase measurement of the pattern beat frequencies.

The FM pattern modulations mix to produce 39,062 KHz AM beat frequency components, the phases of which are measured with respect to the frequency references in each instrument.

The phases measured are:

$$\text{in the Master} \quad \phi_m - (\phi_r - tFr)$$

$$\text{in the Remote} \quad \phi_r - (\phi_m - tFm)$$

These phases are recorded in digital form by microprocessors in each instrument. The Remote then transmits the result to the Master via the datalink and the the results are added. This gives:

$$\Delta\phi = \phi_m - (\phi_r - tFr) + \phi_r - (\phi_m - tFm)$$

$$\text{i.e.} \quad \Delta\phi = t(Fm + Fr) \text{ cycles or } 2\pi t(Fm + Fr) \text{ radians}$$

$$\text{also} \quad \Delta\phi = N + \Delta\phi' \text{ cycles or } 2\pi(m + \Delta\phi') \text{ radians}$$

In the phase discrimination only the part of the cycle  $\Delta\phi'$  is measured as the value of the integer N is unknown.

The Tellurometer is essentially a time measuring instrument, for if  $\Delta\phi$  is observed and  $Fr$  and  $Fm$  are known then the value of  $t$  can be calculated. From this the value of  $D$  can be calculated if the value of the velocity of propagation  $C$ , is known.

The value of the integer  $N$  is determined by using progressively increased values of pattern wavelength in binary steps. This could be done by simply reducing  $Fm$  and  $Fr$ . In practice however, with the long distances involved the frequencies of  $Fm$  and  $Fr$  would become inconveniently low. It is therefore arranged to measure a convenient pattern frequency and to then change the values of  $Fm$  and  $Fr$  by the frequency of the pattern that is required to be measured, the value of this difference is then found by subtracting the resultant phase measurements of these two patterns. For example to measure the phase of a pattern frequency  $Fd$ , due to the transit path delay, this can be achieved by measurement of two patterns  $F1$  and  $F2$  where  $F1 - F2 = Fd$ . For example, as before:

$$\Delta\phi_1 = t(F1m + F1r)$$

$$\text{and} \quad \Delta\phi_2 = t(F2m + F2r)$$

subtracting the two results gives,

$$\Delta\phi d = \Delta\phi_1 - \Delta\phi_2 = t[(F_{1m} + F_{1r}) - (F_{2m} + F_{2r})]$$

Thus the measurement of the phase of a low frequency pattern is achieved by the measurement of the phases of two high frequency patterns differing in frequency by the low frequency "Difference Pattern".

In the Micromin the lowest frequency pattern, 2,441 KHz, is measured by the differential phase measurement of 20,000 000 and 20,002 441 MHz patterns. The unambiguous range of this pattern is 61 397,503 metres, since N is zero for distances shorter than this.

The accuracy of the determination of the distance increases by a the ratio of the pattern frequencies (x2, x4 or x8) with each of the eight patterns up to the finest pattern which has an ambiguous wavelength of 3,747 m. Averaging 16 frames of phase measurement of this pattern results in a final instrumental accuracy of approximately 3 cm.

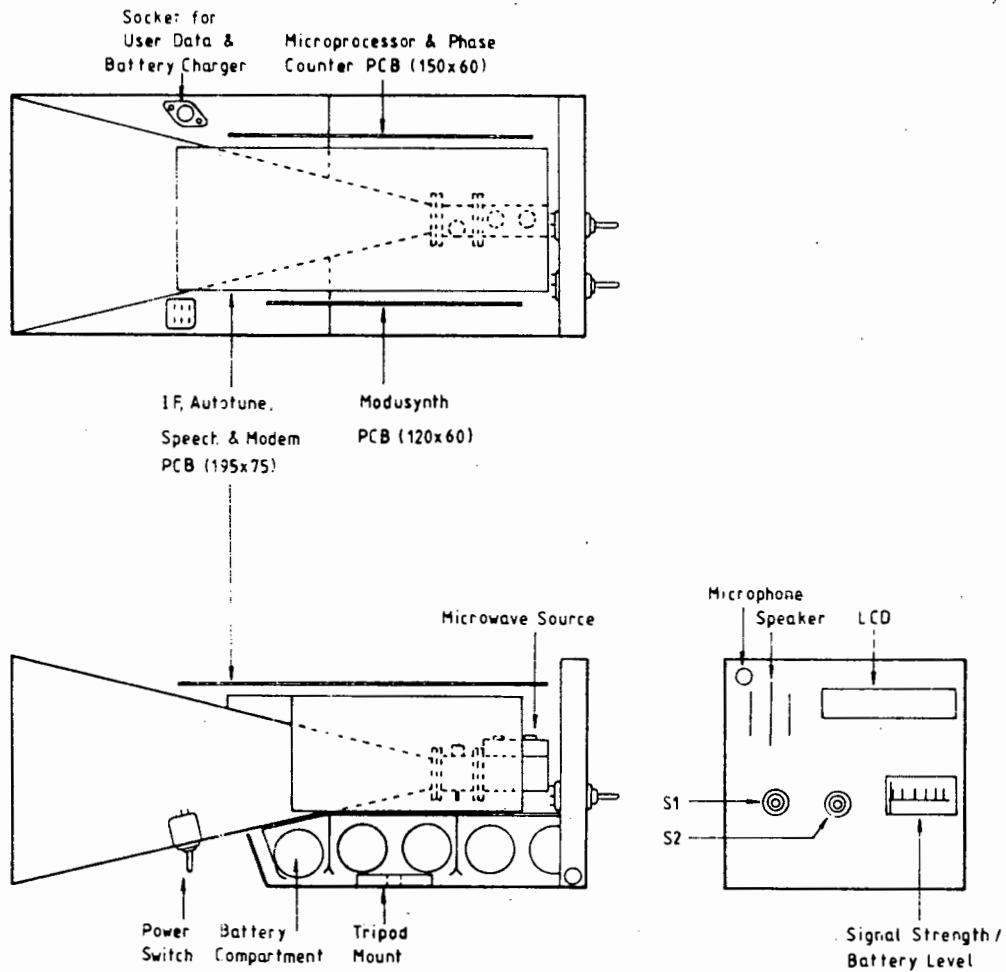
Furthermore this measurement technique is improved by the repetition of the first pattern after the second. The two measurements of the first pattern are averaged and appear as if their average was calculated at the same time as the second pattern, thereby cancelling any errors due to movement of one or both of the instruments. This gives a accurate dynamic measurement capability which is available in the TRACK mode of operation of the Micromin where the distance readout is updated once per second.

This process of repeating the first pattern after the second pattern has resulted in the terminology of a "Straddle Pattern" and a "Centre Pattern". The measurement of the eight patterns in the Micromin are all achieved by a differential straddling process contained within a "frame" 300 ms long involving data transmission between the two instruments, and three phase measurement periods, the first Straddle, the Centre and the second Straddle patterns.

The measurement frame is described in more detail in Chapter 5, and the pattern set is described in Chapter 4.

## Mechanical Arrangement of the Micromin

The general assembly of the Micromin with the outer case removed is shown below in Fig.2-2.



**Fig.2-2, Mechanical Arrangement of the Micromin**

The combination of, small size, light weight, internal batteries, low power consumption, carrying case and rugged construction make the Micromin a convenient and very portable survey instrument.

## The Micromin in the Tellurometer Configuration

The block diagram of the Micromin in the full Tellurometer configuration is shown in Fig.2-3.

The major components are;

- the Microwave Source and Horn Antenna (S and H),
- the Intermediate Frequency stage (IF),
- the Autotune (AT),
- the Modem (FSK TX, RX, HPF and LPF),
- the Speech Facility,
- the Modusynth (MS),
- the Squarer (SQ),
- the Microprocessor ( $\mu$ P),
- the Phase Counter ( $\Phi$ ), and
- the Liquid Crystal Display (LCD).

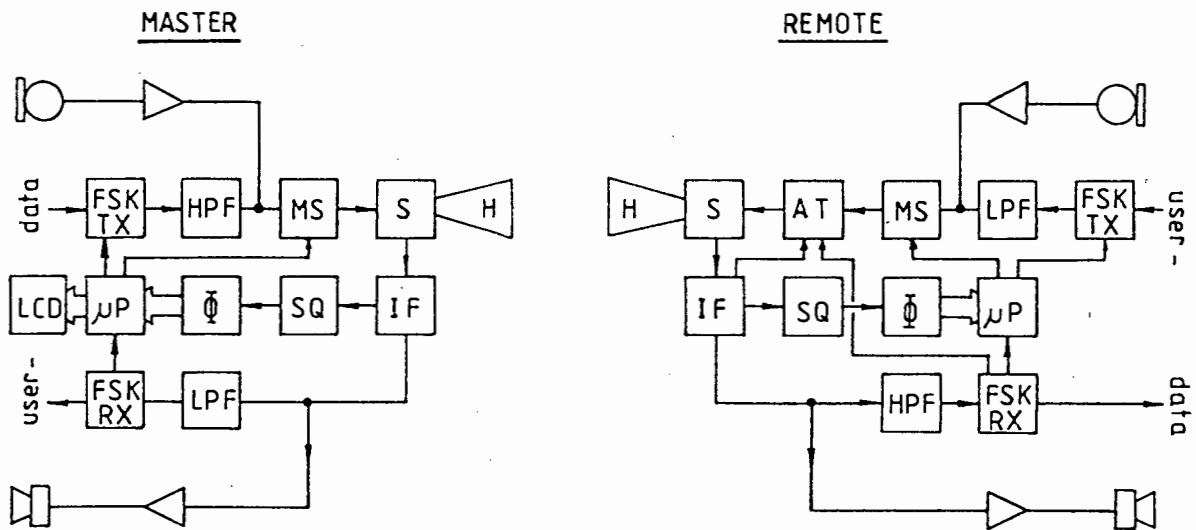


Fig.2-3; Block Diagram of the Tellurometer Configuration

A description of the function of each of these sections follows.

The microwave source (S) consists of a varactor-tuned Gunn oscillator, Plessey type GVD03/001, and a mixer assembly. The source device mounting posts are replaced with larger ones to increase the tuning range. The choice of 10 GHz (X-band) for this instrument was influenced by the availability of low-cost sources and measurement equipment. In the past other survey instruments have achieved acceptable results at 10 GHz, with the main limitation to accuracy being ground swing (described in Chapter 6). Whilst ground swing is less at higher frequencies the accuracy improvement is gained at the expense of higher device costs and greater atmospheric path losses.

The IF is a wideband FM and AM receiver with a bandwidth of 250 kHz and designed to receive signals as low as 1  $\mu$ V. In order to recover an AM product from the FM/FM system of this instrument, an AGC loop is employed. The IF detects the FSK datalink signals in the ranges of 25-35 kHz and 75-85 kHz, and the phase comparison signal (AM) at 39,062 kHz. The FM discriminator outputs are fed to the Autotune which locks the frequency of the Remote to that of the Master.

The modems are phase-continuous FSK transmitters, and phase-locked-loop receivers. Full duplex operation is possible at any rate up to and including 9 600 Bauds. Transmission from the Master to the Remote is in the range of 75-85 kHz and from the Remote to the Master in the range of 25-35 kHz. The datalink is used during the measurement of distance, but at all other times it is automatically switched over to allow the user to use it with any other serial data transmission equipment.

The speech facility is a simple baseband modulation system; transmission is enabled by a press-to-talk switch on both instruments, and modulation level is controlled by an automatic level control. The audio amplifier in each instrument provides approximately 400 mW to an 8  $\Omega$  loudspeaker mounted on the front panel.

The measurement patterns are generated by the modusynth (MS), a frequency-locked loop generating pattern frequencies for the eight sets of binary-related phase measurements. The pattern set gives unambiguous distance measurements up to a maximum range of 61,397 km. All these pattern frequencies fall between 19,6 MHz and 21,25 MHz with the exception of one pattern using 10 MHz, which is generated by division of the 20 MHz signals by 2. The modusynth is realised entirely in CMOS technology and has a very low current consumption of only 60 mA.

The squarer is a selective amplifier tuned to 39,062 kHz to recover the AM comparison-frequency used for the phase measurement process. To ensure accurate phase measurement of the zero-crossings of this signal a comparator is used to "square" the signal waveform. The output of this circuit is fed to the phase counter on the microprocessor board.

The microprocessor and phase counter ( $\mu\text{P}$  and  $\Phi$ ) are also realised entirely in CMOS technology (with the exception of the reference 5 MHz TCXO); current consumption of this circuit is a low 40 mA. Only the Master instrument has an LCD, in order to reduce the system cost.

## Instrument Operation

The operation of the Micromin has been kept as simple as possible. The two toggle switches on the front panel S1 and S2 are used in the following way:

For Master and Remote instruments, in both the Datalink and Tellurometer configurations,

Press-to-Talk,	S1 up, hold up while talking,
Battery Voltage,	S2 down, hold down to read battery condition.

For the Master instrument in the Tellurometer configuration only:

Static Measurement	S1 in centre, briefly push S2 up and release,
Dynamic Measurement	S1 down, briefly push S2 up and release,
Stop Measuring,	push S2 up and hold up until speech is unmuted, then release S2.

## Built-in Test Features

### - Instrument Alignment

The TEST switch on the microprocessor board is used in the adjustment of the synthesiser tuning range and the modulation index for each of the patterns. Pressing the TEST switch sets up the synthesiser and modulates the carrier with the centre pattern frequency of the first pattern (0). Further pressing the TEST switch cycles the synthesiser through the rest of the patterns allowing the modusynths to be adjusted.

The instruments can be tuned in to each other and then by applying the patterns one at a time, the 39,062 KHz difference frequency can be recovered at the output of the squarer of each IF.

The tuned circuit and gain of both the squarers can be set up this way. This procedure gives a good indication of phase noise on each of the patterns (see Fig.6-9).

## - Phase Measurement of One Pattern at a Time

A feature of the Micromin that can be used for both factory testing and operator training is the facility to measure the angle of one pattern at a time and manually repeat, or increment the pattern being measured. Instead of the pattern phase being interpreted as a possibly ambiguous distance, the pattern number and the possibly ambiguous phase angle, in degrees, is displayed on the LCD.

Measuring the angle of one pattern at a time is achieved by having the two instruments tuned in to each other, and physically aligned. Then at the Master instrument, press up S2, then press the TEST switch, then release S2, and then release the TEST switch. The Micromin will then start by measuring the phase of pattern 0, display the pattern number and the phase in degrees, and then wait.

The measurement of the current pattern can be repeated by holding up and then releasing S2.

The measurement of the next pattern can be made by pressing the TEST switch. The pattern count cannot be incremented further than the finest pattern (7).

In order to return to normal measurement the Master instrument can be reset, either with the RESET switch or by switching off and on again.

This feature can be used to demonstrate that the angle of a pattern two, four or eight times that of the previous pattern, or to determine the scatter in the phase readings of various patterns. An example of this has been recorded in Appendix C under the heading of "Pattern Analysis" to show the phase scatter and pattern-ratio fit of the prototype instruments.

## CHAPTER 3

### The Micromin in the Datalink Configuration

The block diagram of the Micromin in the datalink configuration is shown in Fig.3-1.

The major components are:

- the Microwave Source and Horn Antenna (S and H),
- the Intermediate Frequency stage (IF),
- the Autotune (AT),
- the Modem (FSK TX, RX, HPF and LPF),
- the Speech Facility,
- the interface to the optional Modusynth (m).

Because the data input and output lines go to both the Microprocessor option and the USER RS232 connection, they are shown as broad arrows. Note that only the Remote instrument has an Autotune. The Master instrument is kept at a constant frequency and the Remote sweeps and locks onto the Master with an AFC (automatic frequency control) circuit.

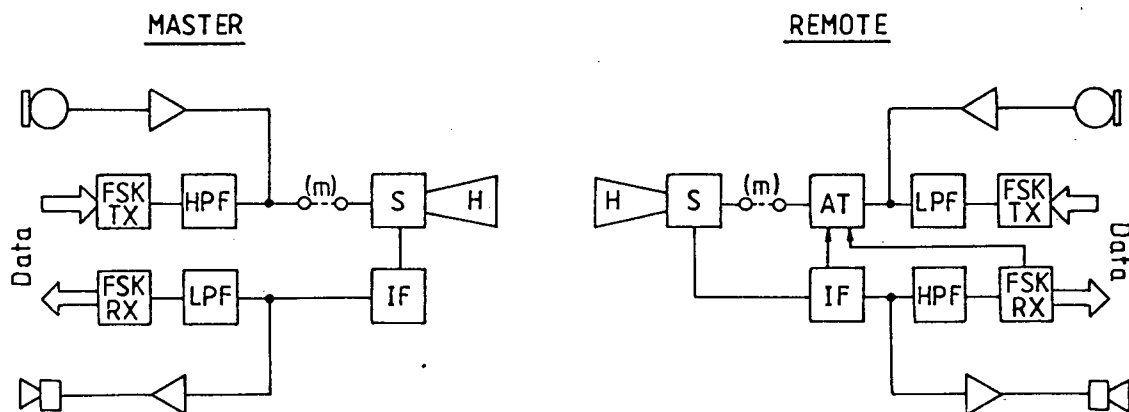


Fig.3-1, Block Diagram of the Datalink Configuration

Each of these sections and their development will be described in this chapter.

## Development of the Microwave Source

A Plessey Optoelectronics and Microwave GDV03/001 varactor-tuned Gunn oscillator is used as the microwave source.

It was chosen because of the following features:

- +8 Volt Gunn voltage,
- low current consumption (nominally 115 mA),
- low cost,
- availability,
- small size and light weight.

The source has a nominal tuning range of only 50 MHz.

To simplify the requirements of the modulator it is necessary to increase the tuning range of the source to approximately 120 MHz.

To achieve this the diameter of the varactor post is increased; this increases the coupling of the varactor to the Gunn diode. More power is absorbed in the varactor reducing the output power, and in order to maintain power output from the source it is necessary to increase the size of the Gunn post. Increasing the size of the Gunn post in the cavity increases the coupling between the Gunn device and the external load, and increases the output power to the load.

This has the result of reducing the cavity Q-factor and degrading the temperature stability and noise performance. The resulting noise and temperature stability are however still acceptable for this application.

Two GDV03/001 sources #1378 and #1379 were tested and the tuning ranges were found to be 49,1 and 45,4 MHz respectively.

Here the tuning range is defined as the change in frequency when the varactor voltage is varied from 5 to 15 Volts.

In order to increase the tuning range of source #1378 the posts were increased from the original, Gunn= 3,5 mm, varactor= 3,0 mm; to Gunn= 9,0 mm, varactor= 9,0 mm.

The tuning range was then found to be 88 MHz. This tuning range was not wide enough, so the posts were increased again to Gunn= 11 mm, varactor= 11 mm.

This resulted in a satisfactory 5-15 V tuning range of 129 MHz. The results of this exercise are shown below in Fig.3-2.

(Each time the posts were changed the cavity tuning screws were readjusted to deliver an output power of 15 mW, and a carrier frequency of 10,3 GHz at a varactor voltage of 8 V.)

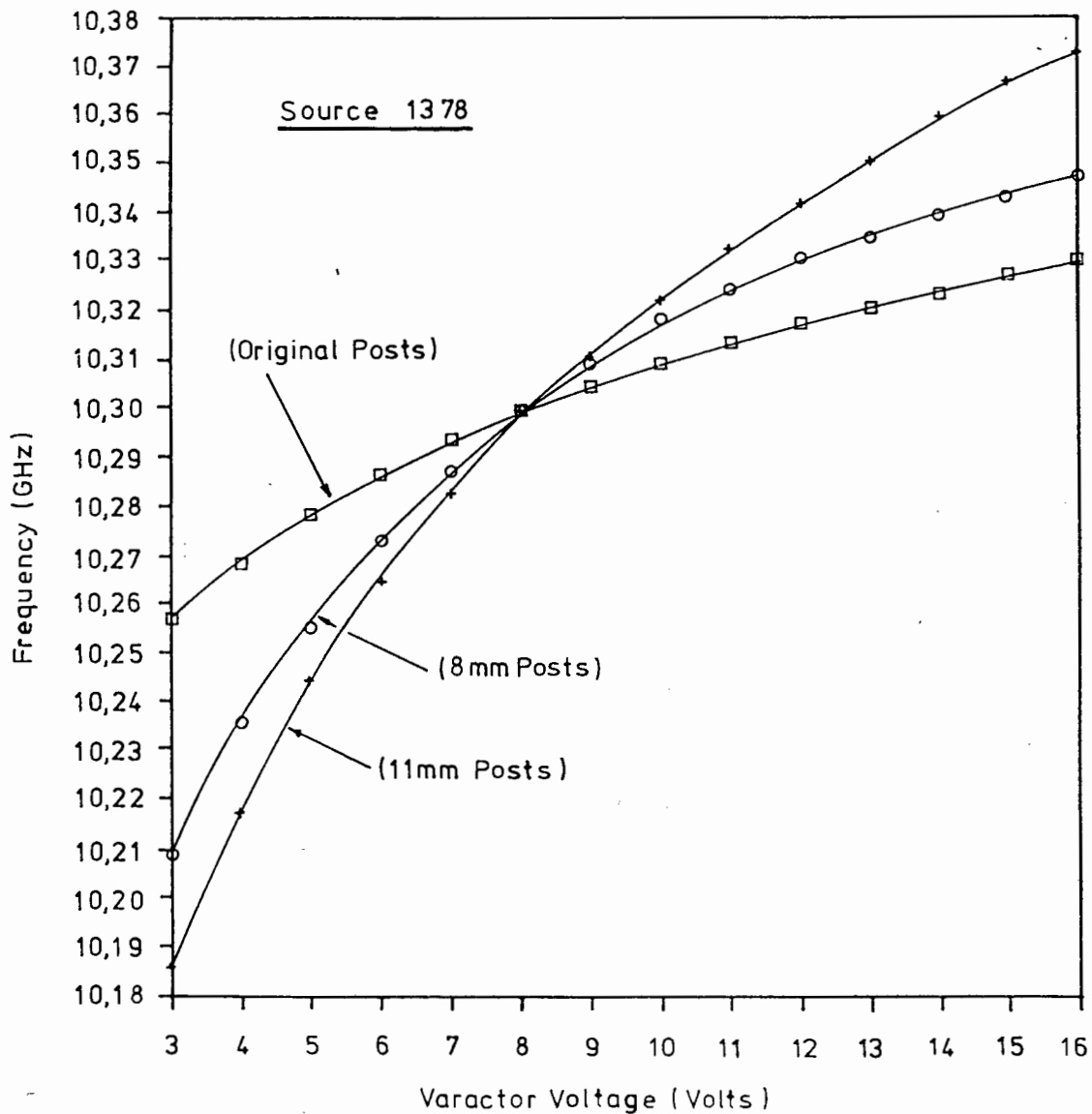


Fig.3-2, Tuning Curve of Source #1378

In order to increase the tuning range of source #1379 the posts were increased from the original Gunn= 3,6 mm, varactor= 2,09 mm; to Gunn= 10,0 mm, Varactor 10,0 mm.

This increased the the tuning range to 116 MHz, as shown below in Fig.3-3.

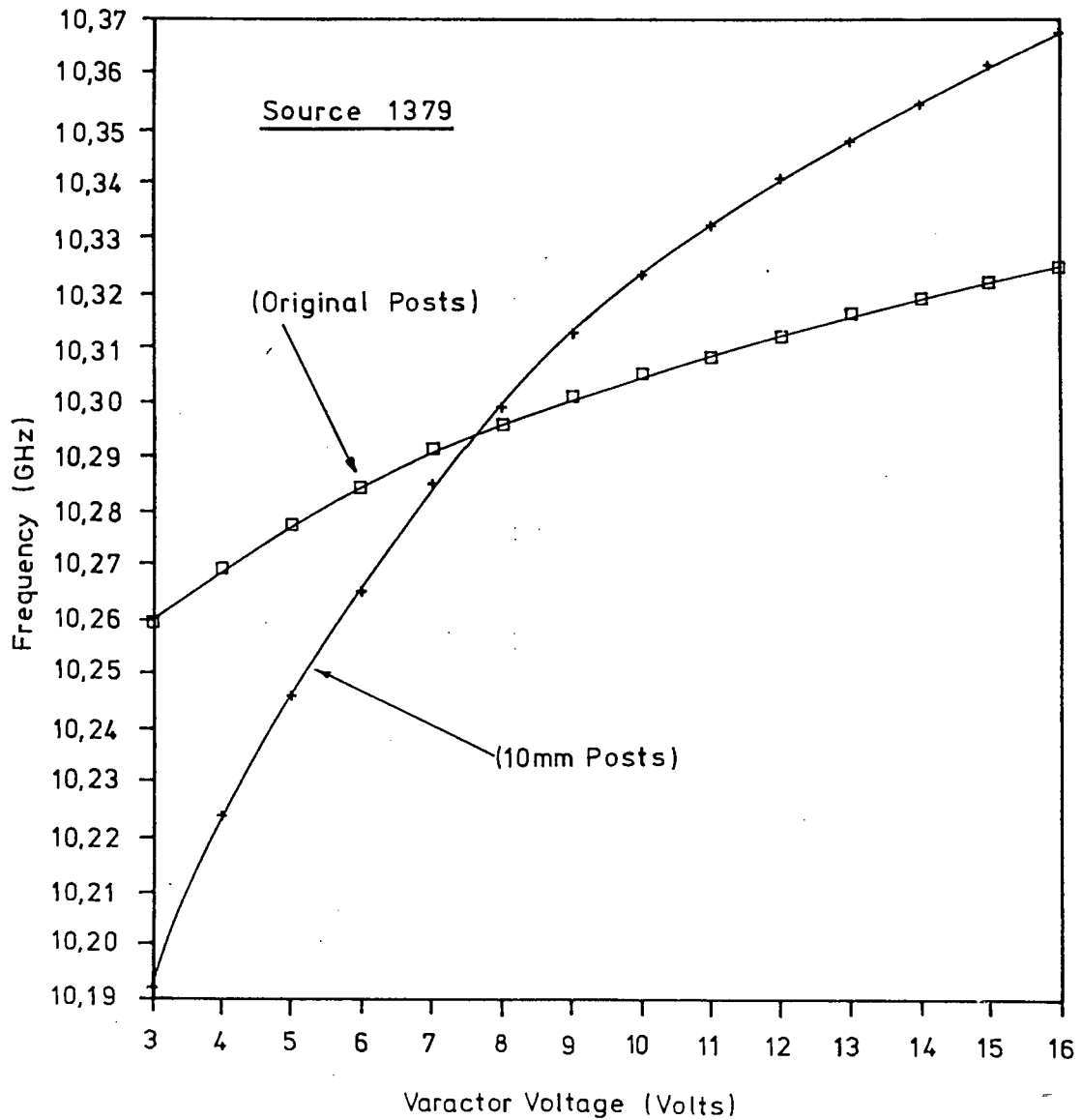


Fig.3-3, Tuning Curve of Source #1379

## The Mixer Mount

The mixer diode is a standard 1N23C silicon Schottky-barrier mixer diode, designed for X-Band waveguide mounting.

Vertical polarization for both transmit and receive paths is used.

Local oscillator bias is achieved by mounting the mixer diode in front of the Gunn diode and off-centre in the waveguide to control the amount of transmit power that is absorbed. This configuration also loses receive power, so there is a compromise between getting sufficient local oscillator bias (and not absorbing too much of the transmit power), and not losing too much of the received signal by positioning the mixer too far to the side of the waveguide.

If 3 dB of the transmit power is absorbed as mixer bias, then 3 dB of receive signal is sacrificed. With the Gunn oscillators providing 15 mW this means that approximately 7 mW would be absorbed and 8 mW transmitted. The mixer mount is shown in Fig.3-4.

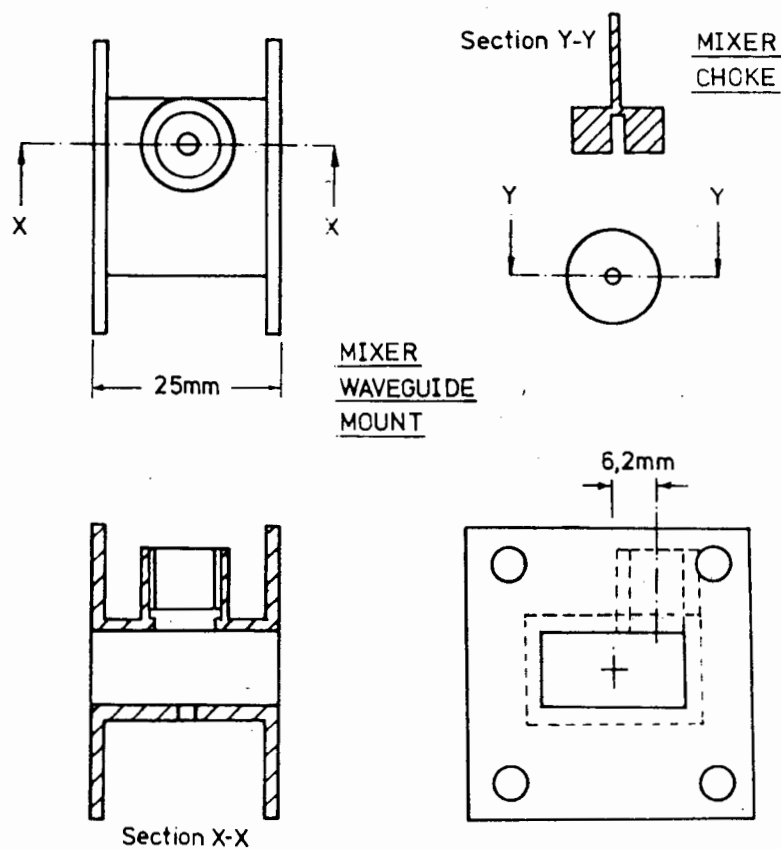
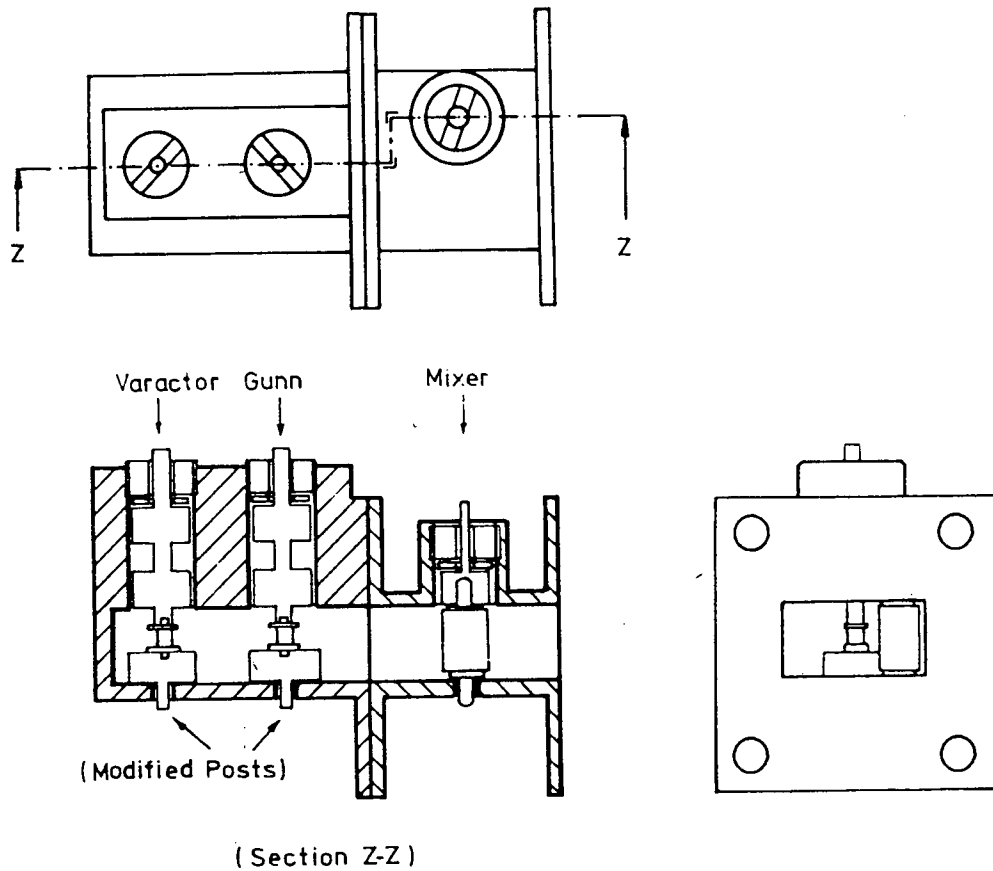


Fig.3-4, The Mixer Waveguide Mount

The arrangement of the source assembly, consisting of the modified GDV03/001 source and the mixer mount, is shown in Fig.3-5. The chokes for the varactor, Gunn and mixer are insulated from the source body by heat-shrink sleeving. For simplicity Fig.3-5 does not show the source-frequency-adjustment or power-matching screws.



**Fig.3-5, The Microwave Source and Mixer Assembly**

The resultant power output and tuning bandwidth of the two sources are shown in Fig.3-6. Note that the power output of #1379 has been reduced, by adjusting the power matching screw, in order to ensure reliable starting of the Gunn oscillator.

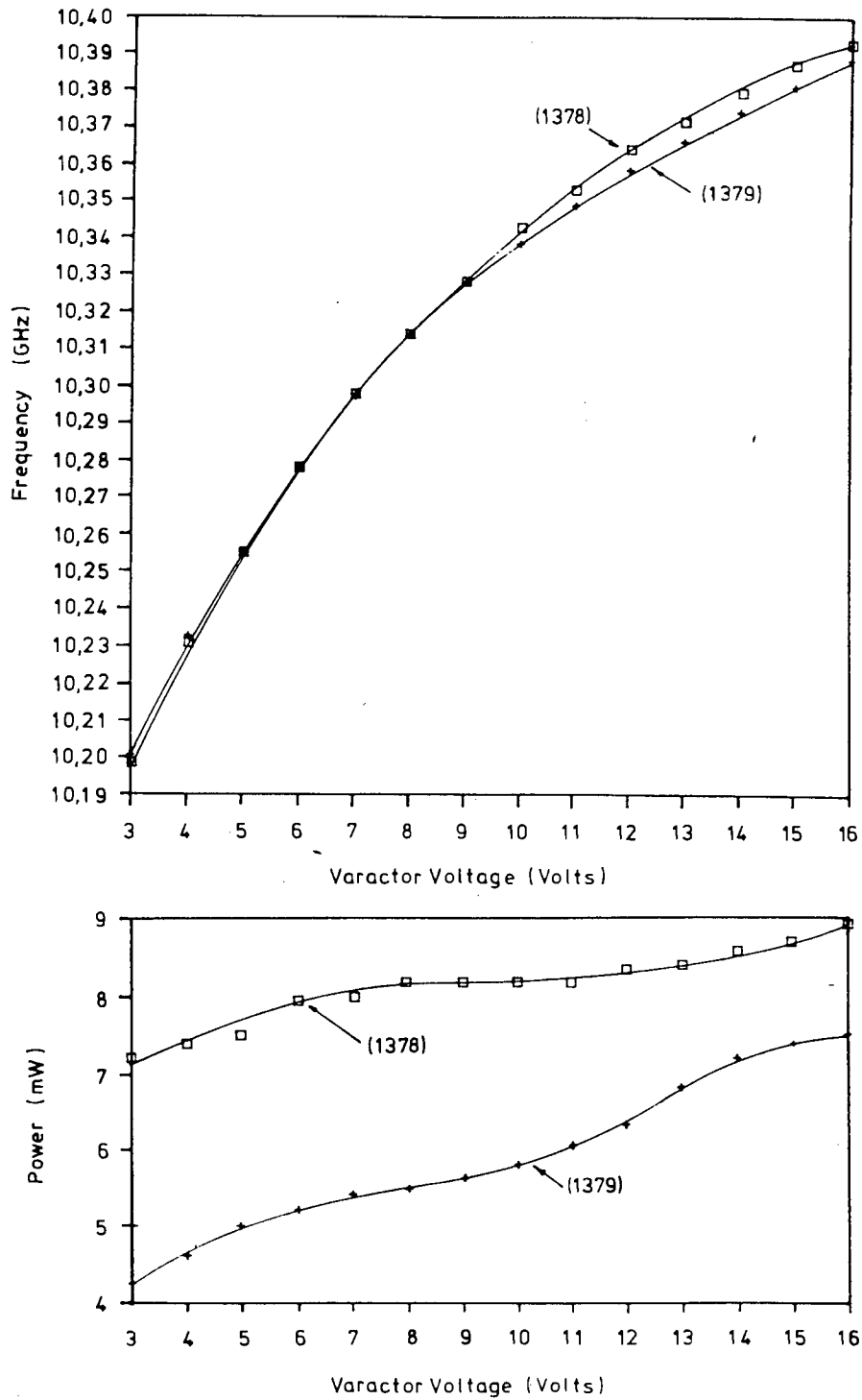


Fig.3-6, Tuning and Power Curves of the Microwave Assemblies

## Gain of the Horn Antenna

The horn antenna was designed as a straight-flare pyramidal horn which provides a simple mechanical arrangement and a convenient base on which to mount the printed circuit boards.

Assuming a TE<sub>01</sub> mode of excitation, the gain of this antenna over a half wave dipole is defined as

$$G = 4,5A_{e\lambda}A_{h\lambda} \quad 3.1$$

where;

$A_{e\lambda}$  = horn aperture in the E plane in free space wavelengths

$A_{h\lambda}$  = horn aperture in the H plane in free space wavelengths

The free space wavelength at 10,3 GHz is, ( $\lambda=C/f$ )

$$(300 \times 10^6) / (10,3 \times 10^9) = 2,91 \times 10^{-2} \text{ m}$$

and with  $A_e = 116 \text{ mm}$  and  $A_h = 123 \text{ mm}$

giving

$$A_{e\lambda} = 3,99 \quad \text{and} \quad A_{h\lambda} = 4,23$$

therefore  $G = 4,5 \times 4,23 \times 3,99 = 75,95$  times,

which expressed in dB is  $10 \log_{10}(75,95) = 18,81 \text{ dB}$

(There is a discussion of Antenna Swing, and the VSWR of the horn antenna, in Chapter 6.)

## Noise Figure Of The Receiver

The noise power of a receiver is given by the formula

$$S = KTB \quad 3.2$$

and if the receiver is preceded by a mixer of noise factor  $F'$  (or noise figure  $F$ , in dB) this becomes

$$S = F'KTB$$

where

- $F'$  = noise factor of the mixer (5, equivalent to 7 dB)
- $K$  = Boltzmann's constant ( $1,38 \times 10^{-23}$  Joules/Kelvin)
- $T$  = absolute temperature (290 K)
- $B$  = IF bandwidth ( $250 \times 10^3$  Hz)

giving

$$\begin{aligned} S &= 5 \times 1,38 \times 10^{-23} \times 290 \times 250 \times 10^3 \\ &= 5,01 \times 10^{-15} \text{ Watts} \\ &= 5,01 \times 10^{-12} \text{ mW} \\ &= -113 \text{ dBm} \end{aligned}$$

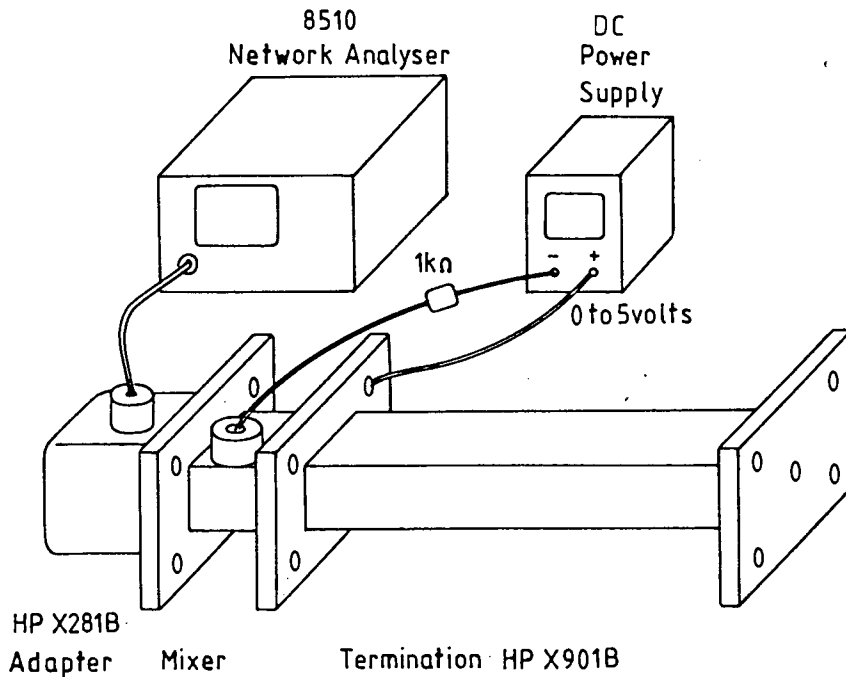
The mixer is mounted off-centre in the waveguide attenuating the received signal by 3 dB. The mixer has an image input increasing the noise level by 3 dB, while the IF has a noise figure of 2 dB.

This 3 dB loss and the extra 5 dB of noise component mean that to equal the level of the internal receiver noise, an incoming signal from the far instrument will need to be at a level of **-105 dBm**.

## Impedance Matching of the Microwave Source Assembly

Another loss in the receive path that must be considered is the impedance matching of the mixer and the source.

The impedance of the mixer assembly was measured using a Hewlett Packard 8510A Network Analyser. The mixer assembly was fitted in front of a tapered dummy load and the VSWR of the combination was measured as shown below in Fig.3-7.



**Fig 3.7, Measurement of the Mixer Mount Impedance Matching**

With no mixer current the VSWR was 1:1, showing that the mixer was not loading the waveguide at all, (not being in conduction), and that the dummy load was a good match.

A mixer current of 5 mA is generated when mounted in front of the source. To emulate this a bias current of 5 mA was injected into the mixer diode from an external DC power supply, changing the VSWR to approximately 2:1.

As the impedance of the dummy load is  $400 \Omega$  and the parallel combination of the dummy load and the biased mixer is  $200 \Omega$  it follows that if no power is being reflected from the mixer it has an impedance equal to the dummy load i.e.  $400 \Omega$ .

With a waveguide and mixer impedances of  $400 \Omega$  the match between the mixer diode and the source is important since it affects the coupling of the receive energy into the mixer.

It was found impossible to measure the VSWR of the source looking into the cavity as this would necessitate powering up the source and disturbing the network analyser. The power match between the source and the load is adjusted by the power-matching screw, but this only matches the impedance to a VSWR of about 3:1. Any improvement in this can only be made by increasing the length of the waveguide and using more power-matching screws. This is not done in practice as it would be uneconomical, resulting in only a 25% increase in output power.

If the VSWR match of the source to the waveguide is in fact 3:1, the impedance of the source as seen by the mixer assembly can be from  $133 \Omega$  to as much as  $1200 \Omega$ , depending on the phase of the reflection. The received signal will be present across both the  $400 \Omega$  load of the mixer and the unknown load of the source and a loss of as much as 6 dB of the receive energy can be expected due to absorption by the source.

Taking the worst case then of the phase of a reflection from a 3:1 VSWR mismatch between the mixer assembly and the source, for an incoming signal to equal the level of the internal receiver noise, it must be 6 dB greater in strength than previously calculated, i.e. **-99 dBm**.

## Maximum Range of the Micromin

The maximum range that the Micromins can work over is determined by the formula;

$$P_r = P_t \times G_t \times G_r \times (\lambda/4\pi D)^2 \quad 3.3$$

where

- $P_r$  = power of the received signal (mW)
- $P_t$  = power of the transmitted signal (8 mW)
- $G_t$  = gain of the transmitting antenna (75,95 times)
- $G_r$  = gain of the receiving antenna (75,95 times)
- $D$  = distance between the antennas (m)
- $\lambda$  = wavelength of the carrier (m)

From this, given that the transmitted power of the weaker of the two sources is 5 mW (in future instruments this should be increased), the antenna gain at each end is 75,95 times, and the wavelength is 29,1 mm, the power of the received signal at a distance of 30 km is;

$$\begin{aligned} P_r &= 5 \times 75,95 \times 75,95 \times (0,0291/(4\pi \times 15\,000))^2 \\ &= 6,88 \times 10^{-10} \text{ mW} \\ &\equiv -91,6 \text{ dBm} \end{aligned}$$

With this received signal strength there will be a signal to noise ratio of **+7,4 dB** if the losses and receiver noise levels as previously discussed are correct. With this margin, it indicates that the maximum range of the Micromin is in the order of 15 km. This has proven to be the case as shown by the results of the field-trials reported in Appendix C.

## Dynamic Range of the Receiver

The dynamic range requirements of the IF can be determined by calculating the received power at the minimum range, say 50 metres. Again using equation 3.3 ;

$$Pr = Pt \times Gt \times Gr \times (\lambda/4\pi D)^2$$

$$\begin{aligned} Pr &= 8 \times 75,95 \times 75,95 \times (0,0291/4\pi)^2 \times (1/50)^2 \\ &= 9,9 \times 10^{-5} \text{ mW} \end{aligned}$$

There will be a loss of 3 dB due to the offset position of the mixer diode, and a further possible loss of 6 dB due to the VSWR of the source, this implies that at 50 m the IF will receive a power level;

$$= 12,46 \times 10^{-6} \text{ mW}$$

Since the input impedance of the IF is 150  $\Omega$  this level of signal strength will develop a voltage of 1,36 mV.

This amplitude defines the gain parameters for the design of the IF amplifier stage.

The receiver noise-floor is at a level of -99 dBm, which is equivalent to a power level of  $1,26 \times 10^{-10}$  mW.

Since the input impedance of the IF is 150  $\Omega$  this level of signal strength will develop a voltage of 4,3  $\mu$ V.

It follows then, that the IF will have to handle input voltages ranging approximately from 4  $\mu$ V to 1,5 mV.

## The Intermediate Frequency (IF) Stage

The first two stages of the IF have a maximum gain of 30 dB, which is distributed as shown in Fig.3-8.

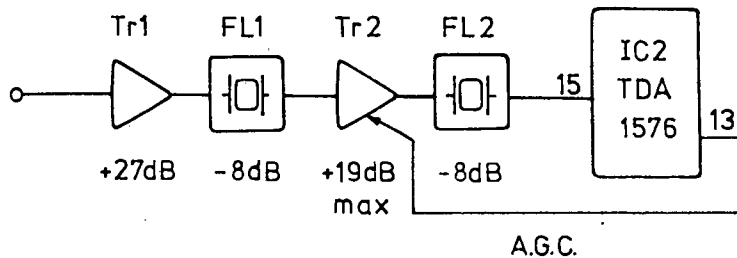


Fig.3-8, Gain Distribution in the IF Front-End

FL1 and 2 are ceramic filters with a passband insertion loss of 8 dB. With an overall gain of 30 dB it follows that the input of IC2 (pin 15), will receive an input voltage ranging from 126  $\mu$ V to 47 mV. This is a reasonable operating range for the TDA 1576. However the Micromin relies on the recovery of a 39,062 kHz AM component from the TDA1576 and this is a limiting factor in the design of the IF's dynamic range. The TDA1576 is an FM receiver and limits the incoming signal by a series of saturating amplifiers. With large signal strengths all of the stages of the TDA1576 saturate causing loss of detected AM.

This saturation is minimised by the AGC circuit which reduces the gain of Tr2 for IF input voltages greater than 10  $\mu$ V. Referring to the circuit diagram of the IF, shown in Fig 3-9; IC3b is controlled by the output voltage level of the TDA1576 (pin 13) and controls the gain of Tr2 by varying the current flowing through the PIN diode D1. This varies the decoupling effect of C11.

The AFC output and its inverted form, FMI, are fed to the Autotune. The AFC signal contains the demodulated FM buffered by the unity gain amplifier of IC3a and is fed to the audio amplifier and the receive modem.

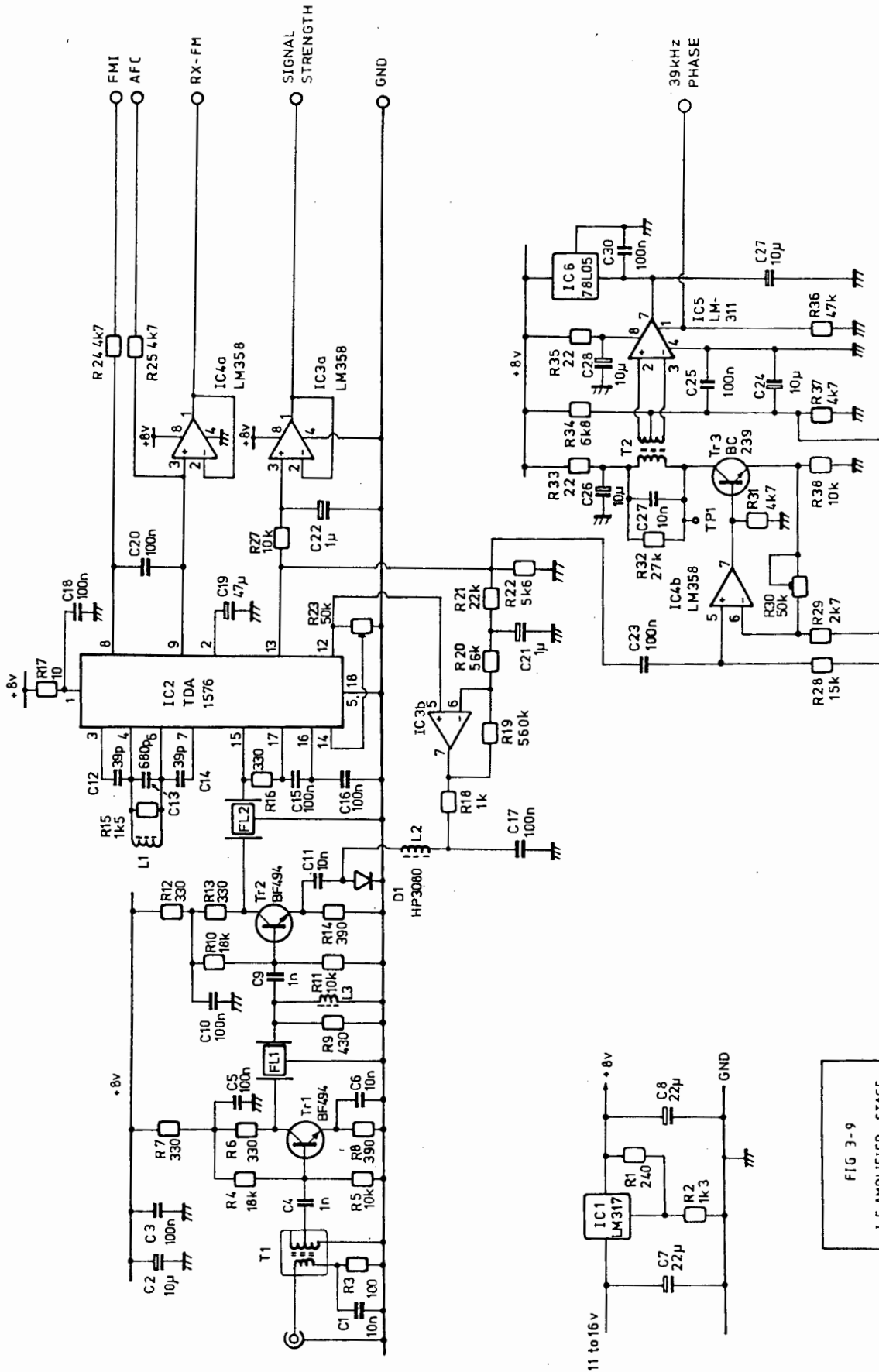


FIG 3-9  
I. F. AMPLIFIER STAGE

The "signal strength" output is fed to the switching circuit that applies this level or the battery voltage to the meter.

When used in the Tellurometer configuration the IF recovers an AM component from the "signal strength" output of the TDA1576 (pin 13) which is fed to the filter and squarer circuit of IC4b, Tr3 & IC5. The gain of the squarer is set by R30. Tr3 increases the current gain of the amplifier. The parallel arrangement of C27 and the primary of T2 is resonant at 39,062 kHz. The Q of this tuned circuit is set to 66 by R32. The value of R36 is kept high (47 k $\Omega$ ) to keep the output current as low as possible, so as to prevent contamination, (refer to the section on contamination in Chapter 6). The output signal is fed to the phase counter of the microprocessor. It is necessary to feed the phase counter with a clean, fast rising edge to ensure accurate phase measurement. This is achieved by arranging the output circuit of IC5 to pull up pin 1 quickly to get a fast rising edge, and having R36 slowly let it decay again. The output configuration and waveform are shown in Fig.3-10.

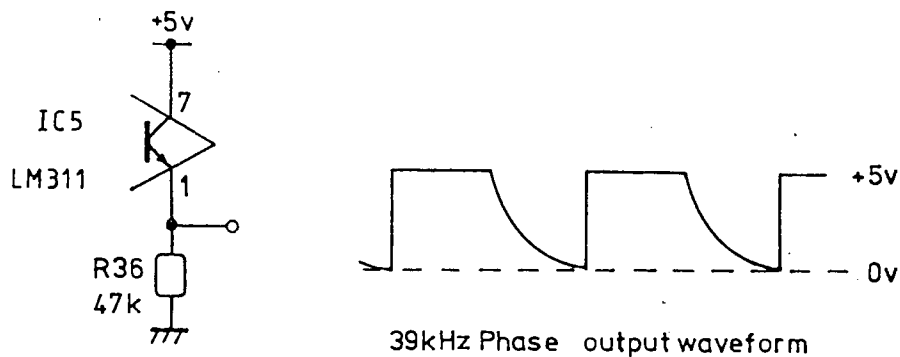


Fig 3-10, Output Configuration and Waveform of the Squarer

## The Autotune

The circuit diagram of the autotune is shown in Fig.3-11. The function of this circuit is to sweep the frequency of the Remote instrument, stop the sweep when an IF signal is detected and then lock the Remote instrument's frequency onto the Master with an AFC loop.

The circuit of IC1a, IC1c & Tr1 generates a ramp waveform on C6. IC1c is a comparator which switches state when the ramp waveform pulls the non-inverting input above or below the preset bias point of the inverting input (set at 3.27 V by R11 and R12). The amplitude of the ramp waveform is set by the hysteresis action of R13 and R14. Switching the comparator output low switches Tr1 on and this charges C6 rapidly through R17. The voltage on C6 decays slowly through R23 with a time constant of 300 ms, as long as the gate IC4c is turned on and the Q output of IC3b is low.

The sweep action is stopped by reverse-biasing D4 which prevents C6 from being further discharged. This is achieved by the S-curve detection circuit of IC2a,c & d and IC3. The two inputs FMI and AFC are derived from the IF. AFC is the frequency discriminator output, and FMI is the inverse of AFC. When the sweep circuit sweeps the Remote signal past the Master signal an S-curve is generated by the FM discriminator of the IF. This S-curve is amplified by IC2a and fed to two peak detectors IC2c and IC2d. In the absence of any signal the discriminator outputs a noise signal. The voltage on C8 is held to the lower limit of the amplitude of this noise signal by the comparator action of IC2d and the monostable IC3b. Likewise the voltage on C10 is held to the upper limit of the noise signal by the comparator action of IC2c and the monostable IC3a. (R25 and R29 prevent latch-up of the comparators). It is so arranged by the polarity of the discriminator and the direction of the sweep, that when an S-curve is detected it first (if it is strong enough) goes higher than the upper limit of the noise.

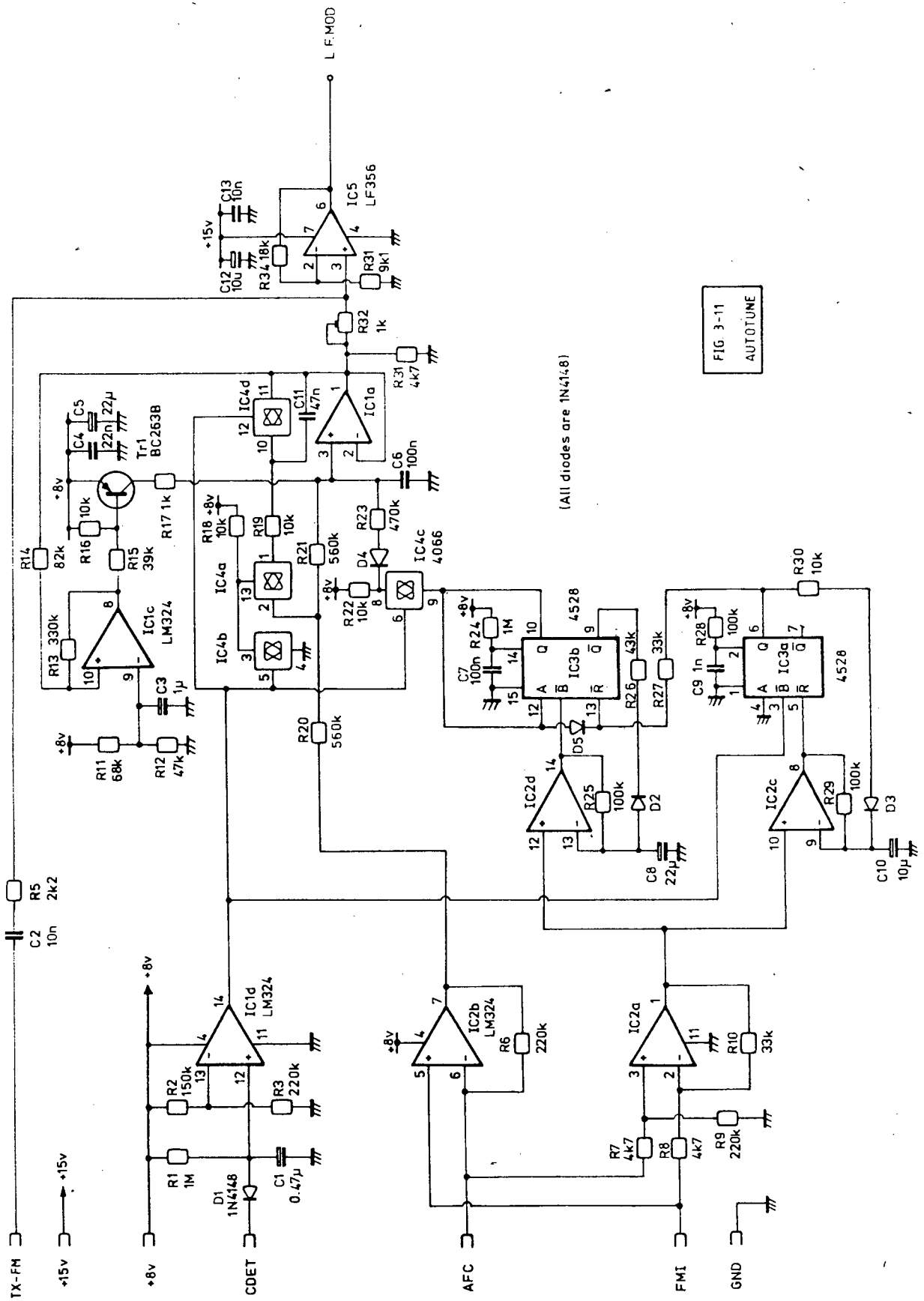


FIG 3-11  
AUTOTUNE

This is detected by IC2c, and triggers the monostable IC3a for 100  $\mu$ s (set by C9 and R28). This trigger then enables IC3b to be triggered by taking the reset of IC3b (pin 13) high and reverse-biasing D5. The continuing sweep pushes the S-curve down below the lower limit of the noise which is then detected by the comparator IC2d which can then trigger IC3b. The time constant of this monostable is set by R24 and C7 to 100 ms and is the time for which the Q output (pin 10) goes high. This stops the sweep by reverse biasing D4.

Note that to stop the sweep there must be a signal that exceeds the upper limit of the noise and then within 100  $\mu$ s goes below the lower limit of the noise. Noise is unlikely to have this characteristic so an S-curve from the IF will very likely be the only thing to stop the sweep.

The Master's signal in the IF will be confirmed by the presence of the datalink subcarrier which will, when detected by the modem, force the carrier detect line, CDET, low. CDET is fed from the modem to the autotune and used to prevent the sweep circuit from sweeping on after the S-curve detector's 100 ms time-out has elapsed.

The CDET line going low discharges C1 via D1, and switches the output of IC1d low. This will then do three things:

- Firstly the monostable IC3a is inhibited from triggering by setting its B input high (this prevents it causing any noise that may interfere with the AFC loop).
- Secondly the gate IC4c is switched off, so keeping D4 reverse-biased and ensuring that the sweep circuit does not oscillate.
- Thirdly it closes the gate IC4a and opens the gate IC4d thus turning IC1a from a buffer into a Sallen Key filter for the AFC loop. (IC4b is used as an inverter).

If the modem's CDET line goes high due to loss of datalink tone detection, the voltage on C1 is slowly charged by R1 (with a time constant of 470 ms). This allows a period of approximately half a second before the sweep is restarted.

This prevents the autotune resweeping in the measurement frames when the datalink tones are switched off. (The datalink tones are switched off during phase measurement to prevent phase corruption of the recovered AM).

The IF discriminator outputs, FMI and AFC, are differentially amplified by IC2 to provide the control loop for the autotune. Any increase in the IF frequency will result in an increase of the AFC voltage and a decrease of FMI voltage resulting in a fall in the output voltage of IC2b.

This is filtered by IC1a and will lower the output of IC5, lowering the frequency of the Remote instrument. The AFC loop will therefore lock the two frequencies together only when the Remote's frequency is 10,76 MHz higher than that of the Master.

The loop filter is a low pass filter with its bandwidth limited to 200 Hz so as not to prevent modulation of baseband speech. The lowest components of the speech signals are around 300 Hz.

The image frequency, where the Remote is 10,76 MHz lower than the Master, will not give the S-curve peaks in the correct order during the sweep and so will not halt the sweep circuit. Moreover the polarity of the AFC loop is reversed on reception of an image and will not sustain a stable lock condition.

Speech from the microphone amplifier and datalink tones are summed together with the AFC control voltage at the input of IC5. The output of IC1a is a low-impedance point so the modulation index of the AF+DATA signal is set by the voltage dividing action of R5 and R32.

## The Modem and Speech Circuits

The requirement for a datalink originated with the need for the two instruments in the Micromin link to transmit data to each other. In the measurement frame the Master instrument informs the Remote what pattern to measure on, and the Remote replies with the resulting phase measurement of that pattern.

The datalink for the Micromin only needs to be simplex for this purpose, but during its development it was realised that it would be very simple to allow the user access to the datalink during the time when the instruments are not using it for measurement. It was also decided to supply a fully duplex link, as this could be achieved with the addition of only a small number of components (a low and a high pass filter in the data path of each instrument) which only marginally increases the cost.

The maximum usable Baud rate is limited by the bandwidth available over the microwave link. The ceramic filters used in the IF stage are the Murata SFJ10.7MA2. These have a -3 dB bandwidth of 300 KHz and an -80 dB stop bandwidth of 800 KHz. Assuming a low modulation index ( $\beta=0,7$ ) this bandwidth alone would imply that a maximum modulating frequency of as much as 150 KHz would be possible. However there are two of these filters in each instrument and the tolerance of the two filters has to be considered.

The setting of the discriminator coil in the Remote's IF determines the point on the S-curve to which the AFC circuit locks, and this should be exactly in the centre of the passband of the filters. If it is not so, the filter roll-off will attenuate one sideband of the datalink more than the other.

Considering the temperature stability and the manufacturing tolerances, the usable IF bandwidth is taken to be 250 KHz (as used in the calculation of receiver noise figure in equation 3-3), and the modem frequencies were chosen to lie below 100 KHz to guarantee the performance of the datalink.

The modems used are the Exar XR2206 FSK transmitter and the XR2211 FSK receiver.

The link from the Remote to the Master is in a band from 25 kHz to 35 kHz and the link from the Master to the Remote is in a band from 75 kHz to 85 kHz.

These mark and space frequencies are far enough apart to allow a maximum data rate of 9 600 Baud. This data rate is considered high enough to satisfy a very wide number of possible applications.

The wide separation (of 40 kHz) between these two frequency bands allows the use of simple filters to achieve a high degree of isolation between the two channels. The best filters for the Exar modems are Butterworth filters, due to their linear phase response within the passband.

The filter characteristics and circuit diagrams of the Master and Remote transmit and receive filters are shown below in Fig.3-12.

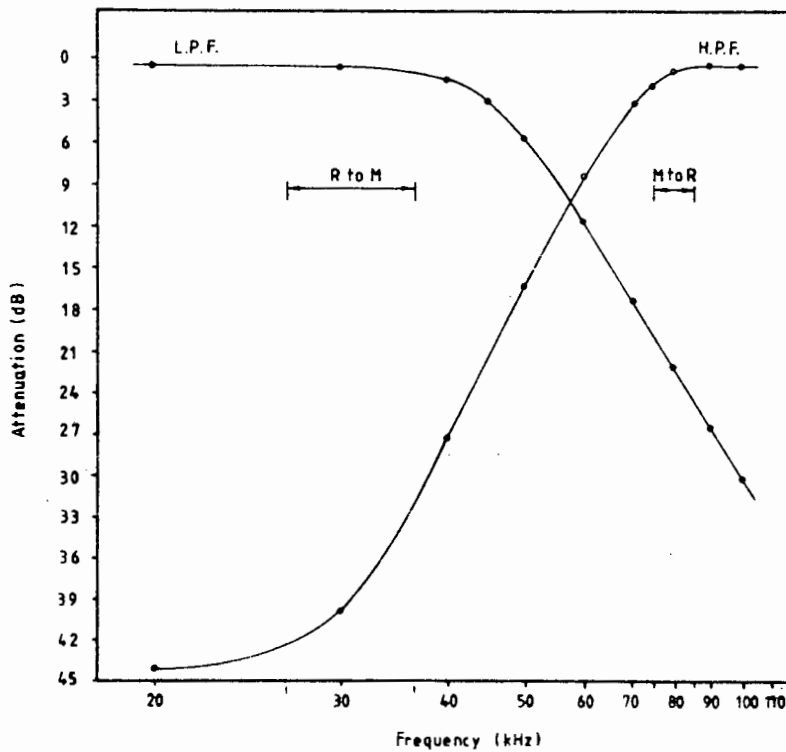
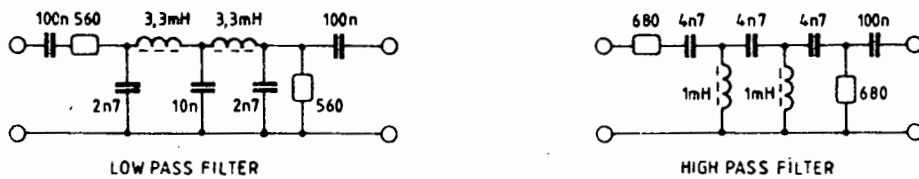
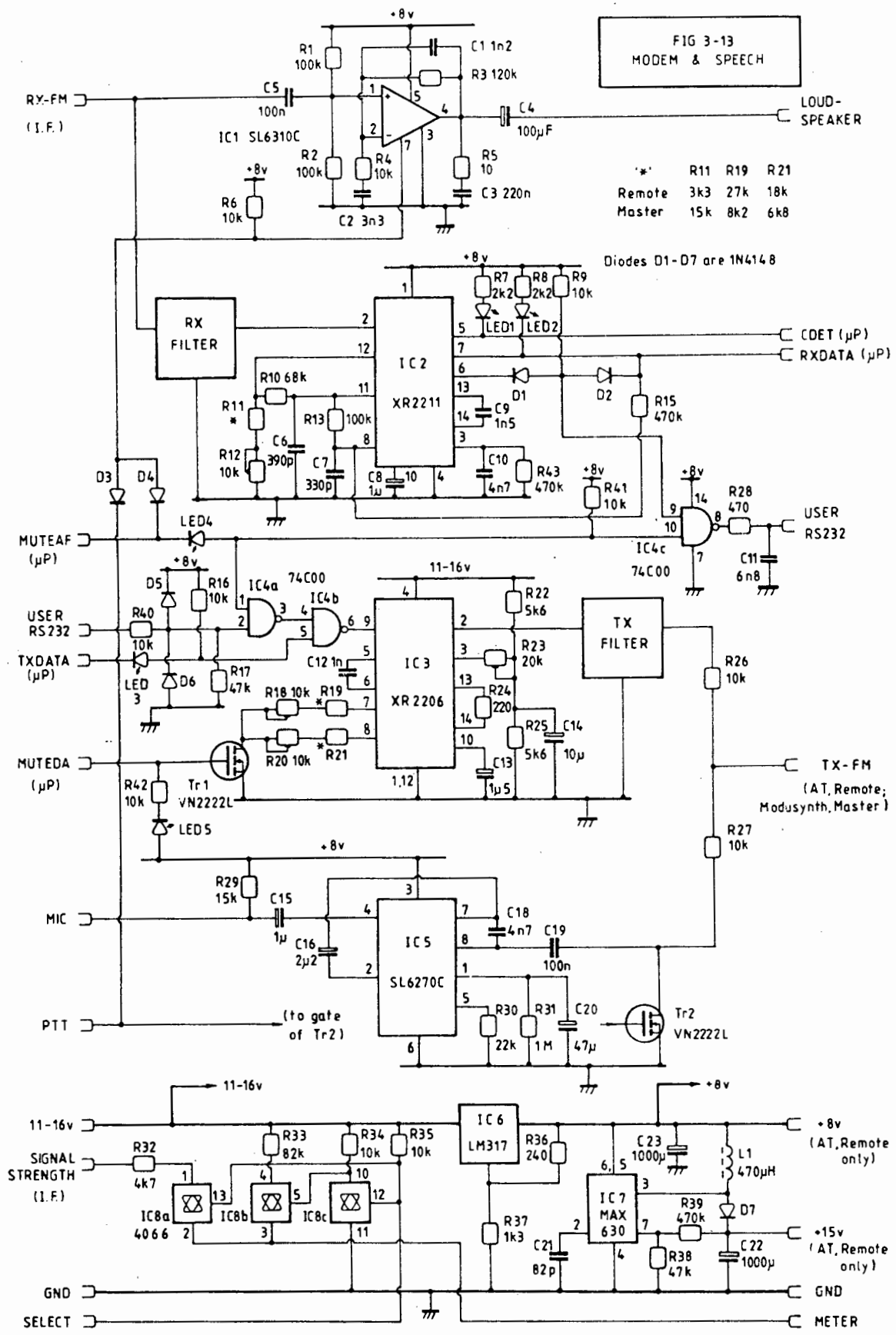


Fig.3-12, Circuits and Frequency Responses of Modem Filters



The ancillary circuits for the Micromin shown in Fig.3-13 include;  
the modem, IC2 and IC3,  
the speech circuitry, IC1 and IC5,  
the meter select circuit IC8, and  
the +15 V switching supply, IC7 for the Autotune.

IC8 is a 4066 quad transmission gate which is used to switch the meter from displaying the incoming signal strength to displaying the battery voltage.

The DATA & AUDIO signal from the IF feeds the baseband speech signal to the loudspeaker amplifier IC1. This has a gain of 12, set by R3 and R4, and provides approximately 400 mW of power to an 8  $\Omega$  speaker. During measurement and when speaking, IC1 is muted by taking the voltage level at pin 7 below 1 V. This is done by the diode OR-gate of D3 and D4. No volume control is provided as this was not found to be necessary (the hiss from the speaker is a most obvious indication to the operator that the instrument is switched on, and the quieting when in lock is a clear indication that the instruments are tuned into each other).

The microphone preamplifier is a two stage amplifier with a voice-operated gain-adjustment device (VOGAD) which provides an almost constant output amplitude of 90 mV rms for any signal input greater than 2 mV rms. The attack and decay times are controlled by R31 and C20. The attack time is defined as the time for the output to return to within 10% of the original level following a 20 dB increase in input level. With C20=47  $\mu$ F this time is 19 ms. The decay time is determined by the discharge rate of this capacitor via R31, which at 1 M $\Omega$  is 20 dB in 0,5 seconds. The microphone used is a small electret device mounted on the front panel of each instrument. These microphones need a DC supply and this is provided by R29.

Press-to-talk is provided by muting the output using Tr2. Various methods of muting IC5 have been tried, muting the input at pin 4, muting the signal from the output of the first amplifier stage at pin 2, switching off the supply, and muting by shorting the output. The first two methods resulted in a small but unacceptable residual noise output due to the high gain of the following unmuted stage(s).

Switching on and off the power supply to IC5 resulted in clicks that could throw the instruments out of tune under weak signal conditions. The last method, of muting by shorting the output, works the best and gives a clean muting action with no residual noise output. When the PTT line is low Tr2 is off and the output signal is unmuted.

The DATA & AUDIO line from the IF also feeds the data signal to the receive modem IC2. The RX FILTER is configured to be a low-pass filter in the Master and a high-pass filter in the Remote. The selection of R11 determines that the receive modem can be tuned, in the case of a Remote (with R11=3,3 k $\Omega$ ) to 75-85 KHz, and in the case of the Master (with R11=15 k $\Omega$ ) to 25-35 KHz. The outputs of IC2 are the carrier detect line CDET from pin 5 and the received data RXDATA from pin 7 which are fed to the microprocessor board option. These are open-collector outputs and interface from the 8 V rail of IC2 to the 5V rail of the microprocessor by the pull-up which is voltage-limited by light-emitting diodes LED1 and LED2.

Diodes D1 and D2 form a diode OR-gate which mutes any data output from IC2 in the absence of any carrier detect, such as when the instruments are not in tune. This is controlled by the open-collector output of pin 6, which is the inverse of the CDET signal on pin 5. In the absence of a carrier detect pin 6 is held low thereby muting any random data output by disabling IC4c.

When there is a carrier detect pin 6 of IC2 goes open-circuit and the open-collector data output of pin 7 can pull down pin 9 of IC4c (via D2) which drives the USER RS232 output. The MUTEAF line, normally held high by R6, is pulled low by the microprocessor during measurement. This disables IC4c to ensure that the data passed between the two Micromins during measurement is not transmitted to the USER RS232 output.

Note that the USER RS232 output is not a true RS232C signal which is defined as a bipolar signal where a "space" is between +3 V and +25 V, and a "mark" is between -3 V and -25 V. The USER RS232 output only supplies a 0 to 8 Volt signal. This simplifies the design of the power supply, by not having to generate a negative supply rail in the instrument.

The signal risetime of the USER RS232 output is limited by R28 and C11 to less than 30 V/ $\mu$ s, in compliance with the EIA RS232C specification.

The FSK transmitter IC3 is an Exar XR2206 and its frequency of operation is configured by selection of R19 and R21. As a Remote IC3 works in the band 25-35 KHz with R19=27 k $\Omega$ , and R21=18 k $\Omega$ . As a Master it works in the band 75-85 KHz (R19=8,2 k $\Omega$ , and R21=6,8 k $\Omega$ ). The XR2206 is a function generator capable of producing sine, square, triangle, ramp, or pulse waveforms of high stability. In this application it is configured to provide a sine wave; R24 optimises the waveform. The output amplitude of IC3 is set by R23. The minimum supply voltage of the XR2206 is 10 V and so IC3 is connected to the unregulated 11 to 16 V supply. A change in supply voltage from 11 V to 16 V results in an insignificant change in output frequency of only 42 Hz at 85 KHz (0,01 %/V).

The data inputs to IC3 come from either the microprocessor option or the USER RS232 input.

During measurement MUTEAF from the microprocessor goes low to disable IC4a, and prevent any USER RS232 data affecting the datalink. LED4 and R41 interface between the microprocessor CMOS running at 5 V and IC4 74C00 running at 8 V. TXDATA from the microprocessor is normally held high by the software (or R16 if the microprocessor option is not installed). LED3 and R16 provide additional 5 V to 8 V interfacing. A low state on TXDATA pulls pin 5 of IC4b down to about 2,4 V, which is a guaranteed low state for IC4. A high state on TXDATA allows the voltage on pin 5 of IC4a rises to about 7,5 V which is a guaranteed high state.

The mute data line MUTEDA from the microprocessor switching Tr1, is used to switch off IC3 by stopping its oscillator. This method of muting is very effective, and is used during the measurement frame to switch off the modems at both instruments during phase measurement. In the datalink configuration (where the microprocessor is not fitted) R42 and LED5 ensure that the transmit modems are permanently enabled.

The frequency of the oscillator of IC3 is controlled by C12 and by either R18 & 19 or R20 & 21, depending on the logical input state of pin 9. If pin 9 is high (>2 V) then R18 and R19 are activated, if pin 9 is low (<1 V) then R20 and R21 are activated. In this way the output frequency is Keyed between two frequencies.

The TX FILTER is a high-pass filter in the Remote, and a low-pass filter in the Master.

The RX and TX filters are Butterworth filters giving minimum passband ripple and phase change. They are designed to give a 20 dB/octave roll-off and the cut-off frequencies are 45 KHz for the low-pass filter and 70 KHz for the high-pass filter. In both receive and transmit cases the filters are driven from low-impedance sources and drive high-impedance loads, so the 560  $\Omega$  and 680  $\Omega$  resistors define the characteristic impedance of the filters. The 100 nF capacitors are only to provide DC blocking and play no part in the filtering action.

Note that the printed circuit board track design for both the high- and low-pass filters is the same, capacitors simply being changed for inductors and vice versa. The same printed circuit board layout can be used in both the Master and the Remote instruments.

The step-up switching-regulator, IC7 etc. uses a Maxim MAX630 which provides +15 V needed for the Autotune in the Remote instrument. The output voltage is set by the ratio of R38 to R39, pin 7 of IC7 being compared to an internal 1,31 V bandgap reference. The frequency of the oscillator of IC7 is set by C21 to 25 KHz, and the output ripple is adequately filtered by C22.

(Note that IC7, R38, R39, D7, L1, C21 and C22 are not fitted in the Master instrument as it does not have an Autotune.)

### Microwave Source Power Supply Circuit

A regulated 8 Volt supply derived from the unregulated battery supply (11 to 16 V) is provided for the Gunn sources.

The varactor bias for the Master instrument is also taken from this 8 V supply to maintain the source at a frequency of 10,30 GHz.

The varactor bias for the source in the Remote instrument is provided by the AFC circuit of the Autotune.

The Gunn supply circuit is shown in Fig.3-14.

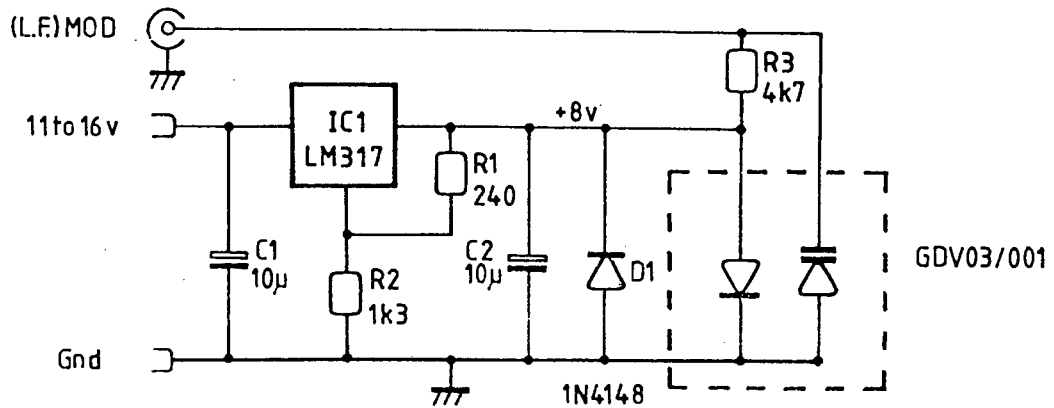


Fig.3-14, Microwave Source Power Supply Circuit

## References for the formulae

- 3.1 Kraus J.D. (1950)  
"Electrical and Electronic Series, Antennas", McGraw Hill,  
page 380, equation 13-49.
- 3.2 "ITT Reference Data for Radio Engineers, 6th Edition",  
1982, page 29-1.
- 3.3 Glazier E.V.D. and Lamont H.R.L. (1958),  
"The Service's Textbook for Radio, Volume 5, Transmission and  
Propagation", H.M.S.O., London,  
page 272, equation 9.25.

## CHAPTER 4

### The Modusynth

**Modusynth** is derived from the term "modulator and synthesiser". The circuit diagram of the modusynth, shown in Fig.4-1, consists of two sections,

a synthesiser, or frequency-locked loop, used to generate pattern frequencies with very low phase noise and,

a modulator, used to buffer, divide and filter the loop signal, and to modulate the microwave source.

The frequency-locked loop is shown in the top half of Fig.4-1, and the modulator is shown in the bottom half.

The loop generates a signal in the range of 19,6 MHz to 21,25 MHz in steps of 2,441 KHz, with special attention being made to reduce phase noise to improve measurement accuracy.

The loop has a 2,5 MHz reference derived from the TCXO on the microprocessor board. This is fed to IC3 the synthesiser chip, where it is divided by a further  $2^{10}$  to form the 2,441 KHz reference for the phase comparator.

The component values of the VCO, which consists of Tr7, D7, L1, C16, C19 and C20, have been chosen to achieve a tuning range from 19,5 MHz to 22,5 MHz with a change in control voltage from 1 V to 8 V.

The VCO output is amplified by IC7a (biased into a linear mode by R17) and fed back to the loop (via C4 and R3), and into the modulator, (IC7b pin 10 and IC6 pin 11).

The VCO signal is divided by a programmable divider in IC3 which is set via the serial data bus SYNDATA, SYNCLK and SYNEN.

The minimum division ratio is 8 184 and the maximum is 8 712 (dec), setting the VCO frequency to 19 980,468 kHz and 21 269,531 kHz respectively.

A digital phase detector in IC3 compares the phase of the 2,441 kHz reference with the divided VCO signal and produces the control signals  $\phi_r$  and  $\phi_v$ .

The sample-and-hold circuit produces an output voltage proportional to the pulse width of  $\phi_v$  which is used to control the frequency of the VCO.

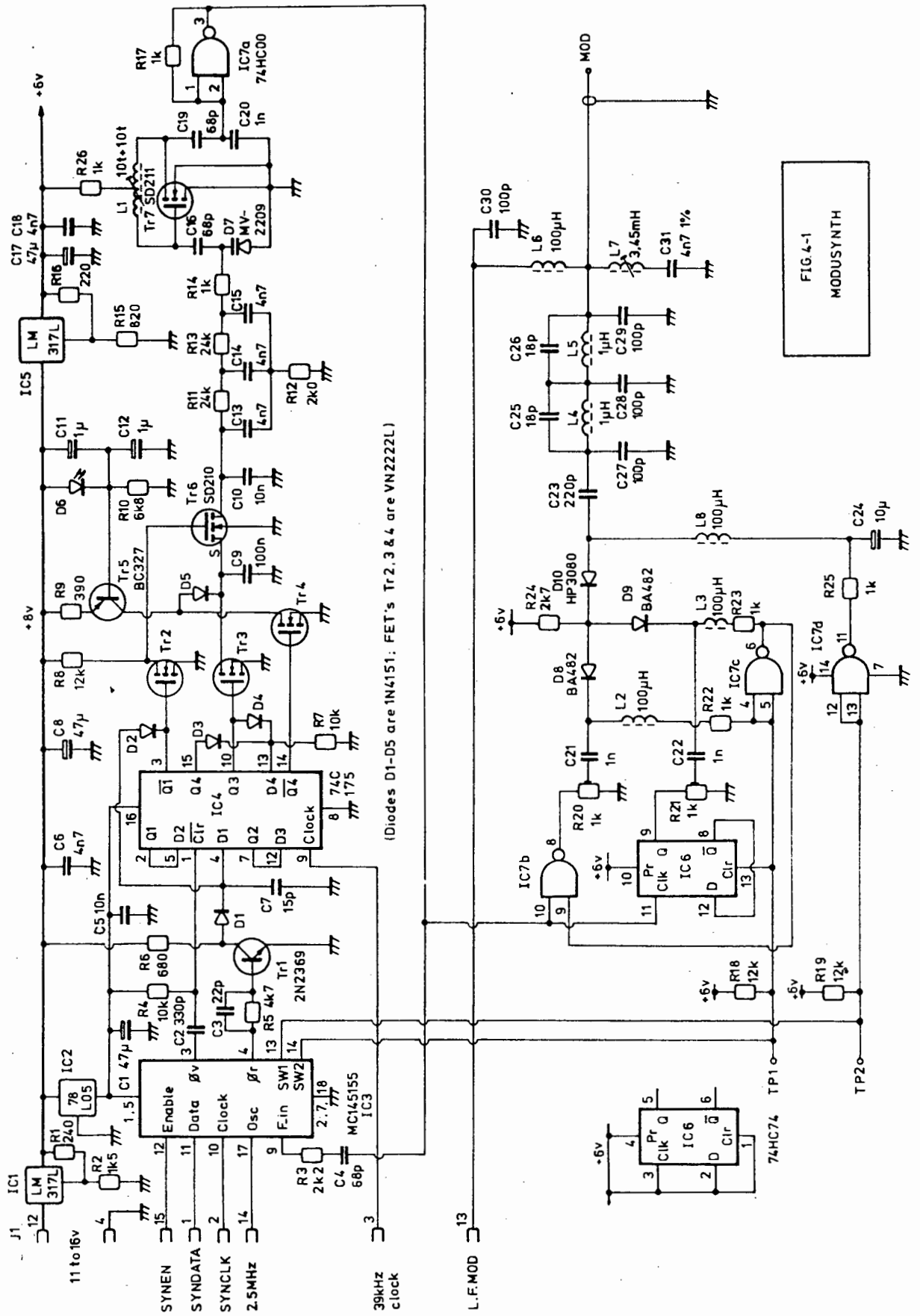
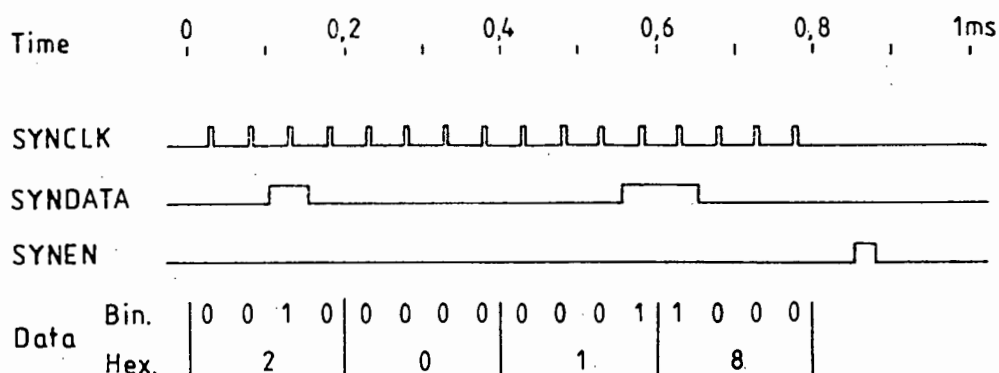


FIG 4-1  
MODUSYNTH

## The Loading Sequence of the Synthesiser.

The data bus lines SYNCLK (synth clock), SYNDATA (synth data) and SYNEN (synth enable) are driven by the microprocessor.

The sequence of loading the division register of IC3 with a value of 2018 (hex) is shown in Fig.4-2.



**Fig.4-2, The Loading Sequence of the Synthesiser**

The synthesiser loading is controlled by subroutine SYNTH which can be found on line 1606 of the software listing.

The rising edges of SYNCLK clock 16 bits of data into a shift register in IC3; SYNEN then moves the data from the shift register into a latch.

Serial loading of the synthesiser is achieved in 0,9 ms.

The loop operation is undisturbed during the serial data transmission, because the new data bits affect the loop only after the SYNEN strobe.

The first two bits in the serial data stream (the 00 in the 2 (hex) in Fig.4-2) are fed to open-drain outputs, SW1 and SW2, which are used to switch the modulator division ratio and to turn the modulator on and off.

## The Sample-and-Hold Phase Detector

The outputs of the phase comparator,  $\phi_r$  and  $\phi_v$ , control the sample-and-hold circuit in which IC4 (74C175) switches the transistors TR2,3,4,& 6 to control the amplitude of a ramp waveform on C9.

Fig.4-3 shows the operation of the sample-and-hold phase detector.

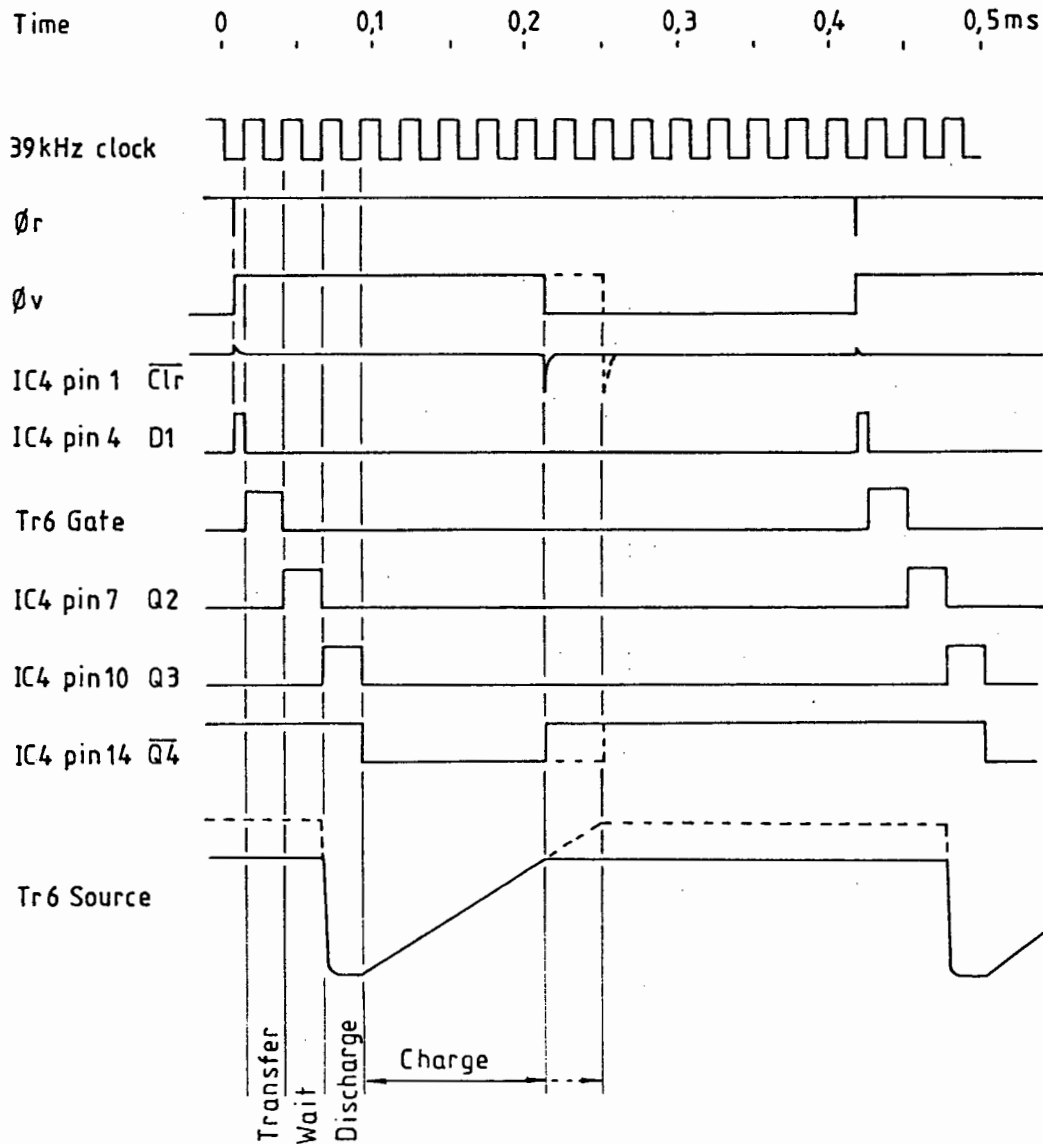


Fig.4-3, The Sample-and-Hold Timing Diagram

The function of the sample-and-hold circuit is to set the DC voltage on C10 proportional to the pulse width of  $\phi_V$ .

An operational cycle of the sample-and-hold is a sequence of six actions controlled a shift register consisting of four serially connected D-type flip flops (IC4), clocked by 39KHz-Clock derived from the microprocessor.

The six parts of the cycle are described as follows.

- 1) The cycle is initiated by the  $\phi_r$  pulse which is inverted by Tr1 allowing R6 to charge up C7 via D1.
- 2) The charge on C7 is held on the data input D1 (pin 4 of IC4) until the next rising edge of the 39 KHz clock which clocks this high state through to Q1. Q1(bar) discharges C7 via D2, and switches on Tr6 (via Tr2) to charge of C10 from C9. This is the TRANSFER part of the cycle.
- 3) The logic 1 state of Q1 is clocked through to Q2 on the following rising edge of the 39 KHz clock. This constitutes a WAIT separating the TRANSFER and DISCHARGE parts of the cycle.
- 4) The logic 1 state of Q2 is clocked through to Q3 on the next rising edge of the 39KHz clock, switching on Tr3 to discharge C9. This is the DISCHARGE part of the cycle.
- 5) The logic 1 state of Q3 is clocked through to Q4 on the next rising edge of the 39 KHz clock, Q4(bar) goes low switching off Tr4 thus allowing the 3,2 mA constant current source of Tr5 to charge C9 through D5. This is the CHARGE part of the cycle.

6) The charging of C9 is interrupted by the falling edge of  $\phi_V$ , which is differentiated by C2 and R4 to create a pulse which clears all the Q outputs of IC4.

The charge on C10 remains steady until the next transfer from C9 due to the very low leakage current through the varicap diode D7.

The dotted lines in Fig. 4-3 show how the loop responds to a change in frequency.

## The Notch Filter

The notch filter of R11,12,13, C13,14 & 15 attenuates ripple in the control voltage at the sampling frequency of 2,441 kHz. The frequency response and circuit of this filter is shown in Fig.4-4.

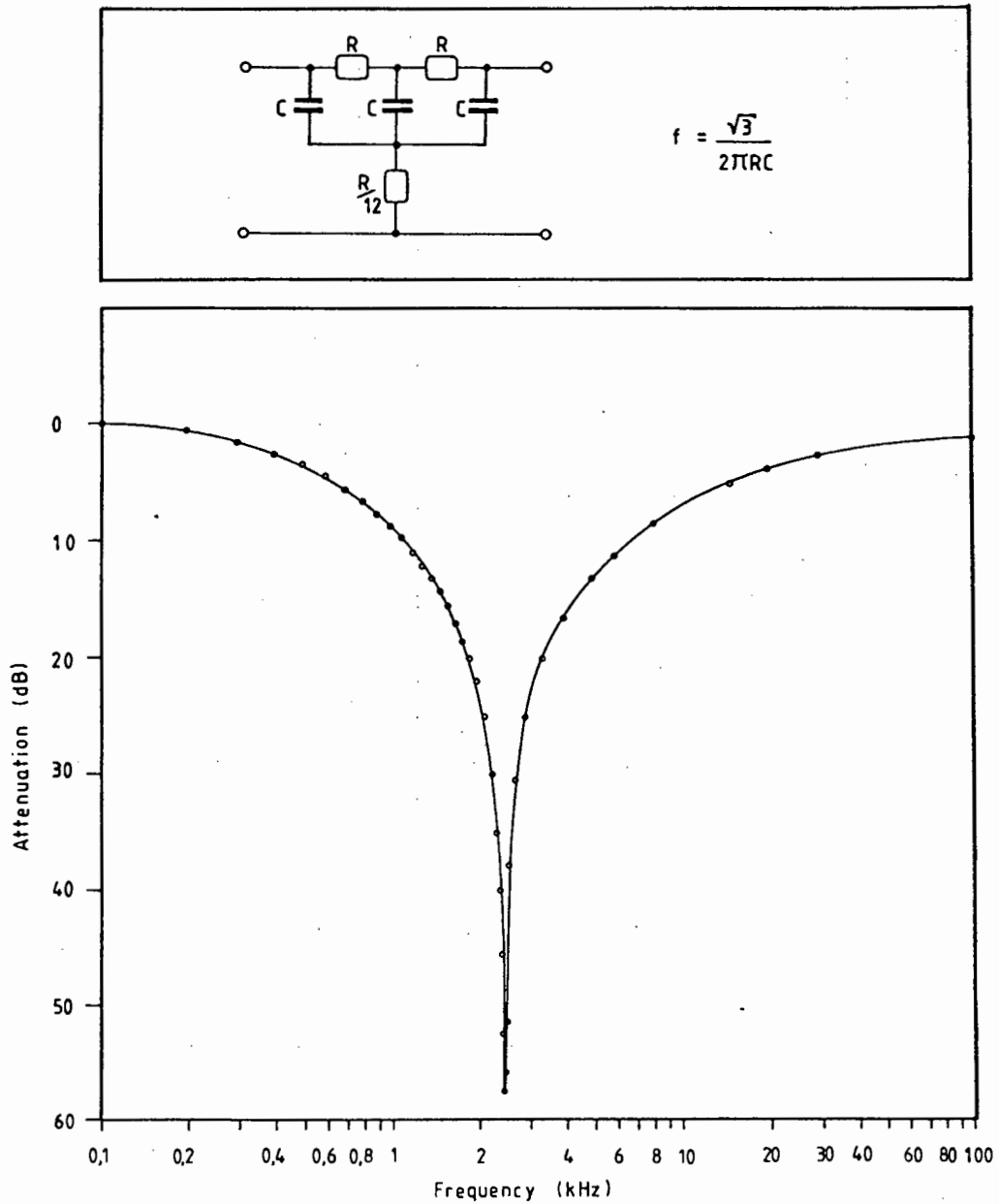


Fig.4-4, Notch Filter Circuit and Frequency Response

## Synthesiser Locking Time

Synthesiser locking time is kept to a minimum because the loop frequency is changed three times in each frame. Too slow a response time will have an accumulative effect on the length of the frame, thereby lengthening the total time for the measurement. The change in measured position of a moving platform between frames is also affected by the frame length, so keeping the frame length short helps the position-updating capability of the dynamic mode of operation. The loop response to a change in frequency from 20 136 kHz to 20 605 kHz is shown in Fig.4-5, which plots the change in voltage across the varicap diode D7.

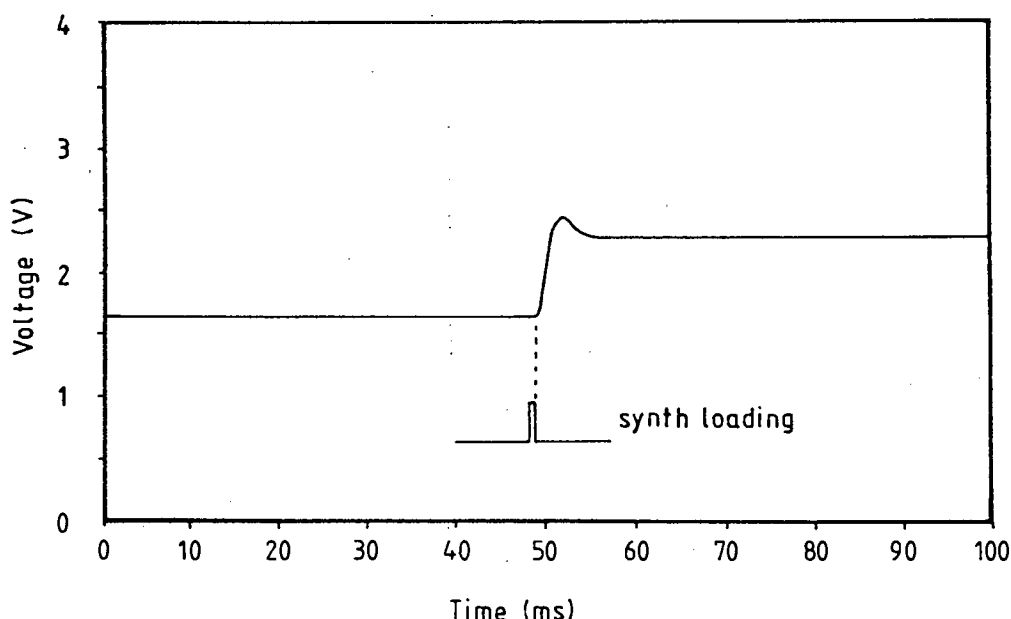
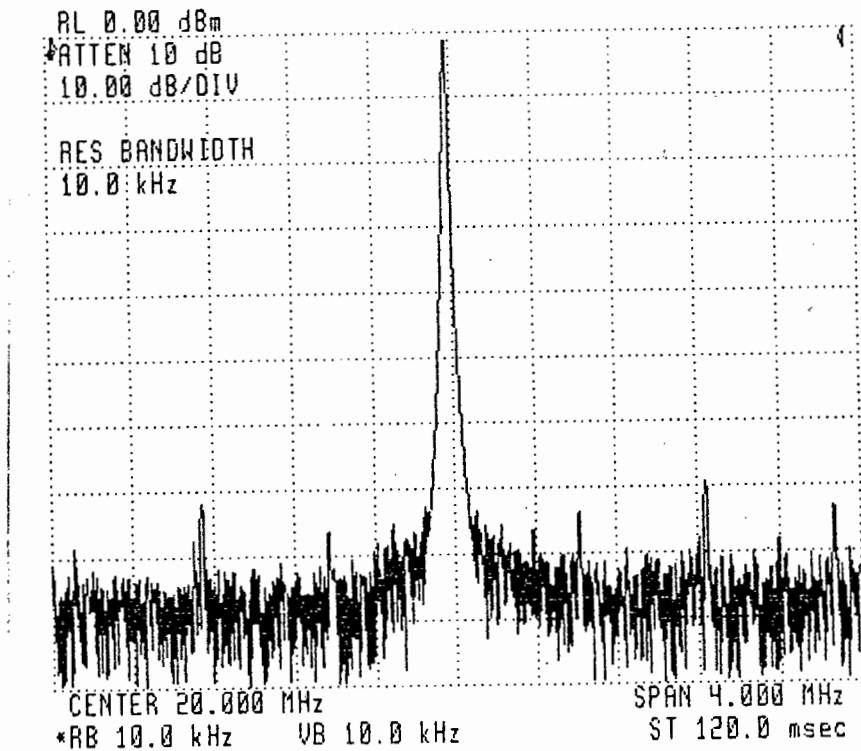


Fig.4-5, Synthesiser Locking Time

As shown above a typical settling time for the synthesiser is <10 ms. In the measurement frame a settling time of 35 ms has been allowed before phase measurement of the 39KHz-Phase signals. This is more than adequate time to allow the phase of the 39KHz-Phase signals to stabilise to within 1 part in 64 (the measurement accuracy of each sample).

## The Output Spectrum

A typical output spectrum of the modusynth is shown in Fig.4-6, showing noise components at approximately -70 dBc.



**Fig.4-6, Modusynth Output Spectrum**

The low synthesiser noise level results in low phase-noise on the final Comparison-Frequency phase measurements.

## The Modulator

The modulator halves the synthesiser output frequency (when required), filters it, adds low frequency modulation to it and feeds this composite signal to the varactor diode in the microwave source.

For 20 MHz patterns SW2 of IC3 is low, switching D8 on and D9 off, and disabling the divider IC6. IC7b buffers the output of the synthesiser and R20 sets the signal amplitude

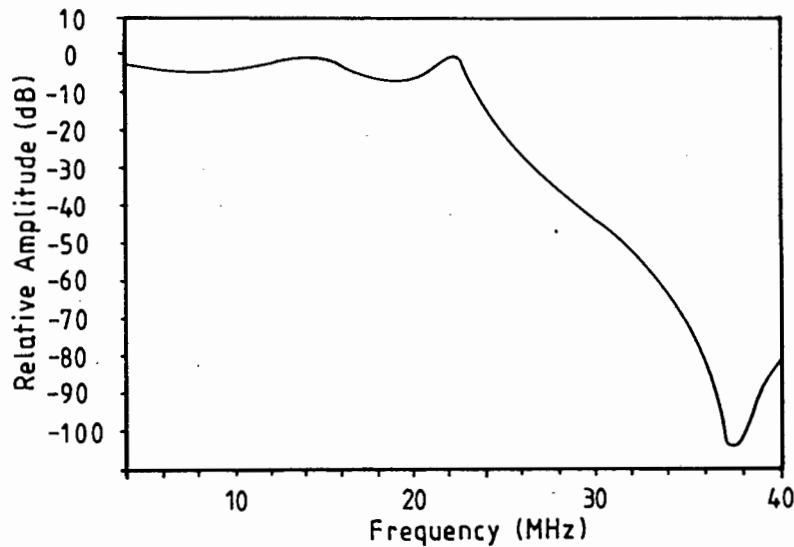
For the 10 MHz signals required for pattern 6, SW2 of IC3 is high allowing the divider to operate, switching off D8 and switching IC7c which switches on D9 and mutes the 20 MHz buffering action of IC7b. IC6 divides the VCO output by two and R21 sets the signal amplitude.

The modulation output can be switched off by D10. The switching speed is set by R25 and C24 to limit the rate of change of modulation amplitude. Due to the non-linear tuning curves of the microwave sources (see Figs.3-2 and 3-3) modulation has an asymmetrical effect on the frequency of the source, the average effect of which pulls the centre frequency. Fast changes in modulation index can pull the carrier frequency out of the IF passband faster than the AFC loop can compensate for, and the AFC loop will lose lock. It is for this reason that R25 and C24 have been chosen to set the time constant for the change in modulation level to 10 ms.

The software allows 35 ms for the modulator to switch on during the measurement frame prior to phase measurements being made.

The output of the modulator is filtered by a low-pass filter consisting of C25, C26, C27, C28, C29, L4 and L5.

The frequency response of this filter is shown in Fig.4-7.



**Fig.4-7, Modulator Filter Frequency Response**

The output of the modulator is filtered to prevent any unwanted signals mixing to produce components that fall within the IF passband that might contaminate the phase of the desired mixing product at 39,062 kHz.

The output of IC6 has a 1:1 mark-space ratio and hence contains very little 2nd harmonic so it is not necessary to have a separate filter for the 10 MHz output. A common filter is used that attenuates the 3rd harmonic of 10 MHz by 45 dB, and the 2nd harmonic of 20 MHz by approximately 80 dB. This is more than satisfactory for the requirements of the Micromin.

The filter has a slight decrease in attenuation from 20 MHz to 22 MHz which equalises the modulation index of patterns from 20 to 21,25 MHz, particularly pattern 5 which has a 21,25 MHz centre pattern straddled by 20 MHz patterns.

For a given modulation index the required amplitude of the modulating signal is proportional to frequency.

Experience has shown that a modulation index of 0,7 at both the Master and Remote results in the best recovery of AM from the IFs. Modulation index is related to frequency deviation and frequency of modulating signal by the following;

$$\beta = \Delta f / f_m$$

where,

- $\beta$  = modulation index (a ratio),
- $\Delta f$  = frequency deviation (MHz), and
- $f_m$  = modulating frequency (MHz).

It follows that for a modulation index of 0,7 and given a varactor sensitivity of 10 MHz/Volt, the following peak-to-peak levels of modulating signals are necessary,

$f_m$	Signal Level
10,0 MHz	2,0 V p-p
20,0 MHz	4,0 V p-p

The maximum output signal of the modulator is 5 V p-p, sufficient signal level to achieve the required modulation index.

Low-frequency modulation from the Modem and Speech circuit is fed into the modulator on the L.F.MOD line. The high-frequency pattern outputs of the synthesiser are prevented from being shunted by the low-frequency drive circuitry. L6 and C30 form a low-pass filter allowing the speech and data low-frequency modulations through to the varactor, and blocking the pattern frequencies.

A series resonant trap formed by L7 and C31 shunts any modulation at 39,062 kHz. Baseband frequency modulation at 39 kHz is the cause of cyclic contamination, described in Chapter 6. This series resonant trap effectively removes this source of error.

## The Pattern Set

The pattern set produced by the modusynth is shown below :

Patt	Straddle	Centre	Ambiguity (m)	Ratio
0	20M <sup>-</sup>	20M <sup>-</sup> +2K441	61 397,503	
1	20M <sup>-</sup>	20M <sup>-</sup> +9K765	15 349,376	4:1
2	20M <sup>-</sup>	20M <sup>-</sup> +39K062	3 837,344	4:1
3	20M <sup>-</sup>	20M <sup>-</sup> +156K25	959,336	4:1
4	20M <sup>-</sup>	20M <sup>-</sup> +625K	239,834	4:1
5	20M <sup>-</sup>	20M <sup>-</sup> +1M25	119,917	2:1
6	10M <sup>-</sup>	10M <sup>-</sup> +10M	14,990	8:1
7	20M <sup>+</sup>	20M <sup>-</sup>	3,747	4:1

The + and - signs indicate the "plus" and "minus" patterns.

For example a 20M<sup>-</sup> pattern means that the Master and Remote are simultaneously modulated with sidebands of  $(20-8\omega_m)$  MHz and  $(20+8\omega_r)$  MHz respectively,

where  $16\omega_m = 16\omega_r = 39,062$  kHz, the Comparison-Frequency.

Similarly a 20M<sup>+</sup> pattern is one where the Master and Remote are simultaneously modulated with sidebands of  $(20+8\omega_m)$  MHz and  $(20-8\omega_r)$  MHz respectively.

As mentioned in Chapter 1, the simultaneous modulations of the Master and Remote always differ by the Comparison-Frequency of 39,062 kHz. It is by mixing these two sidebands in the microwave mixers of both instruments that this signal is recoverable as an AM component of the 10,76 MHz IF signal.

The "Ambiguity" column shows the distance at which the resultant phase of the pattern will be 360°, and beyond which the measurement will be ambiguous.

The "Ratio" column shows the amount the phase readings are multiplied by (shifted in the binary arithmetic) for comparison with adjacent patterns in the measurement "breakout".

Patterns 0 to 6 are Difference Patterns, and pattern 7 is an Absolute Pattern.

The Straddle Patterns for patterns 0 to 5 are  $20M^-$  and the Centre Patterns differ from the Straddle Patterns by amounts increasing by a factor of x2, x4 or x8 between each pattern. The differential phase measurement of the Straddle and the Centre Patterns results in a measurement of the phase of the Difference Frequency, (the difference in frequency between the Straddle and Centre Patterns).

The Straddle Pattern of pattern 6 is a Minus Pattern at 10 MHz and the Centre Pattern is 10 MHz higher. This results in a phase measurement of the Difference Frequency of 10 MHz.

Straddle Patterns can be at any frequency as long as the Centre Pattern falls at the correct Difference Frequency above (or below) them. This can be used to avoid frequencies that fall too close to the IF passband.

(Note that if the Centre Pattern is chosen to fall below the Straddle pattern then the sign of the resultant phase measurement will be reversed, for example  $20^\circ$  will become  $340^\circ$ . This would have to be accounted for in the breakout software.)

Pattern 7 is an Absolute Pattern centred on 20 MHz, resulting in a phase measurement of 20 MHz. The Straddle is a  $+$  pattern and the Centre is a  $-$  pattern, the Comparison Frequency is applied to both in opposing sense, resulting in a 4:1 phase relationship between the 10 MHz Difference and the 20 MHz Absolute Patterns (see Appendix A equation A.13).

The following table shows the pattern set in more detail.

Patt	N <sub>S</sub>	Straddle (KHz)	N <sub>C</sub>	Centre Freq (KHz)
0M	8 184	19 980,468	8 185	19 982,910
0R	8 200	20 019,531	8 201	20 021,972
1M	8 184	19 980,468	8 188	19 990,234
1R	8 200	20 019,531	8 204	20 029,296
2M	8 184	19 980,468	8 200	20 019,531
2R	8 200	20 019,531	8 216	20 058,593
3M	8 184	19 980,468	8 248	20 136,718
3R	8 200	20 019,531	8 264	20 175,781
4M	8 184	19 980,468	8 440	20 605,468
4R	8 200	20 019,531	8 456	20 644,531
5M	8 184	19 980,468	8 696	21 230,468
5R	8 200	20 019,531	8 712	21 269,531
6M	8 176/2	9 980,468	8 184	19 980,468
6R	8 208/2	10 019,531	8 200	20 019,531
7M	8 200	20 019,531	8 184	19 980,468
7R	8 184	19 980,468	8 200	20 019,531

The first column indicates the pattern number, the M and R refer to Master and Remote, and N<sub>S</sub> and N<sub>C</sub> refer to the synthesiser division ratio (in decimal) for the straddle and centre frequencies respectively.

For example, 0M is pattern 0 for the Master instrument, and for the Straddle the synthesiser generates

$$(0M) = 8\ 184 \times 2,441 = 19\ 980,468\ \text{KHz.}$$

The "/2" following the divisor for Pattern 6 shows that the modulator divides the synthesiser output by 2, for example the Master Straddle on pattern 6 is generated by

$$(6M) = 8\ 176 \times 2,441 / 2 = 9\ 980,468\ \text{KHz.}$$

## CHAPTER 5

### The Microprocessor and Phase Counter

#### The Microprocessor

The microprocessor and phase counter board controls the timing of the measurement frame and all the tasks involved in the measurement, e.g. the control of the modusynth, data communications with the distant instrument, and phase measurement.

The circuit diagram of this board is shown in Fig.5-1. The microprocessor IC3 is a Hitachi 63701VOC single chip microcomputer which contains all the RAM, EPROM, timers and ports required for the Micromin. It can be configured to run in several different modes. In this application Mode 5 is selected by appropriate logic levels applied to pins 8,9 & 10, that are read at power-up and upon reset. In this mode the data bus (D0 to D7) is not multiplexed, and a simplified version of the address bus is generated, A0, A6, & A7 being the only lines needed for the address mapping. The unused address lines are configured as input ports, and appear as P41 to P45.

The address lines A6, A7 and the IOS line are decoded by the 1-out-of-8 decoder IC8 which generates four active-low chip select lines, which are;

Chip Select	Address Range (hex)	Device Selected
IC8 pin 15	0100 to 0130	Phase counter latch
IC8 pin 14	012F to 017F	Liquid Crystal Display
IC8 pin 13	0180 to 01BF	Synthesiser Enable (SYNEN)
IC8 pin 12	01C0 to 01FF	TCXO Control

IC4a & b invert the chip select lines to the LCD and IC9 as these devices require active-high chip select lines.



Crystal X1 determines the clock frequency of 4 MHz, resulting in a bus cycle time of 1  $\mu$ s. This rate is sufficient for uncritical timing of the real-time data processing in the software.

At power-up the processor is briefly held in a reset state by the delay time constant of R7 and C3. IC4 is a Schmitt trigger inverter to ensure a single clean rising edge on the reset line that ensures reliable starting of the processor.

The liquid crystal display is a Hitachi H2570 single line 16 digit dot-matrix alphanumeric display. The optimum viewing angle is set by R6.

The input and output lines of the microprocessor board are;

11 to 16 V	power supply,
39KHz-Phase	phase comparison signal from the squarer of the IF,
MEAS	front panel switch S1, low to initiate measurement,
TRACK	front panel switch S2, low for static, high for dynamic,
CDET	modem carrier detect,
RXDATA	modem receive data,
2,5 MHz	frequency reference for the Modusynth,
39KHz-Clock	sample-and-hold clock for Modusynth,
MUTEDA	mute data, switches off modem transmission,
TXDATA	modem transmit data,
Spare	spare port,
SYNDATA	serial data to Modusynth,
SYNCLK	data clock to Modusynth,
MUTEAF	mutes audio during measurement,
SYNEN	Synthesiser Enable, data strobe for Modusynth.

The SYNEN strobe for the Modusynth is derived from the chip-select decoder IC8. To create a pulse long enough to guarantee the minimum pulse width required by IC3 of the Modusynth, a pulse is generated four times by the software (see line 1647 of the software listing) and the time constant of R20 and C8 together with the Schmitt trigger of IC4d generate a pulse 20  $\mu$ s wide.

## TCXO Locking

Difference in the frequency of the Master and Remote TCXOs appears as a "slipping" of the two comparison frequencies, which introduces error terms in the measurement (see Appendix A). The TCXOs are locked together during the measurement to cancel these error terms.

The X9103 (IC9) is a 100 step digital potentiometer, controlled in the measurement routine to lock the frequency of the Master TCXO to that of the Remote. At power up IC9 is initialised to the centre of its range by incrementing 100 times and decrementing 50 times (see line 202 of the software listing).

Two groups, each of 128 phase counter readings, make up the phase measurement of each pattern. The averages of these two groups are compared to determine the direction of drift between the Master and Remote references.

The frequency of the Master TCXO is pulled to counteract any detected drift, and in this way the TCXOs are frequency-locked together.

The extent of frequency adjustment is limited to  $\pm 15$  Hz by R18 and R19.

Subroutine TCXO performs the locking function and can be found on line 1561 of the software listing.

In both the Master and the Remote instruments R18 is used to set the frequency of the TCXOs to 5,000 000 MHz  $\pm$ 5 Hz.

The Master TCXO frequency is adjusted to equal that of the Remote and the Remote does not need IC9. Fig.5-2 shows how the TCXO is configured in each instrument.

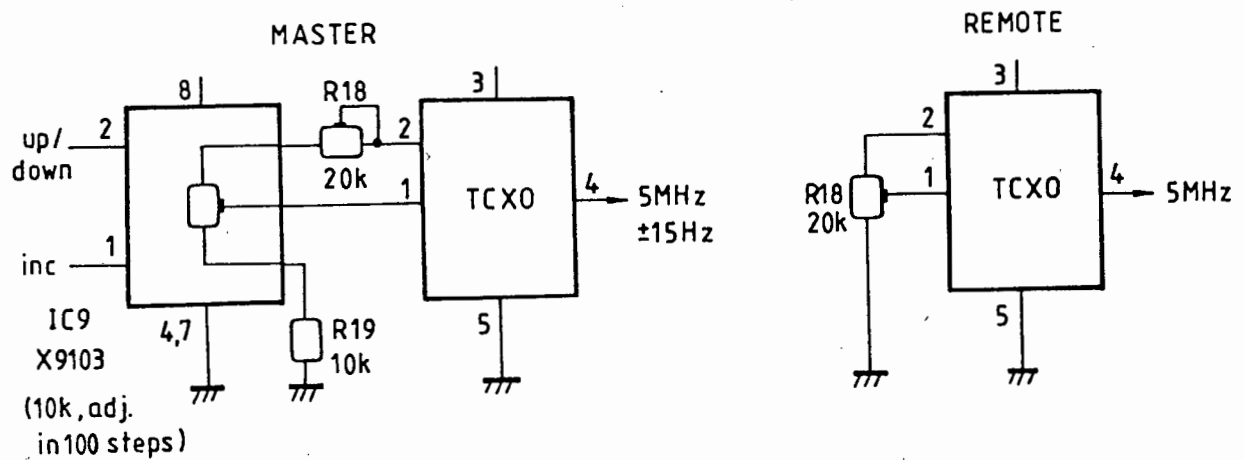


Fig.5-2, TCXO Configuration in Master and Remote

## The Phase Counter

The phase counter is shown at the top of Fig.5-1, and appears in more detail in the timing diagram of Fig.5-3.

The function of the phase counter is to measure the phase of the "39KHz-Phase" signal relative to the phase of the 9,7 KHz reference signal derived from the reference TCXO via the divider IC10.

It consists of a dual edge-triggered flip-flop (IC5) that gates a 5 MHz clock (5M) to a counter (IC6), and a latch to transfer the counter value to the microprocessor data-bus via a three-state output.

The use of edge-triggered JK flip-flops to gate the clock was chosen because it produces an integer number of clock cycles of the correct pulse-width, i.e. there is no truncation of the pulses fed to IC6. A simpler (level sensitive) gating arrangement using a NAND gate was tried but found to create pulses that were less than the minimum pulse width specification of IC6. This had the effect of disrupting the counter state in an unpredictable manner.

The 9,7 KHz reference signal is inverted by IC4c. The falling edge of the output of IC4c is differentiated by C6 and R3 to create a negative-going pulse that is fed to S1(bar) of IC5. This pulse causes Q1 to go high which does two things.

- Firstly, the rising edge of Q1 is differentiated by C7 and R5 to create a positive-going pulse the falling edge of which clears the counter register of IC6.
- Secondly Q1 is fed to J2 of IC5b, Q1(bar) is fed to K2(bar), and this allows the 5 MHz signal feeding CLK2 to toggle IC5b.

IC5b halves the clock frequency and produces a 2,5 MHz clock train to the counter IC6.

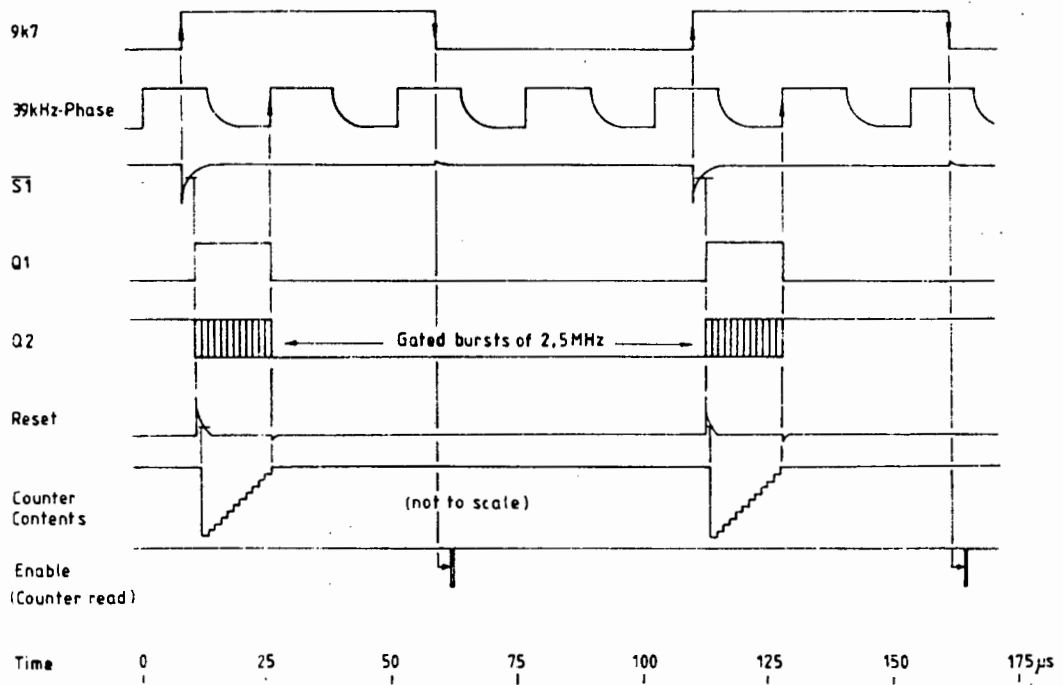
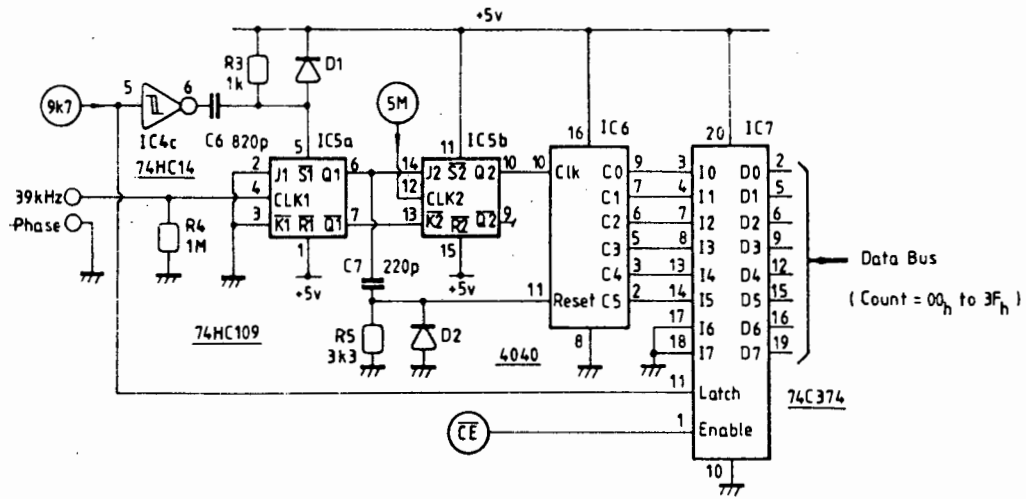


Fig.5-3, Phase Counter Circuit and Timing Diagram

The counter register of IC6 increments with each rising edge of Q2. This continues until there is a rising edge of 39KHz-Phase on the CLK1 input of IC5a, which sets Q1 and clears Q1(bar) and so disables IC5b.

The falling edge of the 9,7 kHz reference transfers the output (C0 to C5) of the counter into a latch in IC7. This falling edge is also detected by the microprocessor (P10 of IC3) which then reads the contents of the latch.

The value of the counter is proportional to the phase difference between the 9,7 kHz reference and 39KHz-Phase.

The maximum value of the reading is the number of cycles of 2,5 MHz that can occur in one cycle of 39,062 KHz, which is 63(dec) or 3F(hex).

It can be seen from the timing diagram that the phase is read only on every fourth cycle of 39KHz-Phase. This is because the rate of data collection by the software is limited by the speed of operation of the software. This is not a critical limit, at the 4 MHz clock rate the microprocessor can comfortably read every fourth cycle of the phase-counter. To read every third (or less) cycle would require a higher speed microprocessor clock, and need a more costly microprocessor chip. This would not result in any justifiable improvement in the performance of the instrument.

The phase-reading routine averages 256 readings of the phase counter in two sets of 128 readings taking into account any roll-under or roll-over in the reading (e.g. if the reading changes from 01 to 00,3F,3E etc.).

The phase-reading software is Subroutine PHSMES and can be seen on line 1483 of the software listing.

## The Software

The software listing in Appendix D is written in assembly language on a Hewlett Packard HP64000 microprocessor development system. The comments within the listing adequately describe the code and it forms a readable document in its own right.

The program is contained in a single module allowing the assembler to address all RAM in the Direct Addressing mode, which uses one byte per address, instead of the two-byte addresses needed by Extended-Addressing mode. This conserves valuable EPROM space. (The 63701VOC processor contains 4 096(dec) bytes of internal EPROM and 192 bytes of RAM).

The Micromin program consists of approximately 3 000 bytes of measurement routines and approximately 300 bytes of special test routines to facilitate testing and alignment.

The program uses up 3 334(dec) of the 4 096(dec) available bytes of the EPROM (i.e. 81%). So future enhancements can be added without a major redesign.

RAM variables are declared from 0040(hex) through to 00C8(hex) leaving the area from 00C9(hex) through to 00FF(hex) for the stack. The stack is used by the CPU to store return addresses and register contents for subroutine jumps and interrupt-service routines. The stack-pointer position was traced through all conditions of the program's execution, to confirm the required stack depth. The results of this trace are shown in Fig.5-4.

Fig.5-4 shows the movement of the stack-pointer for both instruments for all conditions of the program's operation, from initialisation through to testing, distance measurement, and display. The stack pointer is initialised to 00FF(hex) and is decremented by one for each byte stored on the stack. The names of the subroutines are shown positioned to the left by the amount of the stack they use, and progress down in the order of program execution.

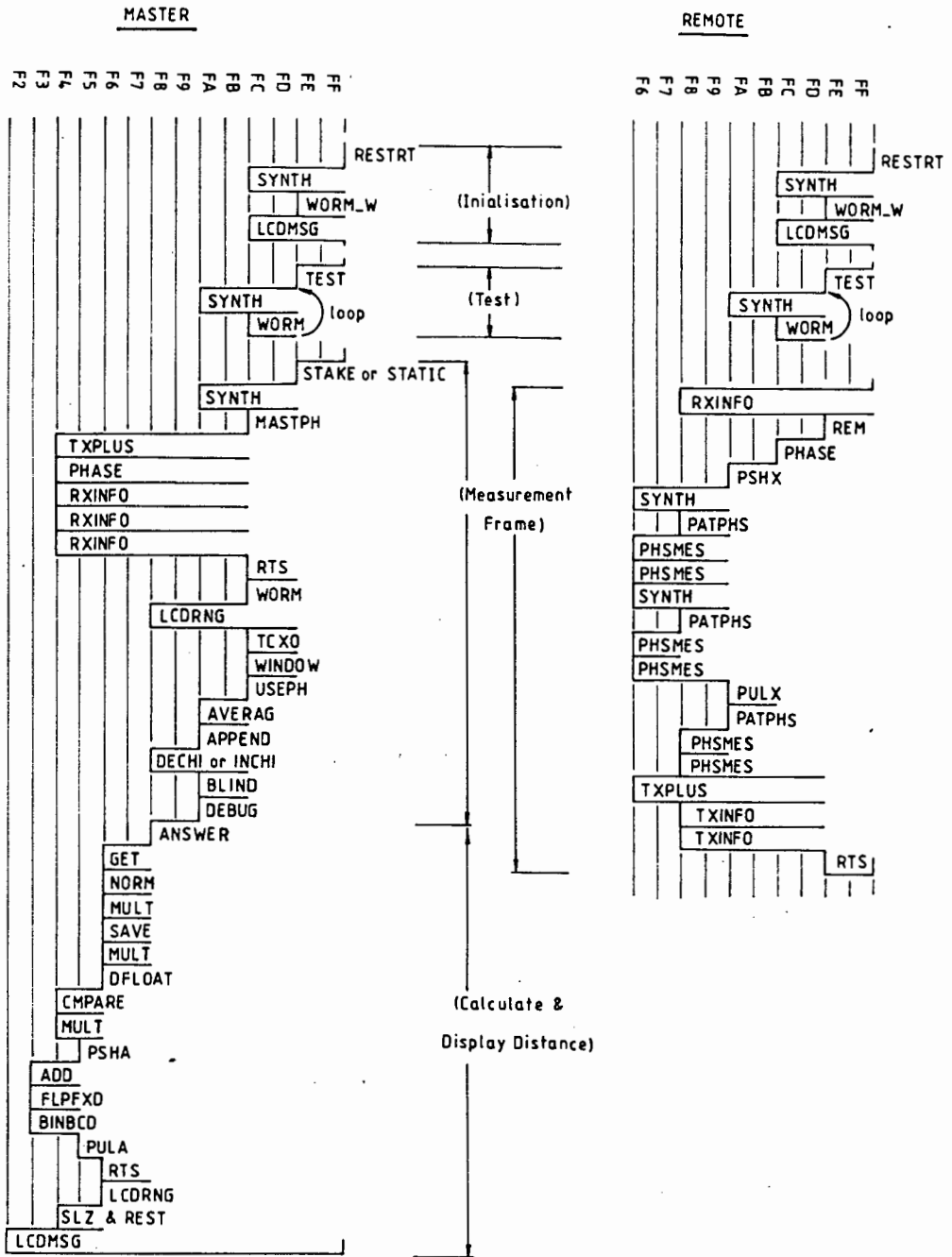


Fig.5-4, Software Operation and Stack Depth

It can be seen from Fig.5-4 that the stack drops down to 00F2(hex) in the Master, and down to 00F6(hex) in the Remote.

An interrupt will store 8 bytes on the stack. Only one interrupt can occur at a time, so the lowest used stack position is 00F2-8 = 00EA(hex) in the Master, and 00F6-8 = 00EE(hex) in the Remote.

If the stack were to drop as low as 00C9(hex) it would overlap RAM variables and writing there would corrupt the stack and result in a program "crash". This will not happen in the Micromin as there are 33(dec) unused bytes between the top-most RAM variable and the lowest possible position of the stack.

Maximum RAM usage is 159 out of the 192 bytes i.e. 83%.

The operation of the software can be described in four main parts,

- 1) Initialisation
- 2) Test
- 3) Phase Measurement Frame
- 4) Breakout Calculation and Display.

- 1) Initialisation consists of setting up the Input/Output ports, data-direction registers and the LCD. The Master then waits for a command to measure from the operator panel, and the Remote waits for a command to measure from the Master via the datalink.
- 2) Test programs allow the pattern modulation-indices to be adjusted, and each pattern's phase to be measured, one at a time. These features are useful training and debugging aids.
- 3) The Measurement Frame consists of data transmission between the instruments, the phase measurement of a set of patterns (a leading-straddle, a centre and a trailing-straddle) and TCXO adjustment.

- 4) The Breakout Calculation brings together the results of all the phase measurements replacing the least significant bits of coarser patterns with the most significant bits of the finer patterns to build up the distance register (DIST). In dynamic or "TRACK" mode the distance is displayed on the LCD every 600 ms. In static mode fifteen measurements of pattern 7 (20 MHz) are averaged before the distance is displayed.

### Program Timing

The 16-bit timer-counter, CNTR, in the 63701VOC, incremented by the clock every 1  $\mu$ s, controls the timing of the program to an accuracy of 1  $\mu$ s by setting and waiting for timer breakpoints. The counter-timer overflows every  $2^{16}$   $\mu$ s (65,536 ms), causing a Timer Overflow interrupt. The Timer Overflow interrupt service routine (LNGTIM) increments a register (LONGTM) which forms an extension to the 16-bit timer. LONGTM-CNTR thus form a 24-bit counter with an overflow every  $2^{24}$   $\mu$ s (16,777 seconds).

Timer breakpoints are set by reading the counter, adding a value (equal to the number of 1 $\mu$ s clock cycles till the next required breakpoint), storing this sum in the Output Compare Register (OCR), clearing a synchronisation flag (SYNC) and then waiting for the flag to be set. The output compare register is continually being compared with the counter (by the hardware of the microprocessor) and generates an output compare interrupt (OCI) when the values are equal. This interrupt service routine sets the synchronisation flag SYNC.

This technique is used to control the timing of the measurement frame (the names of the timer breakpoints are shown on the top line of Fig.5-5), and in time-sensitive routines such as serial data transmission and reception (Subroutines TXINFO and RXINFO).

## Data Transmission and Reception

Data transmission between the Master and Remote instruments during the measurement frame uses the datalink as a simplex link at a rate of 1 200 Baud.

The format of the data is,

1 start bit, 8 data bits, 2 checksum bits, 1 stop bit.

The data transmission is generated by subroutine TXINFO which can be seen on line 1836 of the software listing. TXINFO sets and clears TXDATA (pin 15 of IC3) to produce serial data. The rate is controlled by the 16 bit counter-timer.

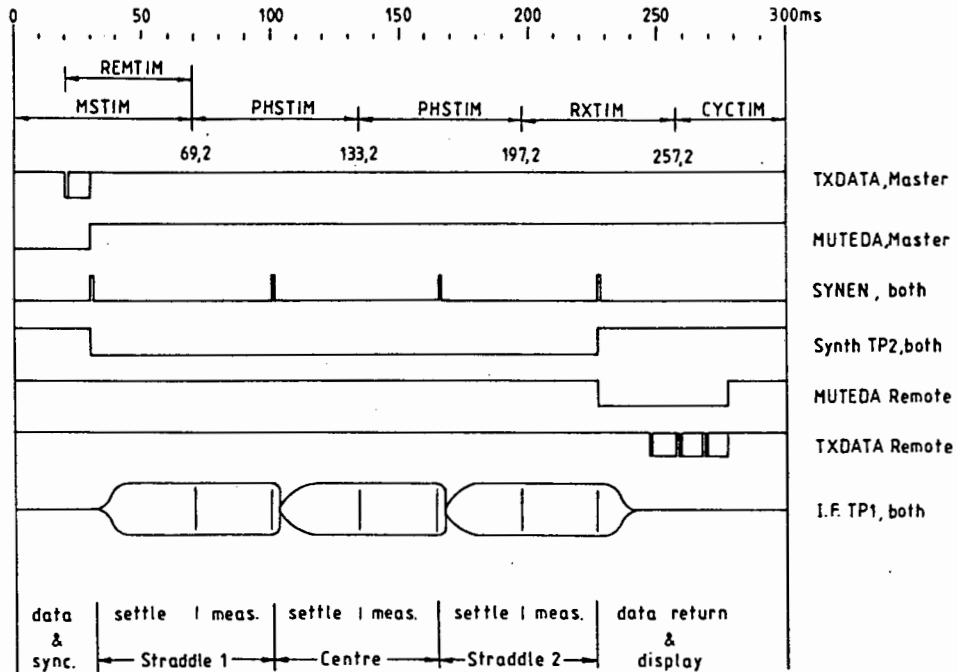
The MUTEDA line is used to enable the modems, allowing a 20 ms lead-in to guarantee carrier detection at the receive modem before data are sent. The carrier detect line, CDET (pin 26 of IC3), must be high for data reception to be valid.

Both modems are switched off during phase measurement to prevent intermodulation and phase contamination of the 39KHz-Phase signal.

Data reception is performed by subroutine RXINFO which can be seen on line 1903 of the software listing. RXINFO reads data by sampling the logic state of RXDATA (pin 25 of IC3), the rate being controlled by the 16 bit counter-timer.

## The Measurement Frame

Fig.5-5 shows the timing and port activity of a measurement frame.



**Fig.5-5, The Measurement Frame Cycle**

The measurement software starts on line 583 of the software listing. Each frame consists of the following sequence of events.

- 1) The Master transmits a byte of data (with a 20 ms high lead-in) to the Remote. The Remote synchronises the timing of its frame from the falling edge of the start bit. The data informs the Remote of the pattern number. The Master switches off its transmit modem.

- 2) Both instruments apply pattern modulation of the first Straddle Pattern for the current frame.  
After a delay to allow for phase settling, the phase of the recovered mixed product of these modulations, (39KHz-Phase), is measured and recorded in both instruments. Both instruments wait for 1 ms for the other to stop measuring.
- 3) Both instruments apply pattern modulation of the Centre Pattern for the current frame.  
After a delay to allow for phase settling, the phase of the recovered mixed product of these modulations, (39KHz-Phase), is measured and recorded in both instruments.  
Both instruments wait for 1ms for the other to stop measuring.
- 4) Both instruments apply pattern modulation of the second Straddle Pattern for the current frame.  
After a delay to allow for phase settling, the phase of the recovered mixed product of these modulations, (39KHz-Phase), is measured and recorded in both instruments. Both instruments wait for 1 ms for the other to stop measuring.  
Both instruments switch off pattern modulation.
- 5) The Remote transmits a 20 ms high lead-in followed by three bytes of data to the Master. The data contains the results of the Remote's three phase measurements and, as a check of the integrity of the link, the pattern number of the current frame.
- 6) The Master calculates the phase of the current pattern and updates the distance register.  
The Master then increments, decrements or repeats the pattern number (depending on the fit of the breakout phases) and continues onto the next frame; or stops measuring if the measurement is complete. The Master adjusts its TCXO frequency to equal that of the Remote, and updates the LCD.

## CHAPTER 6

### Parameters Affecting Performance

In this chapter some of the limitations of Tellurometers will be discussed, and their effect on the Micromin in particular.

#### Antenna Swing

Change in apparent measured distance with variation of microwave carrier frequency is termed "antenna swing". The cause is a frequency-dependent change in the phase-centre of the instrument. The phase-centre of the instrument is the point where incoming received energy mixes with the local oscillator, and is the point from which the distance to the other instrument is measured. This point is ideally at the mixer diode, but departs from this ideal due to the following effects,

- 1) The Gunn and Mixer not being coincident,
- 2) The antenna being mismatched to free-space,
- 3) The group delay through the mixer circuit and antenna.

1) The microwave source and the mixer not being coincident results in antenna swing due to the frequency-dependence of the speed of propagation of information in the waveguide.

The phase velocity,  $V_p$ , of a wavefront propagating in a waveguide is defined by the formula

$$V_p = C/\sqrt{1-(\lambda/2W)^2} \quad 6.1$$

where

C = propagation speed in air

W = width of the waveguide (0,023 m)

$\lambda$  = free-space wavelength

(29,25 mm @ 10,25 GHz; 29,87 mm @ 10,35 GHz)

The velocity at which information can be propagated along this wave is called the group velocity,  $V_g$ , and is related to the phase velocity by the formula

$$c^2 = V_g \times V_p$$

Thus  $V_p$  is frequency-dependent and the time taken for the local oscillator wave to reach the mixer diode varies with frequency. This is a mechanism by which the position of the phase centres of the instruments vary with frequency.

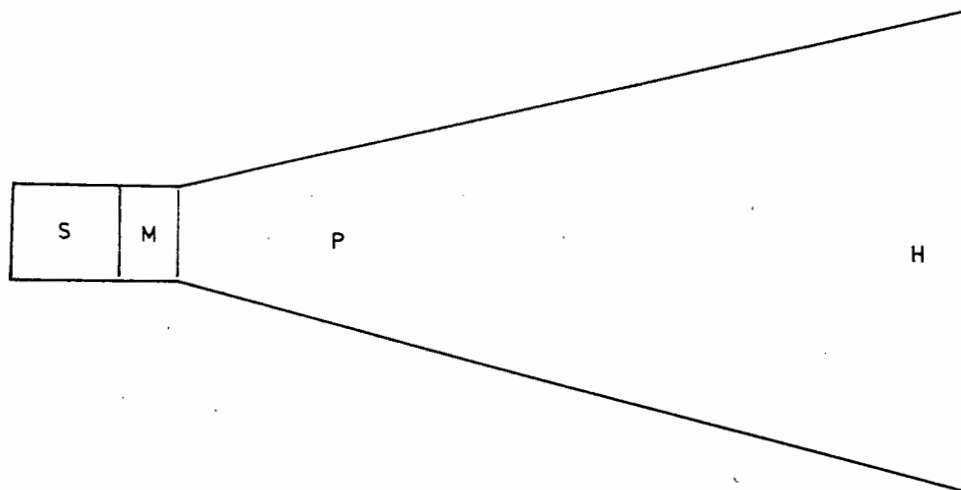
In the Micromin, taking the source of the modulated wavefront to be between the varactor and the Gunn diodes (a reasonable assumption), and the mixer diode as 25 mm away from this source, then a frequency change of 100 MHz at 10,3 GHz will produce a change in measured distance of (only) 0,21 mm at each end.

The effect occurs at both ends of the path resulting in a variation of 0,42 mm over the whole path.

Note that if the waveguide is operated at near the cutoff-frequency (where  $\lambda$  approaches  $2W$ ) then this effect becomes more significant.

2,3) Any local oscillator energy reflected from the antenna will add to the primary source of mixer local-oscillator bias (i.e. a point between the varactor diode and the Gunn diode). This will shift the effective point of mixer bias.

Graphically this can be shown as in Fig.6-1.



**Fig.6-1, Phase Centre of the Horn Antenna**

If the antenna is a perfect match there will be no reflection and the phase-centre will be at the mixer diode, at point M.

However, with a reflection of energy from the antenna the mixer bias consists of a proportion of bias from the source at point S, and the reflection from the antenna at point H. The resultant phase-centre is somewhere between these two points at point P. The position of P will be frequency dependent because the antenna match will be frequency dependent.

At microwave frequencies the atmosphere is non-dispersive, i.e. the difference between the velocities of the modulation envelope and the carrier frequency is so small as to be ignored, and the wavefront propagates at a speed of  $C/RI$  ( $RI$  = refractive index). So the group velocity of the wavefront accelerates from  $V_g$  in the waveguide, to  $C/RI$  in free space (at the mouth of the horn), and if it is reflected back into the horn it will return to the mixer, decelerating from  $C/RI$  to  $V_g$  as it returns.

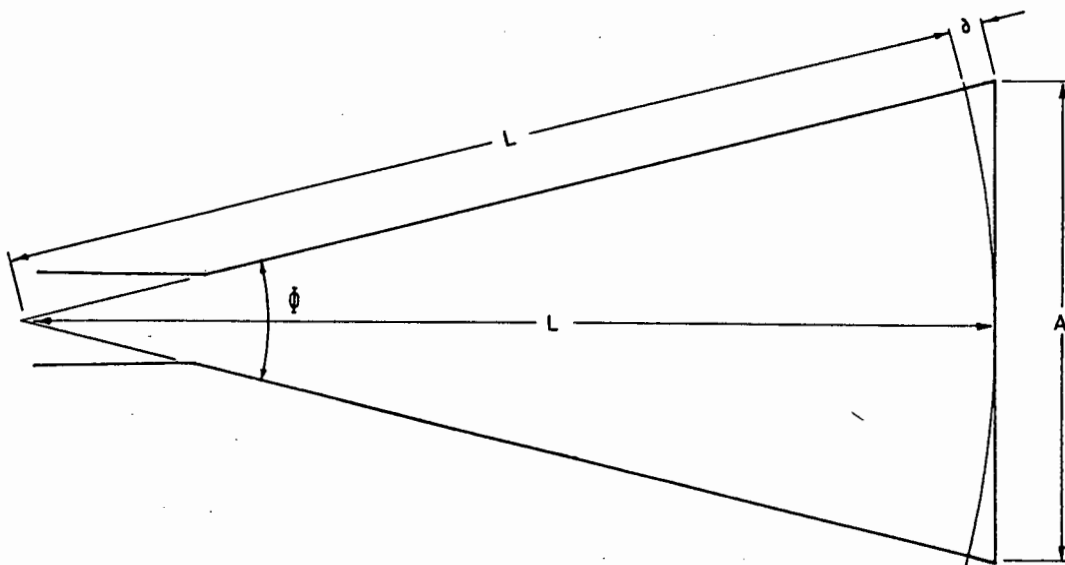
Again, because the group velocity in the horn is frequency dependent this is a further source for "antenna swing".

Because the amount of VSWR phase-centre pulling is governed by the ratio of the amplitudes of the "direct" signal to the reflected signal it is an advantage for the Micromin to have a high level of mixer bias (approximately 8 mW).

The horn antenna has a low VSWR (approximately 1,05:1) and an inherently broad bandwidth. These features make the horn a very attractive antenna for Tellurometer work (compared to stripline antennas, for example).

Maximum directivity of the horn is achieved by ensuring a uniform power distribution across the aperture.

Consider the cross-section through a horn antenna of Fig.6-2.



**Fig.6-2, Excess Path Length of the Horn Antenna**

The axial length of the horn is  $L$ , the aperture is  $A$  and the total flare angle is  $\phi$ . The length  $\delta$  is the difference in path length for a wave reaching the aperture at the axis and one reaching the aperture at the side of the horn.

If  $\delta$  is a sufficiently small fraction of a wavelength the field is nearly uniform over the entire aperture. However, when  $\delta = 0,5\lambda$ , the phase change at the edges is  $180^\circ$  and the resultant interference increases the side-lobes.

In the Micromin this is minimised as it would decrease both accuracy and maximum range performance.

For an optimum horn  $\delta$  must usually be in the range of 0,1 to 0,4 free-space wavelengths.

In the Micromin, at 10,30 GHz,

in the E-plane  $L = 250$  mm,  $A_e = 116$  mm, &  $\delta_e$  is  $0,23\lambda$

and

in the H-plane  $L = 250$  mm,  $A_h = 125$  mm, &  $\delta_h$  is  $0,26\lambda$ .

The excess path length, or  $\delta$ -effect described here is an inherent limitation to the length of a horn for a given flare angle.

This excess path length, being a small fraction of  $\lambda$ , ensures low side-lobes and minimum beamwidth for the horn.

The minimisation of sidelobes from the horn antenna reduces another source of error in surveying called "ground-swing".

## Ground Swing

Errors in phase measurement are introduced by the influence of ground reflections of the microwave beam.

Considering the simple case of a single reflection off the ground between the two instruments as shown in Fig.6-3, it can be seen that the signal received by each instrument is the vector sum of the two signals. The resultant of these two will normally have a different phase angle from that of the direct beam alone, affecting the measurement.

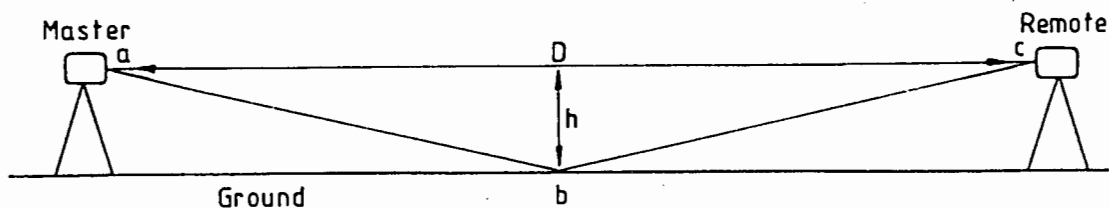


Fig.6-3, Ground Reflection Geometry

The strength of the reflected beam depends on the microwave carrier frequency, the angle of incidence, the plane of polarisation, and the nature of the reflecting surface. The phase difference depends on the excess path length  $d$ , and both the microwave carrier and pattern modulation wavelengths ( $\lambda_c$  and  $\lambda_m$ ).

For the case shown in Fig.6-3 the error in measured distance is shown (by Bomford, 1971) to be

$$e = \frac{\lambda_m}{2\pi} \arctan \left( \frac{\gamma(\gamma - \cos\beta_c) \sin\beta_m}{1 - \gamma \cos\beta_c (1 + \cos\beta_m) + \gamma^2 \cos^2\beta_m} \right) \quad 6.2$$

where

$$\beta_c = 2\pi d / \lambda_c, \text{ and}$$

$$\beta_m = 2\pi d / \lambda_m$$

and where

- e = error in measured distance (m)
- $\lambda_m$  = pattern wavelength (m)
- $\gamma$  = ground reflection coefficient (between 0 and 1)
- d = path length difference (abc - ac in Fig.6-3)

In cases where the ground reflection coefficient is smaller than 0,3 equation 6.2 can be simplified to

$$e = -(\lambda_m/2\pi) \times \gamma \times \text{Cos}\beta_c \times \text{Sin}\beta_m$$

This formula shows that there are two cyclic components in the function, the cosine term varying rapidly and cycling through zero every half wavelength of the microwave carrier, and the sine term varying slowly cycling through zero every half wavelength of the modulated-pattern frequency.

It also shows that the maximum error is  $\pm \gamma \times \lambda_m/2\pi$ .

Fig.6-4 and Fig.6-5 show the errors that can be expected with a ground reflection coefficient of 0,1 , a carrier wavelength of  $\lambda_c = 29,1$  mm and the 20 MHz fine pattern of the Micromin ( $\lambda_m = 14,99$  m).

Fig.6-4 shows the first few cycles of the function, and Fig.6-5 shows the envelope of that function.

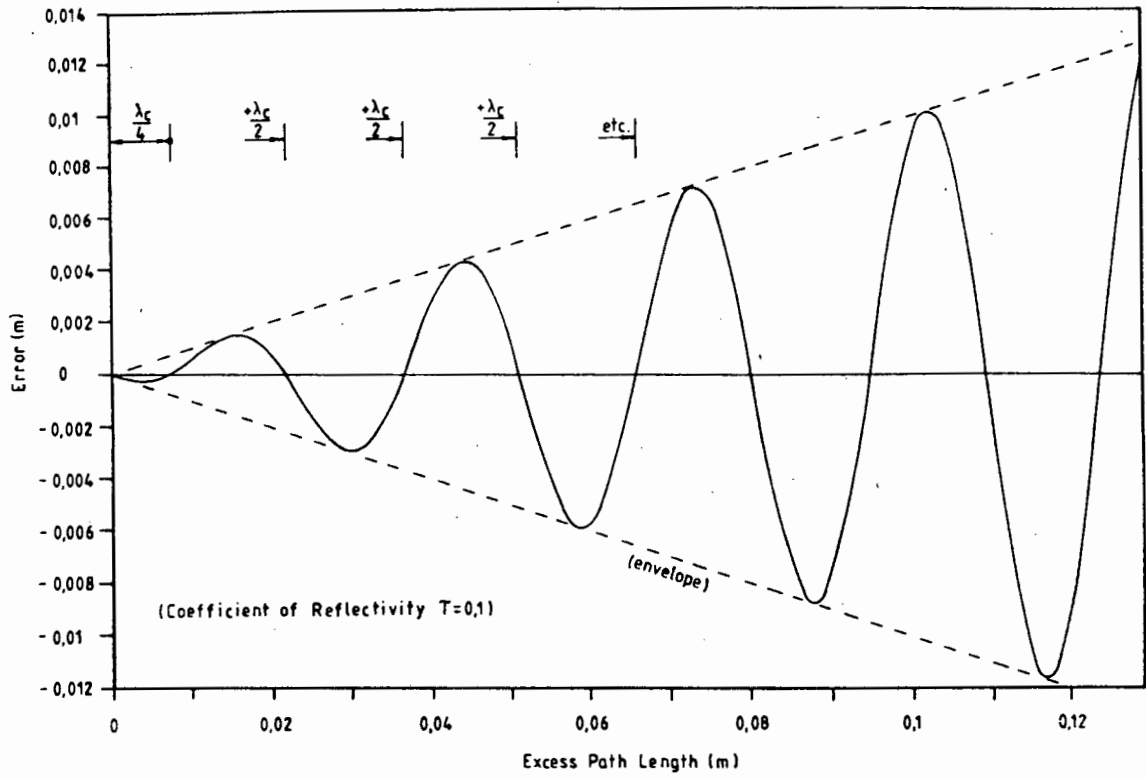


Fig.6-4, Ground Reflection Error vs. Excess Path Length

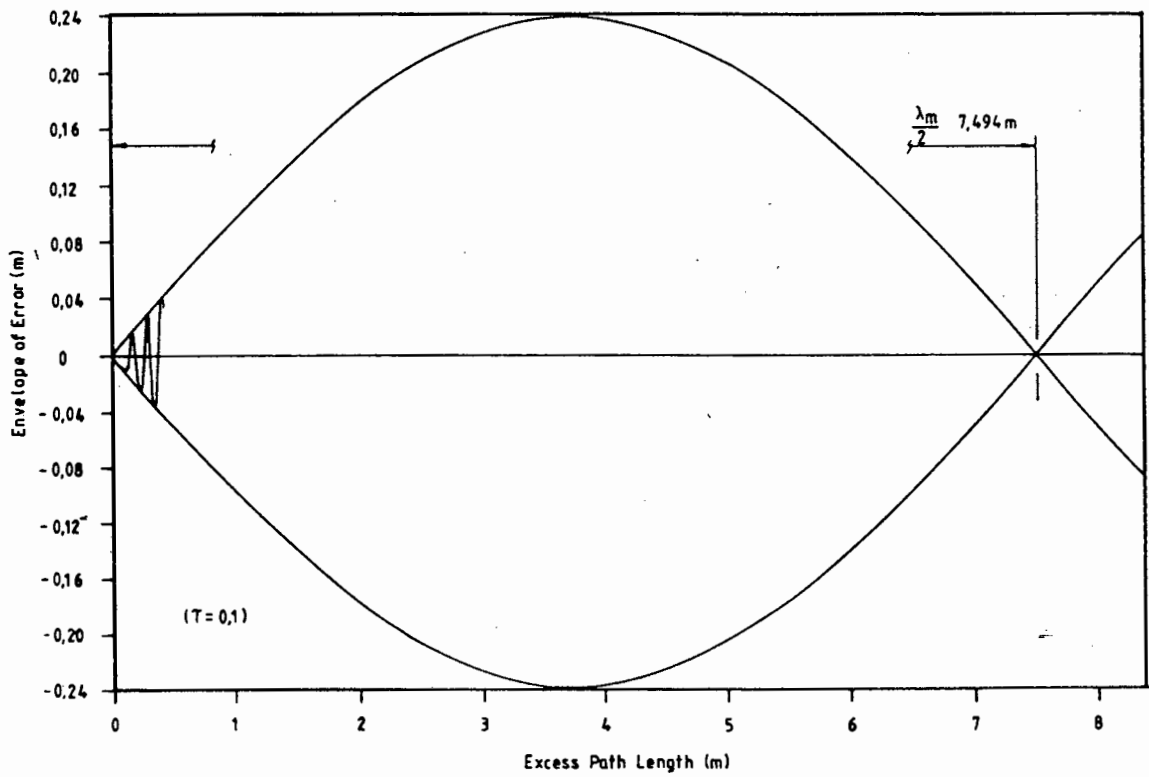


Fig.6-5, Envelope of Ground Reflection Error

For coefficients of reflection other than 0,1 the Y-axes of Fig.6-4 and Fig.6-5 can be proportionally scaled.

The excess path length  $d$ , drops off rapidly as the separation between the two instruments is increased and can be defined by the relationship,

$$d = [2(h^2 + (D/2)^2)]^{-1/2} - D$$

The value of  $d$ , for a height  $h$  of 1 m and an instrument separation  $D$  of up to 60 m, is shown by the solid line Fig.6-6.

The situation at very close ranges (less than 10 m) is improved by the narrow beamwidth of the horn antenna which limits the amount of microwave signal illuminating the ground.

The beamwidths at half-power points in the E & H-fields are given by;

$$\begin{aligned} \frac{1}{2}\text{-power beamwidth in E-field} &= 56/A_{e\lambda} = 14,05' \\ \frac{1}{2}\text{-power beamwidth in H-field} &= 67/A_{h\lambda} = 15,96' \end{aligned} \quad 6.3$$

and the angle between the first nulls is given by;

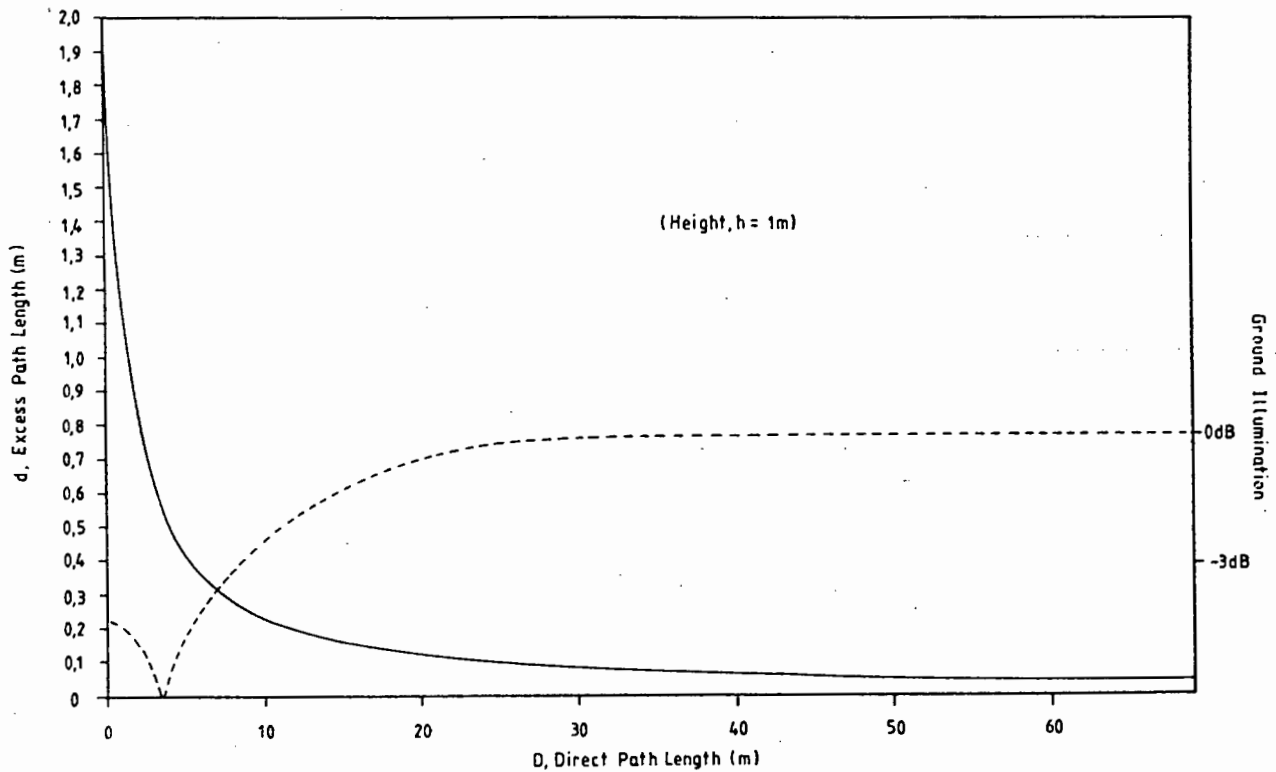
$$\begin{aligned} \text{angle between nulls E-field} &= 115/A_{e\lambda} = 28,85' \\ \text{angle between nulls H-field} &= 172/A_{h\lambda} = 44,15' \end{aligned} \quad 6.3$$

where  $A_{e\lambda}$  &  $A_{h\lambda}$  are the horn apertures in the E and H fields respectively, expressed in units of free-space wavelengths.

In the E-field the half power beamwidth is 14,05' and for an instrument height of 1 m, the ground illumination is 3 dB less than the main beam at a distance of 8,1 m away from the base of the tripod.

There is a null in the radiation at an angle of  $\frac{1}{2} \times 44,15'$  away from the line of the direct beam in the E-field so there will be no illumination of the ground at a distance of 3,88 m away from the base of the tripod.

The change in ground illumination with change in instrument separation at a height of 1 m is shown by the dotted line in Fig.6-6.



**Fig.6-6, Excess Path Length and Ground Illumination**

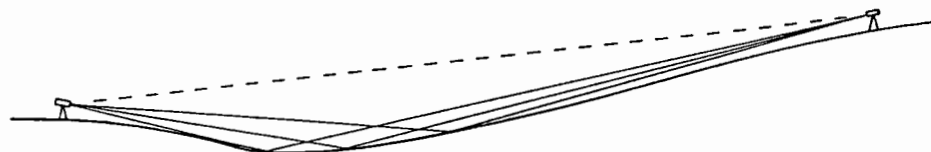
In practice there can be multiple reflections and then the results do not in general bear much resemblance to the theoretical ones. Sometimes reflections can make a measurement very inaccurate and special measures must be taken to reduce the strength of the reflected beam.

For example on hilltops the instruments can be moved back from the top or lowered so that the ground absorbs some of the reflected signal. On flat terrain the instruments can be lowered so as to reduce  $h$  and  $d$ .

Two special cases of ground swing that produce particularly large errors are worth noting.

The first is the case where the reflected beam cancels out the direct beam allowing a third beam to become dominant. This situation is readily identifiable by a loss of signal strength (if the operator is experienced enough with the Micromin and knows what sort of signal strength to expect over the range), accompanied by significant scatter on readings. If this occurs the operator can alter the instruments height, tilt the instrument or if necessary move the position of the line to get out of the interference area.

Another case is when measuring over a smooth dip in the ground such as down the length of a road that drops away from the operator and rises again as shown in Fig.6-7. The surface of the road can act as a collimating mirror and the reflected path can be much stronger than the direct path. The operator is likely to "beam up" on the strongest beam, (especially if he is not "beaming up" by line of sight). There will be significant scatter between adjacent readings, and an experienced operator may see that the signal strength is greater than should be expected over the operating range.



**Fig.6-7, Error due to Instruments Aligned on a Reflection**

## Contamination

The accuracy and range performance of the Micromin can be impaired by noise and contaminating signals. The main causes described here have been systematically reduced to within acceptable levels.

## Cyclic Error

Error in the measured distance varying cyclically with respect to distance is termed Cyclic Error.

Distance measurement is achieved by comparison of the phase of a 39KHz signal recovered from the IFs in both instruments which are the product of two high frequency modulations, (i.e. 10-21,25 MHz). The squarer of the IF is a highly selective amplifier tuned to 39,062 kHz to recover this signal.

In the absence of any contaminating signals the phase of this recovered signal with respect to the internal reference will vary linearly with a change in distance between the two instruments. However any baseband modulation at 39,062 kHz will also be readily amplified by the squarer and be presented to the phase counter with the recovered 39KHz-Phase and will affect the phase.

The phase of the internal contaminating signal does not vary in phase with change in distance because it does not travel the path, (the other contaminating signal from the far instrument travels the path at baseband and the phase cycles slowly with change in distance). The resultant phase is the vector sum of these signals varying with change in distance with a cyclic error.

The magnitude of error depends on the relative amplitudes of the contamination and the recovered comparison signal.

Cyclic error in the Micromin is reduced by the 39,062 kHz series resonant trap of L7 and C31 of the Modusynth.

An experiment to determine the magnitude of this contamination is described in Appendix C.

## Synthesiser Noise

The output spectra of the Modusynths are important factors in the accuracy of the Micromin. Any sidebands on the output of the Modusynth will add noise to the final phase reading of the comparison signal (39KHz-Phase).

A typical output spectrum of the Modusynth is shown in Fig.4-6. Particular attention was paid to the following areas:

- 1) Supplying power to the VCO and the modulator via a dedicated regulator, IC5 and isolating the supply rail from any disturbance (particularly the sample-and-hold switching circuitry).
- 2) Filtering the loop control signal at the sampling frequency (2,441 kHz, see Fig.4-4).
- 3) Adequate decoupling of supply lines.
- 4) Consideration of earth loops, circuit board layout and screening of the VCO coil (L1).

## Microprocessor Noise

Noise generated by the microprocessor covers a wide frequency spectrum and can interfere with the IF, desensitising the receiver and reducing the maximum range of the instruments.

In the Micromin this noise has been minimised by having separate voltage regulators for the IF and the Microprocessor, and taking the power leads for these boards directly to the voltage source.

The level of interference in the prototype instruments has been determined by listening to the noise level of the receiver (with the other instrument switched off), and switching the microprocessor on and off. There is a slight noticeable increase in the noise level when this is done, but testing the IF sensitivity using a signal generator shows that the IF achieves full quieting with a 10,76 MHz input signal of 3  $\mu$ V independent of the microprocessor being on or off.

This indicates that the microprocessor noise level is low, but could be reduced in future instruments to give a slight improvement in range performance.

The "star" arrangement of power distribution, effective in reducing mutual interference is shown in Fig.6-8.

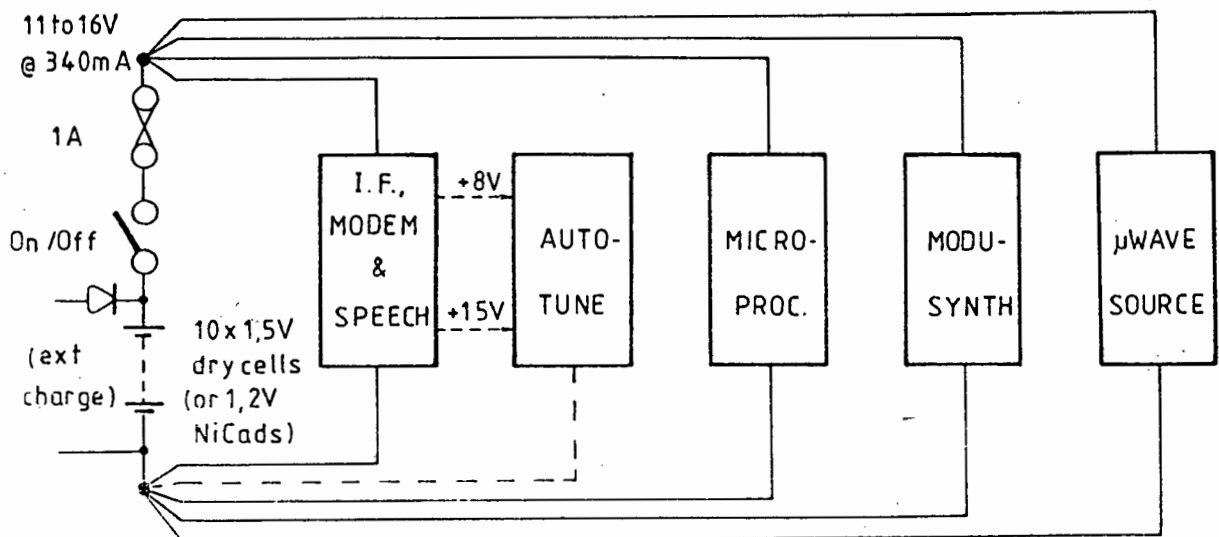


Fig.6-8, "Star" Power Supply Distribution

## Data and Speech

Baseband speech modulation disturbs the phase measurement. Although the press-to-talk switches can be used during measurement the audio amplifiers are muted so there is no speech link available during measurement.

### Measurement of Phase Noise on the Comparison Signal

All these sources of noise combine to corrupt 39KHz-Phase which can be measured by the following bench test.

A 39,062 KHz reference (Microprocessor IC10 pin 4) triggers one channel of a dual channel oscilloscope, and the other channel monitors the recovered 39KHz-Phase.

With the instruments tuned into each other the patterns are selected one at a time using the Test switch on the microprocessor.

Typical signals found are shown in Fig.6-9. The width of the phase noise is typically 1 % of a cycle of 39KHz-Phase. This corresponds to approximately 5 cm peak-to-peak scatter on each phase reading of pattern 7 (ambiguity = 3,747 m).

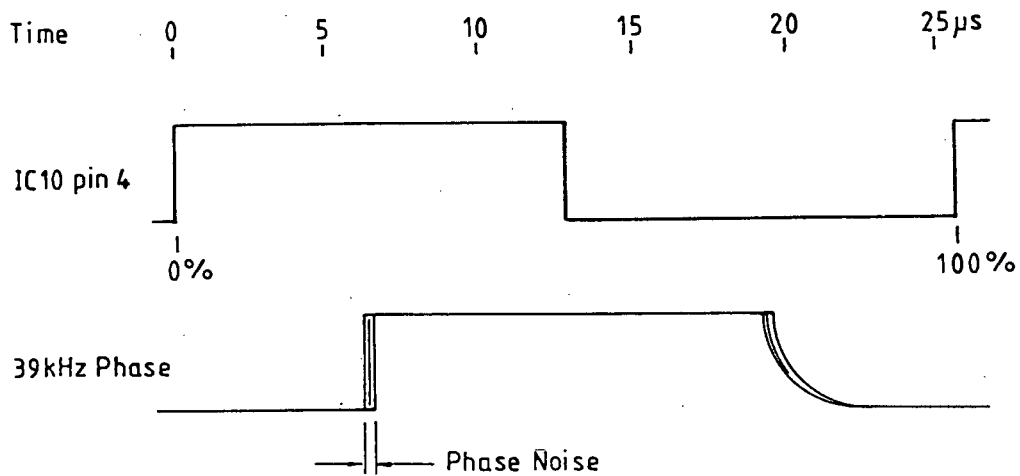


Fig.6-9, Phase Noise on the 39KHz-Phase Comparison Signal

## References for the formulae

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page 388.

## CONCLUSION

This thesis describes the results of three years of work on a Tellurometer, that has included the fields of software, microprocessor, digital and analogue design, low noise frequency-synthesis, microwaves and meteorology. The value-engineering inherent in this design comes as a result of the author's last seven years of industrial experience in the development of Tellurometer products.

During this time, terrestrial-survey equipment sales to the developed countries has been in decline, and the focus of attention has shifted to hydrographic survey (particularly of rivers and coastlines) and satellite navigation.

Satellite position-fixing equipment is relatively inaccurate and expensive compared to the instrument described here.

The author believes that this instrument, in the Tellurometer configuration, could create a new market for itself due to the survey needs of the under-developed nations. The simplicity of operation and repair, the excellent price/performance ratio and the latest market trends give substance to this belief.

In the datalink configuration, the Micromin could find applications particularly in the developed nations, 9 600 Baud duplex being a common modem data-rate for computer-based applications.

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## APPENDIX A

### Mathematical Analysis of the Measurement Process in the Micromin

Two Micromin instruments are used to measure distance, the Remote X-band carrier signal being locked to the Master with an AFC loop. The Remote instrument, when locked to the Master, is at a frequency 10,76 MHz lower than the Master.

The carriers of both the Master and the Remote are frequency modulated with PATTERN frequencies. By measuring the phase of the product of these patterns (present as amplitude modulation of the IF signal) simultaneously at both instruments, the distance between the two instruments can be calculated.

#### Pattern Modulations

Two classes of pattern are used, Absolute Pattern pairs, and Difference Pattern pairs. The way of measuring distance from the phase measurements of these patterns is similar, though the mathematical description of each is different. The two classes are therefore discussed separately.

## Assumptions and Symbols

In the discussions of both Absolute and Difference Pattern pairs, the following assumptions and symbols are used:

1) Phase measurements will be taken simultaneously in both the Master and the Remote instruments.

2) All frequencies used will be derived from a reference frequency oscillator,  $\omega_m$  in the Master and  $\omega_r$  in the Remote (in both cases this frequency is 2,441 KHz).

3) The distance between the Master and the Remote at a time  $t$  is  $D$ . The rate of increase of distance with time between the Master and the Remote is  $S$ .

4) The propagation speed of the carriers is  $C$ .

5) +Patterns are modulations at the basic pattern frequency plus  $8\omega_m$  at the Master and minus  $8\omega_r$  at the Remote (i.e.  $\pm 19,031$  KHz).

6) -Patterns are modulations at the basic pattern frequency minus  $8\omega_m$  at the Master and plus  $8\omega_r$  at the Remote (i.e.  $\pm 19,031$  KHz).

## Absolute Pattern Pairs

Absolute Pattern pairs consist of a +Pattern and a -Pattern, each of the same basic pattern frequency  $N\omega$ .

These two Patterns are called the Straddle Pattern and the Centre Pattern respectively. The Straddle Pattern is applied a time  $\delta t$  before and a time  $\delta t$  after the Centre Pattern to cancel out terms due to  $\delta t$ . The mechanism for this will be analysed later.

At the mixer of the Master the following signals are present.

Straddle Pattern:

$$\text{Lo: } \omega_m(N+8)t + \phi_{sm}$$

$$\text{Rx: } \omega_r(N-8)(t-D/(C+S)) + \phi_{sr} \quad \text{A.1M}$$

Centre Pattern:

$$\text{Lo: } \omega_m(N-8)(t+\delta t) + \phi_{cm}$$

$$\text{Rx: } \omega_r(N+8)(t+\delta t-D/(C+S)) + \phi_{cr} \quad \text{A.2M}$$

where 'Lo' is the locally generated sideband and 'Rx' is the received sideband of the other instrument, and where  $\delta t$  is the time difference between the measurements of the Straddle Pattern and the Centre Pattern. The  $\phi$ -terms are the random starting phase for each synthesiser when loaded with a new frequency. It is also assumed that  $S$  is small in comparison to the resolution of  $D/\delta t$ .

At the mixer of the Remote the following signals are present

Straddle Pattern:

$$\text{Lo: } \omega_r(N-8)t + \phi_{sr}$$

$$\text{Rx: } \omega_m(N+8)(t-D/C) + \phi_{sm} \quad \text{A.1R}$$

Centre Pattern:

$$Lo: \omega_r(N+8)(t+\delta t) + \phi_{cr}$$

$$Rx: \omega_m(N-8)(t+\delta t-D/C) + \phi_{cm}$$

A.2R

Signals detected at the mixer of the Master

Straddle Pattern: The locally generated sideband minus the received sideband, (from the components of A.1M),

$$(Lo-Rx)=$$

$$\omega_m(N+8)t + \phi_{sm} -$$

$$\omega_r(N-8)(t-D/(C+S)) - \phi_{sr}$$

A.3M

Centre Pattern: The received sideband minus the locally generated sideband, (from the components of A.2M),

$$(Rx-Lo)=$$

$$-\omega_m(N-8)(t+\delta t) - \phi_{cm}$$

$$+\omega_r(N+8)(t+\delta t-D/(C+S)) + \phi_{cr}$$

A.4M

These signals are passed through the IF (with a delay  $\delta_m$  at the Master) and measured with respect to the local reference frequency  $\omega_m$  at the Master.

The result is :

Straddle Pattern:

$$[ \omega_m N t + \theta(\omega_m t) + \phi_{sm} - \omega_r N t$$

$$+ \theta(\omega_r t) + \omega_r N D / (C+S) - \theta(\omega_r D / (C+S))$$

$$- \phi_{sr} - \delta_m ] - \omega_m t$$

A.3M<sup>1</sup>

Centre Pattern:

$$\begin{aligned}
 & [ - \omega_m N t - \omega_m N \delta t + 8(\omega_m t) \\
 & + 8(\omega_m \delta t) - \phi_{cm} + \omega_r N t \\
 & + \omega_r N \delta t - \omega_r N D / (C+S) + 8(\omega_r t) \\
 & + 8(\omega_r \delta t) - 8(\omega_r D / (C+S)) \\
 & + \phi_{cr} - \delta m ] - \omega_m t
 \end{aligned}
 \tag{A.4M}$$

These two phase differences are measured by the phase counter in the Micromin and then the two results are subtracted in the microprocessor. The difference between them is:

$$(S\text{-Pattern}) - (C\text{-Pattern}) = A.3M^1 - A.4M^1 =$$

$$\begin{aligned}
 & 2\omega_m N t - 2\omega_r N t + 2\omega_r N D / (C+S) \\
 & + \phi_{sm} - \phi_{sr} + \phi_{cm} - \phi_{cr} \\
 & + \omega_m N \delta t - 8(\omega_m \delta t) \\
 & - \omega_r N \delta t - 8(\omega_r \delta t)
 \end{aligned}
 \tag{A.5M}$$

Rewriting equation A.5M gives :

$$\begin{aligned}
 & 2N(\omega_m - \omega_r) t \\
 & + 2\omega_r N D / (C+S) \\
 & - \phi_{sr} + \phi_{sm} - \phi_{cr} + \phi_{cm} \\
 & + [ \omega_m (N-8) - \omega_r (N+8) ] \delta t
 \end{aligned}
 \tag{A.5M}$$

The first term is due to the 'slipping' between the reference oscillators of the two instruments.

The second term is of interest, from which the distance is derived.

The third term is a random phase value that results from the loading of the synthesisers. These values also occur in the Remote and later cancel out as shown in equation A.6.

The fourth term is the error due to the two patterns being applied at times differing by  $\delta t$ . The  $\delta t$  term is compensated for by a measuring technique called 'Straddling' (as will be explained later), and can be ignored for now.

Similarly at the Remote, neglecting the  $\delta t$  effects, the following signals are detected at the mixer;

Straddle Pattern, (from the components of A.1R),

(Rx - Lo) =

$$\begin{aligned} & -\omega_r(N-8)t - \phi_{sr} + \\ & \omega_m(N+8)(t-D/C) + \phi_{sm} \end{aligned} \quad \text{A.3R}$$

Centre Pattern, (from the components of A.2R, neglecting  $\delta t$ ),

(Lo - Rx) =

$$\begin{aligned} & \omega_r(N+8)t + \phi_{cr} - \\ & \omega_m(N-8)(t-D/C) - \phi_{cm} \end{aligned} \quad \text{A.4R}$$

These two patterns are measured with respect to the local reference in the phase counter (9,7 kHz), and then subtracted in the microprocessor to give, (ignoring the  $\delta t$  terms):

(S-Pattern) - (C-Pattern) : A.3R - A.4R =

$$\begin{aligned} & 2N(\omega_m - \omega_r)t - 2\omega_m ND/C \\ & -\phi_{sr} + \phi_{sm} - \phi_{cr} + \phi_{cm} \end{aligned} \quad \text{A.5R}^1$$

This result is transmitted from the Remote to the Master where it is subtracted from the result A.5M<sup>1</sup> obtained at the Master (again by ignoring the  $\delta t$  terms).

N.B. all the  $\phi$ -terms cancel.

The difference is :  $A.5M^1 - A.5R^1 =$

$$(S-Patt_m - C-Patt_m) - (S-Patt_r - C-Patt_r) =$$

$$2\omega_r ND / (C+S) + 2\omega_m ND / C$$

A.6

From which the distance can be calculated (assuming C is known and that S is small with respect to C).

## Difference Pattern Pairs

Difference Pattern pairs consist of two -Patterns, each differing in its frequency by the Difference Frequency which distinguishes the particular pattern.

Again the two patterns are called the Straddle Pattern and the Centre Pattern.

In the following discussion the synthesiser loading phases ( $\phi_{SM}$ , etc) will not be considered as they disappear from the final results in exactly the same way as for the Absolute Pattern case.

Also the effects of the  $\delta t$  seen in equation A.5M<sup>1</sup> will not be shown, as the same method for compensating for these terms (to be discussed later) is used in this case as is used for the Absolute Pattern case.

The Difference Pattern frequency will be written as  $\omega_M$ :

At the mixer of the Master instrument the following signals are present:

Straddle Pattern:

Lo:  $\omega_m(N-8)t$

Rx:  $\omega_r(N+8)(t+D/(C+S))$  A.8M

Centre Pattern:

Lo:  $\omega_m(N+M-8)t$

Rx:  $\omega_r(N+M+8)(t+D/(C+S))$  A.9M

These are detected, passed through the IF and measured with respect to the local reference in exactly the same way as for the Absolute Patterns.

This gives:

Straddle Pattern: (Lo-Rx)=

$$\begin{aligned} &\omega_m(N-8)t - \omega_r(N+8)(t+D/(C+S)) \\ &- \omega_m t - \delta m \end{aligned}$$

A.10M

Centre Pattern: (Lo-Rx)=

$$\begin{aligned} &\omega_m(N+M-8)t - \omega_r(N+M+8)(t+D/(C+S)) \\ &- \omega_m t - \delta m \end{aligned}$$

A.11M

Note that the Centre Pattern difference is (Lo-Rx) and not (Rx-Lo) as for the ABSOLUTE PATTERN case. This is a consequence of the frequency relationship between the modulation applied at the Remote and at the Master.

In the ABSOLUTE PATTERN case the Remote modulation is of lower frequency than the Master, the reverse being true in the DIFFERENCE PATTERN case.

Subtracting these two results in the microprocessor gives the result:

A.11M - A.10M =

$$(\omega_r M - \omega_m M)t + \omega_r M(D/(C+S))$$

A.12M

The first term is minimised by locking the Master and Remote references and the second term is the one of interest.

Similarly, at the mixer of the Remote instrument the following signals are present:

Straddle Pattern:

$$Lo: \omega_r(N+8)t$$

$$Rx: \omega_m(N-8)(t+D/C)$$

A.8R

Centre Pattern:

$$Lo: \omega_r(N+M+8)t$$

$$Rx: \omega_m(N+M-8)(t+D/C)$$

A.9R

These are detected, passed through the IF and measured with respect to the local reference in exactly the same way as for the Absolute Patterns. This gives:

Straddle Pattern: (Lo-Rx)=

$$\begin{aligned} &\omega_r(N+8)t - \omega_m(N-8)(t+D/C) \\ &- \omega_r t - \delta m \end{aligned}$$

A.10R

Centre Pattern: (Lo-Rx)=

$$\begin{aligned} &\omega_r(N+M+8)t - \omega_m(N+M-8)(t+D/C) \\ &- \omega_r t - \delta m \end{aligned}$$

A.11R

Subtracting these two results in the microprocessor gives the result:

A.11R - A.10R =

$$-(\omega_m M - \omega_r M)t - \omega_m M(D/C)$$

A.12R

This result is transmitted to the Master and subtracted from the result A.12M, which yields,

$$(S-Patt_m - C-Patt_m) - (S-Patt_r - C-Patt_r)$$

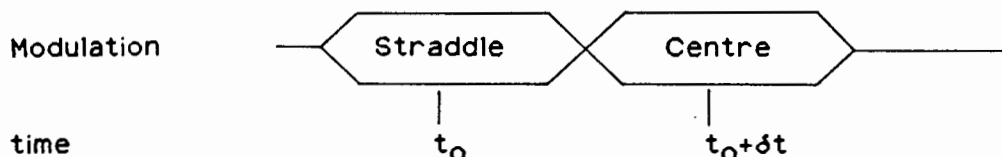
$$=w_rM(D/(C+S)) + w_mM(D/C)$$

A.13

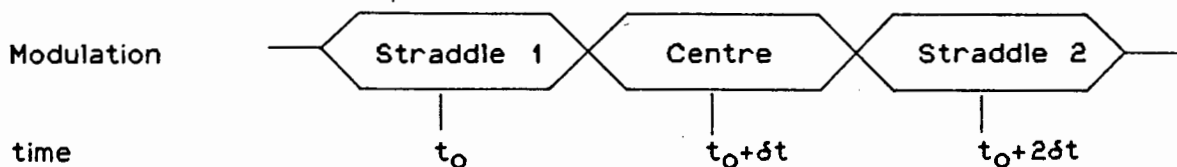
Which is very similar in form to the equation A.6 derived for the Absolute Patterns, from which the distance D can be calculated. The only difference is a factor of 2 which has to be taken into account when calculating the distance.

### Compensating For $\delta t$ Errors by Straddling:

Referring to equation A.5M<sup>1</sup>, the last term, which is just  $k\delta t$ , where  $k$  is a constant (in the short term) for the particular pattern, represents an error introduced by measuring the phase of the Centre Pattern after the Straddle Pattern:



this error can be removed by repeating the Straddle Pattern and effectively measuring two pairs of phase measurements:



Now if the measurements are made at :

$t_0$ ,  $t_0 + \delta t$ , and  $t_0 + 2\delta t$ , from equation A.6, by calculating:

$$[ (\text{Straddle}_m^1 - \text{Centre}_m) - (\text{Straddle}_r^1 - \text{Centre}_r) ]$$

We get:

$$2\omega_r N(D/(C+S)) + 2\omega_m N(D/C) + k_m \delta t + k_r \delta t$$

A.6<sup>1</sup>

and by calculating:

$$[ (S-Patt_m^2 - C-Patt_m) - (S-Patt_r^2 - C-Patt_r) ]$$

We get:

$$2\omega_r N(D/(C+S)) + 2\omega_m N(D/C) + K_m(-\delta t) + K_r(-\delta t) \quad A.6^2$$

Adding (or averaging) A.6<sup>1</sup> and A.6<sup>2</sup> yields a result without any  $\delta t$  error terms.

$$4\omega_r N(D/(C+S)) + 4\omega_m N(D/C) \quad A.14$$

From which the distance can be calculated.

## APPENDIX B

### Meteorological Formulae

For Tellurometer phase readings to be interpreted as a distance the velocity of the microwave radiation must be known. This requires a knowledge of the refractive index of the atmosphere through which the waves travel. The following formulae are used in the determination of the atmospheric refractive index at microwave frequencies and are applicable to the Micromin.

$$(RI-1)10^6 = 77,62(P-E)/TK + 64,70(1+(5\,748/TK))E/TK \quad \text{B.1}$$

Where;

RI = refractive index

$T_K$  = dry bulb temperature in degrees Kelvin

P = atmospheric pressure in millibars

E = partial pressure in millibars

$$E = SVP - \delta P \quad \text{B.2}$$

$$SVP = a+T_w(b+T_w(c+T_w(d+T_w(e+T_w(f+gT_w)))))) \quad \text{B.3}$$

$$\delta P = 0,000\,66(1+0,001\,15T_w)(P)(T_d-T_w) \quad \text{B.4}$$

SVP = saturation vapour pressure in millibars

$\delta P$  = depression pressure in millibars

$T_w$  = wet bulb temperature in degrees Centigrade

$T_d$  = dry bulb temperature in degrees Centigrade

a = 6,107 799 961

b = 4,436 518 521  $\times 10^{-1}$

c = 1,428 945 805  $\times 10^{-2}$

d = 2,650 648 471  $\times 10^{-4}$

e = 3,031 240 396  $\times 10^{-6}$

f = 2,034 080 948  $\times 10^{-8}$

g = 6,136 820 929  $\times 10^{-11}$

## Met. Calculation Program for the Hewlett Packard HP41CV

This calculation is performed by the following program for the HP41CV calculator which calculates the atmospheric refractive index given the parameters of dry bulb temperature (°C), wet bulb temperature (°C) & atmospheric pressure (millibars):

01	LBL "MET"	30	+	59	RCL 01
02	"Td IN C?"	31	RCL 02	60	/
03	PROMPT	32	*	61	1
04	STO 01	33	3.031240396 E-6	62	+
05	"TW IN C?"	34	+	63	RCL 06
06	PROMPT	35	RCL 02	64	*
07	STO 02	36	*	65	64.7
08	"P IN MB?"	37	2.650648471 E-4	66	*
09	PROMPT	38	+	67	RCL 01
10	STO 03	39	RCL 02	68	/
11	RCL 02	40	*	69	ENTER
12	1.15 E-3	41	1.428945805 E-2	70	RCL 03
13	*	42	+	71	RCL 06
14	1	43	RCL 02	72	-
15	+	44	*	73	77.62
16	ENTER	45	4.436518521 E-1	74	*
17	RCL 01	46	+	75	RCL 01
18	RCL 02	47	RCL 02	76	/
19	-	48	*	77	+
20	*	49	6.107799961	78	STO 07
21	6.6 E-4	50	+	79	RCL 07
22	*	51	STO 05	80	FIX 1
23	RCL 03	52	273.16	81	"RI="
24	*	53	ST+ 01	82	ARCL X
25	STO 04	54	RCL 05	83	"↓PPM"
26	RCL 02	55	RCL 04	84	AVIEW
27	6.136820920 E-11	56	-	85	END
28	*	57	STO 06		
29	2.034080948 E-8	58	5748		

If the operator of the Micromin wishes to apply meteorological correction to the readings made, then the HP41CV program listed here can be used to calculate the refractive index.

The meteorological measurements necessary can be made with a barometer to measure pressure, and a psychrometer to measure the wet and dry-bulb temperatures.

A more accurate determination of the RI can be made by measuring the meteorological conditions at both instruments, the calculation is then performed for both sets of readings and the average of the two results is used.

Note that the Micromin already assumes a default value of 1,000 325 for the refractive index. So if a distance of D is indicated by the Micromin and a true value of, for example 1,000 375 is measured for RI, then the correction should be applied thus;

True distance =  $D \times (1,000\ 325 / 1,000\ 375)$ .



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## APPENDIX C

### Field-Trial Results

The field-trials described were performed to evaluate the cyclic error, accuracy and range performance of the prototype instruments.

#### Cyclic Error

As described in Chapter 6, cyclic error is caused by contamination of the recovered Comparison-Signal with signals internal to the Tellurometer. Such contamination affects the resultant phase of the Comparison-Signal such that it does not vary linearly in phase with change in distance. The Fine-Pattern of the Micromin is 20 MHz, and can be expected to give errors of a cyclic nature with a cycle of error every wavelength of this frequency, i.e. every 14,990 m.

An experiment was set up where the two instruments were separated by approximately 100 m, over a grass surface. The instruments were placed close to the ground to avoid any ground-reflections that might affect the readings. The Master instrument was moved along a straight line towards the Remote in steps of 0,5 m at a time. The 0,5 m steps were measured with a 5 m tape measure. Six readings were made at each of 32 positions, the Master being moved a total of 15,5 m. The accuracy of this experiment was limited by the positioning of the Master instrument; it is estimated that the placement was performed with an accuracy of  $\pm 2$  cm.

The results of this exercise shown in Fig.C-1, show no evidence of a 15 m cycle of error, and that the distance was determined with a tolerance of 6 cm peak-to-peak. Scatter found between successive determinations of each distance was a maximum of 3 cm.

-----0,5 m Increments-----

99.24	99.24	99.25	Average	99.243	98.75	98.76	98.76	Average	98.752
99.24	99.25	99.24	Scatter	0.01	98.75	98.75	98.74	Scatter	0.02
98.23	98.22	98.23	Average	98.228	97.71	97.71	97.71	Average	97.722
98.24	98.21	98.24	Scatter	0.03	97.73	97.74	97.73	Scatter	0.03
97.21	97.21	97.21	Average	97.215	96.7	96.72	96.73	Average	96.723
97.21	97.23	97.22	Scatter	0.02	96.73	96.73	96.73	Scatter	0.03
96.25	96.26	96.24	Average	96.248	95.72	95.72	95.72	Average	95.723
96.26	96.24	96.24	Scatter	0.02	95.73	95.73	95.72	Scatter	0.01
95.23	95.23	95.22	Average	95.232	94.73	94.73	94.74	Average	94.727
95.24	95.23	95.24	Scatter	0.02	94.72	94.72	94.72	Scatter	0.02
94.23	94.2	94.21	Average	94.213	93.73	93.74	93.74	Average	93.730
94.22	94.21	94.21	Scatter	0.03	93.72	93.72	93.73	Scatter	0.02
93.23	93.21	93.21	Average	93.217	92.76	92.74	92.73	Average	92.752
93.21	93.22	93.22	Scatter	0.02	92.76	92.76	92.76	Scatter	0.03
92.26	92.26	92.26	Average	92.258	91.74	91.74	91.74	Average	91.740
92.25	92.26	92.26	Scatter	0.01	91.74	91.74	91.74	Scatter	0.00
91.21	91.24	91.23	Average	91.230	90.71	90.71	90.72	Average	90.710
91.23	91.23	91.24	Scatter	0.03	90.72	90.7	90.7	Scatter	0.02
90.22	90.2	90.21	Average	90.217	89.74	89.72	89.73	Average	89.723
90.22	90.23	90.22	Scatter	0.03	89.72	89.72	89.71	Scatter	0.03
89.23	89.24	89.23	Average	89.232	88.74	88.77	88.76	Average	88.755
89.23	89.23	89.23	Scatter	0.01	88.75	88.76	88.75	Scatter	0.03
88.28	88.27	88.28	Average	88.277	87.74	87.75	87.74	Average	87.743
88.29	88.27	88.27	Scatter	0.02	87.74	87.75	87.74	Scatter	0.01
87.23	87.23	87.25	Average	87.240	86.74	86.75	86.74	Average	86.743
87.24	87.24	87.25	Scatter	0.02	86.75	86.75	86.73	Scatter	0.02
86.26	86.27	86.26	Average	86.260	85.76	85.75	85.76	Average	85.765
86.25	86.25	86.27	Scatter	0.02	85.78	85.77	85.77	Scatter	0.03
85.26	85.25	85.26	Average	85.257	84.72	84.72	84.71	Average	84.713
85.26	85.26	85.25	Scatter	0.01	84.71	84.71	84.71	Scatter	0.01
84.22	84.24	84.23	Average	84.235	83.75	83.75	83.75	Average	83.752
84.23	84.24	84.25	Scatter	0.03	83.75	83.76	83.75	Scatter	0.01

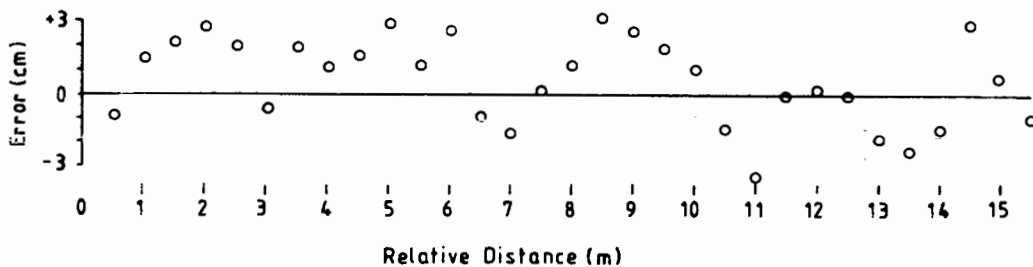


Fig.C-1, Cyclic Contamination

## Accuracy, Calibration of the Instruments

To determine the accuracy of the Micromin a five standard lines were measured.

These lines are between the Plessey towers, and between three ground-level posts on the back-field of the Plessey factory site. They have been measured for many years using a wide range of distance measuring equipment. The lines are regularly calibrated with high-precision optical instruments and the distances are known to an accuracy of 1 mm.

Fig.C-2 lists the measurements of these lines and records readings between 13,9 cm and 20,6 cm greater than the true distances. The resultant correction ("zero-calibration") of the prototype instruments is taken to be the average of these five corrections, i.e. 17,3 cm.

When 17,3 cm is subtracted from each of the measurements shown in Fig.C-2 the error is between +3,3 cm to -3,4 cm. This is consistent with the results of the Cyclic-Error test and forms the basis of the provisional accuracy specification for this instrument.

Zero-Correction, Plessey Towers Date...12 Aug 1987

S Tower, E Pole to N Tower E Pole				S Tower, E Pole to N Tower E Pole					
100.19	100.13	100.13	Average	100.168	100.21	100.22	100.21	Average	100.203
100.13	100.13	100.15	Scatter	0.06	100.21	100.23	100.21	Scatter	0.07
100.15	100.14	100.18			100.25	100.25	100.23		
100.19	100.18	100.19	Actual	99.962	100.23	100.24	100.22	Actual	100.064
100.17	100.16	100.17	=====		100.22	100.21	100.21	=====	
100.18	100.18	100.18	Zero	0.206	100.21	100.23	100.21	Zero	0.139
100.18	100.17	100.17			100.20	100.20	100.21		
100.17	100.17	100.19			100.22	100.21	100.20		
100.15	100.16	100.17			100.21	100.21	100.20		
100.19	100.18	100.18			100.21	100.20	100.19		
100.19	100.18	100.18			100.20	100.19	100.20		
100.18	100.18	100.16			100.19	100.19	100.18		
100.18	100.19	100.19			100.18	100.19	100.19		
100.18	100.19	100.16			100.18	100.19	100.18		
100.15	100.16	100.16			100.20	100.18	100.19		
100.16	100.16	100.15			100.19	100.19	100.18		
100.16	100.16	100.17			100.18	100.18	100.19		
100.17	100.17	100.15			100.18	100.18	100.19		

Zero-Correction, Plessey Sports Field Date...14 Aug 1987

East Post to Middle Post				East Post to West Post					
35.27	35.26	35.26	Average	35.266	83.15	83.18	83.18	Average	83.159
35.27	35.27	35.27	Scatter	0.03	83.14	83.17	83.15	Scatter	0.04
35.28	35.27	35.27			83.16	83.18	83.15		
35.26	35.27	35.28	Actual	35.099	83.16	83.18	83.16	Actual	82.960
35.25	35.27	35.26	=====		83.15	83.17	83.16	=====	
35.27	35.28	35.26	Zero	0.167	83.17	83.16	83.14	Zero	0.199
35.27	35.26	35.26			83.16	83.16	83.15		
35.27	35.27	35.28			83.17	83.17	83.14		
35.27	35.25	35.26			83.17	83.15	83.16		
35.27	35.26	35.26			83.16	83.16	83.15		
35.26	35.27	35.26			83.17	83.17	83.15		
35.27	35.27	35.26			83.14	83.15	83.15		

West Post to Middle Post				
48.02	48.02	48.02	Average	48.014
48.01	48.01	48.02	Scatter	0.03
48.00	48.01	48.03		
48.01	48.02	48.02	Actual	47.861
48.01	48.01	48.02	=====	
48.01	48.00	48.01	Zero	0.153
48.01	48.01	48.01		
48.01	48.02	48.01		
48.02	48.02	48.02		
48.01	48.01	48.02		
48.00	48.02	48.02		
48.03	48.01	48.00		

Fig.C-2, Zero-Correction

## Pointing Error

Error in the measured distance caused by antenna misalignment is called "pointing-error". The pointing-error of the instruments was measured by taking angle readings of pattern 7 whilst progressively pointing the Master instrument away from the Remote.

The line used was between the East pole of the South tower to the West pole of the North tower where the instruments were 100,064 m apart.

The Remote instrument was kept aimed directly at the Master, the Master instrument was aimed between 40 degrees to the left and 40 degrees to the right of the Remote, in steps of 10 degrees.

The results are shown in Fig.C-3.

The angle readings are converted to a relative distance reading shown on the right-hand side of the graph.

There is a "well-behaved" characteristic between  $\pm 30$  degrees with -5 cm error. If the instrument is aligned to within  $\pm 10$  degrees then there is typically 1 cm error.

S.Tower, E.Pole to N.Tower, W.Pole

Measuring Angle of Pattern 7 (3,747 m Ambiguity)

-----LEFT-----			-----CENTRE-----			-----RIGHT-----			
-40 deg	-30 deg	-20 deg	-10 deg	0 deg	10 deg	20 deg	30 deg	40 deg	
274	262	263	263	262	263	262	264	273	
271	261	265	266	266	264	263	266	275	
278	265	261	264	266	257	260	260	275	
271	262	263	266	269	266	254	264	276	
271	261	259	268	266	265	262	263	274	
275	259	261	264	265	265	260	264	276	
274	261	262	261	267	265	261	264	274	
273	259	264	265	264	265	261	264	274	
273	261	261	264	266	265	261	264	274	
271	259	262	265	264	264	257	261	274	
273	262	262	262	263	263	261	262	276	
274	259	261	264	267	263	260	262	274	
273.2	260.9	262.0	264.3	265.4	263.8	260.2	263.2	274.6	Average (degrees)
7	6	6	7	7	9	9	6	3	Scatter (degrees)
3.5	4.0	4.5	5.0	5.0	5.0	4.5	4.0	3.5	Signal Strength

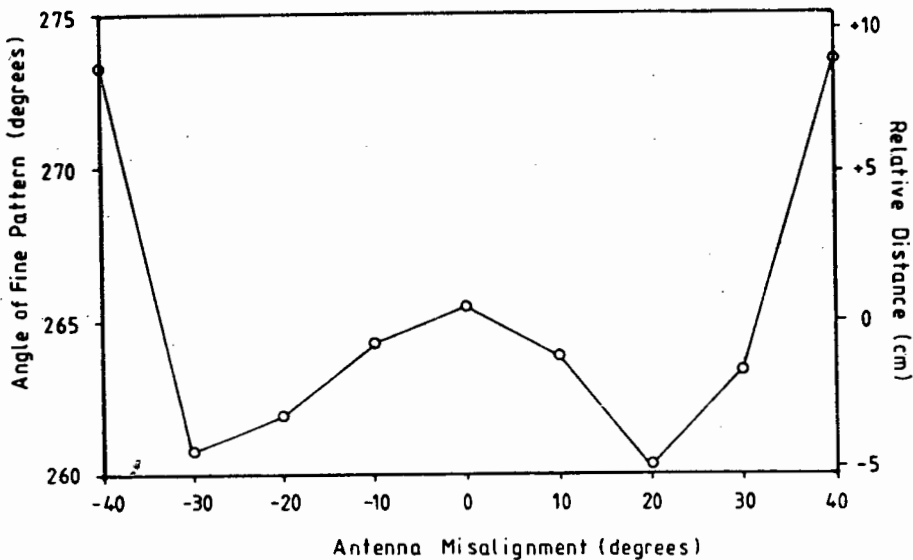


Fig.C-3, Pointing Error

## **Analysis of Each Pattern**

The accuracy of measurement of the eight patterns and the binary ratio between the patterns was measured over a standard line.

The line used was between the Plessey towers, from the East pole of the South Tower, to the East pole of the North tower, a distance of 99,962 m.

Fig.C-4 shows the results of each pattern angle being measured thirty times.

The average is shown at the right of each set of readings. When this average is multiplied by the appropriate pattern ratio (x2, x4 or x8) the "prediction" of the next pattern can be seen to be in agreement with the result of the next pattern.

The tolerance with which the patterns are fitted together is  $\pm 90$  degrees, this can be seen on line 788 of the software listing.

S.Tower, E.Pole to N.Tower, E.Pole (99,962 m): Pattern Angles in degrees

Pattern 0							2,441 kHz, 61 397,503 m	
0	1	0	358	357	359	Average	-0.3	
357	0	0	0	0	0	Scatter	9	
356	3	0	0	0	0			
0	0	357	358	357	0	times 4		
359	5	0	0	0	3	predicts	-1.2	
Pattern 1							9,675 kHz, 15 349,376 m	
4	2	2	2	3	355	Average	2.1	
4	3	7	3	0	0	Scatter	13	
2	3	356	0	3	357			
2	2	4	3	5	2	times 4		
3	2	2	2	3	8	predicts	8.4	
Pattern 2							39,062 kHz, 3 837,344 m	
10	10	7	10	6	8	Average	9.2	
9	8	9	9	9	6	Scatter	10	
14	6	9	10	12	12			
5	9	7	10	10	10	times 4		
11	12	6	15	10	8	predicts	36.8	
Pattern 3							156,25 kHz, 959,336 m	
37	39	40	36	37	41	Average	38.2	
40	38	37	37	41	38	Scatter	14	
35	38	33	38	35	37			
37	39	37	38	39	40	times 4		
38	38	43	37	35	47	predicts	152.8	
Pattern 4							625 kHz, 239,834 m	
151	150	150	150	149	151	Average	149.5	
150	147	151	151	151	151	Scatter	6	
150	150	149	149	151	149			
150	149	150	148	145	150	times 2		
147	148	150	151	150	146	predicts	299.0	
Pattern 5							1,25 MHz, 119,917 m	
307	308	309	298	305	310	Average	307.0	
299	306	304	309	305	309	Scatter	13	
309	305	309	306	308	308			
306	306	308	308	309	307	times 8		
309	306	311	308	307	310	predicts	296.0	
Pattern 6							10 MHz, 14,990 m	
245	245	244	248	244	244	Average	245.3	
245	245	244	245	245	245	Scatter	15	
244	245	245	244	245	243			
246	244	246	239	246	254	times 4		
254	245	247	249	239	245	predicts	261.2	
Pattern 7							2 x 20 MHz, 3,747 m	
261	272	268	264	258	266	Average	262.8	
262	263	263	261	262	261	Scatter	15	
263	262	257	258	262	263			
262	263	262	263	265	263			
261	262	265	262	267	262			

Fig.C-4, Pattern Analysis

## Range Performance

As calculated in Chapter 3 the range of the Micromin is approximately 15 km. This has been shown to be the case and range trial results are shown in Fig.C-5 showing signal-strength as a function of distance.

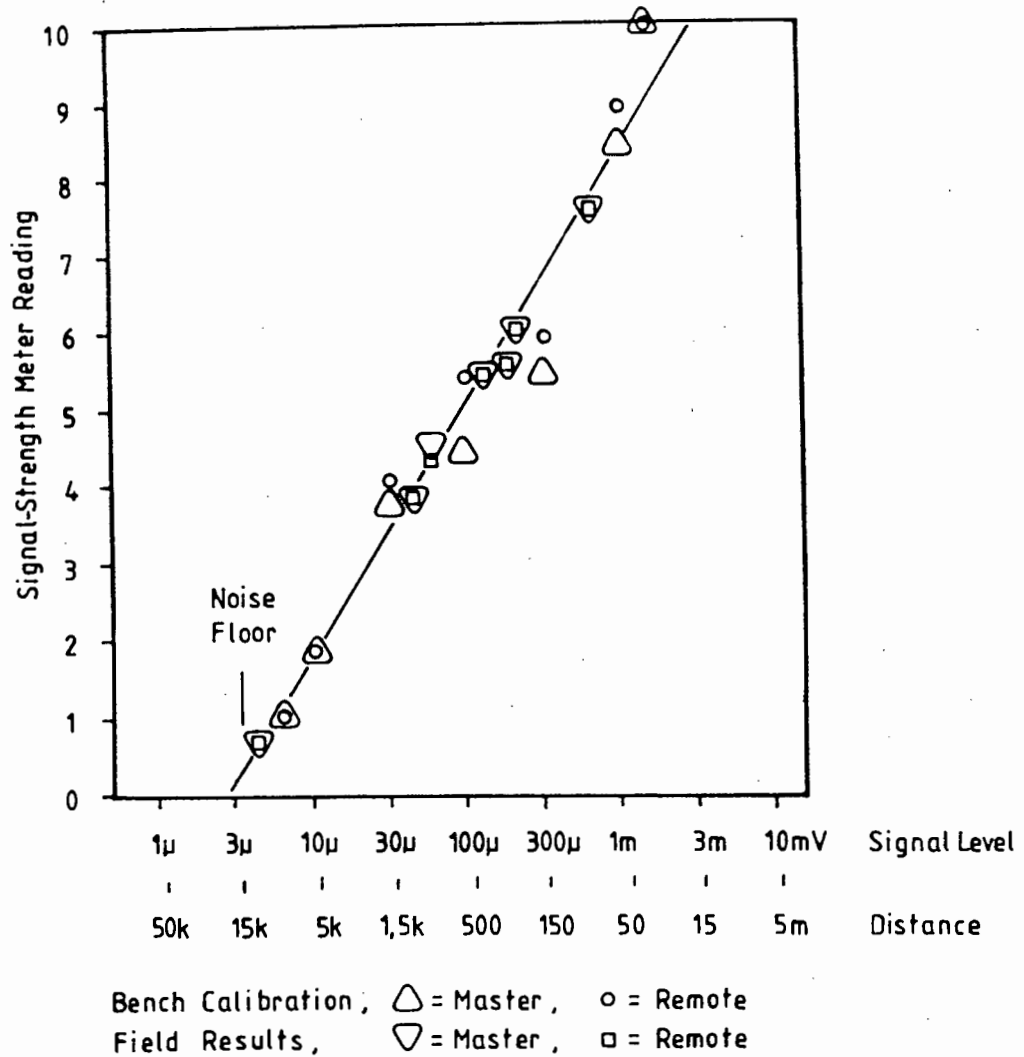
In order to maximise the range-performance of the prototype instruments, the matching of the source mixer assemblies was optimised by fitting waveguide shims between the Gunn source and the mixer assembly. In this way reflections from the Gunn source are used as constructive interference to augment the received signal. This was done by measuring the signal-strength output voltage with a digital voltmeter and fitting shims of varying thickness and noting the trend in received signal-strength. The shims inserted were up to 30 mm deep, and the additions were made in steps of 1 mm. Both instruments were adjusted in this manner.

A signal improvement of 3,5% was achieved in the Master by fitting 6 mm of shims. A change in signal-strength reading from 2 to 9 is equivalent to a change in input signal level from 10  $\mu$ V to 1 mV, (from Fig.C-5). This is a 40 dB change in signal amplitude for a 70% change in meter reading. The meter thus responds at 5,7 dB/division, or 0,57 dB/% of full scale deflection. From this it follows that a change of 3,5% is equivalent to an increase of 2,0 dB.

Likewise, a signal improvement of 3,85% was achieved at the Remote by fitting 3 mm of shims, this is equivalent to 2,2 dB improvement.

The signal-strength meters of the instruments were calibrated by injecting a 1,5 mV, 10,76 MHz signal into each IF (from a signal generator), and adjusting R23 of the IF (see Fig.3-9) for full-scale-deflection of the signal-strength meter.

With the IFs calibrated this way the response of the signal-strength meters to a signal varying from 3  $\mu$ V to 1,5 mV is as shown by the  $\Delta$  and o symbols in Fig.C-5.



**Fig.C-5, Range Performance**

The equivalent distance for this range of voltages was calculated as for the analysis of the "Dynamic Range of the Receiver" in Chapter 3, and is shown by the "Distance" abscissa of Fig.C-5.

This calculated-function of signal strength vs. distance was then compared with the signal-strength readings found at various ranges in the field. These results are shown by the  $\nabla$  and  $\square$  symbols in Fig.C-5, and as can be seen there is agreement between the theory and the field results.

At 10 km the instruments tune in and work with a good signal to noise ratio but fall out of tune easily during measurement.

At 25 km the instruments were unable to tune in, although at the Master instrument there was a faint sound of the Remote sweeping through the band. The Master signal received by the Remote was not strong enough to halt the Autotune sweep.

It has been the experience of the author that with prototype instruments, in any development of this nature, the first pair of instruments invariably do not perform as well as later models due to an accumulation of many small shortcomings in performance. This is particularly so with long-range performance, and it is felt that if more instruments are made, these models could improve on the performance of the prototypes.

An alternative mixer arrangement using horizontal polarisation in one instrument and vertical polarisation in the other would offer an improvement in range performance. There would be no receiver losses due to an offset of the mixer diode from the centre of the waveguide, and there would be less absorption of transmitted power. These two factors would give approximately an extra 6 dB signal strength, doubling the range performance to 30 km. This could be achieved by tapering the horn to a square waveguide to accommodate the mixer diode assembly, and then tapering down to rectangular waveguide to mate with the Gunn source. The Gunn source in one instrument would then have to be turned through 90 degrees. This extra complexity would increase the materials cost of the instruments, but may very well be worthwhile.

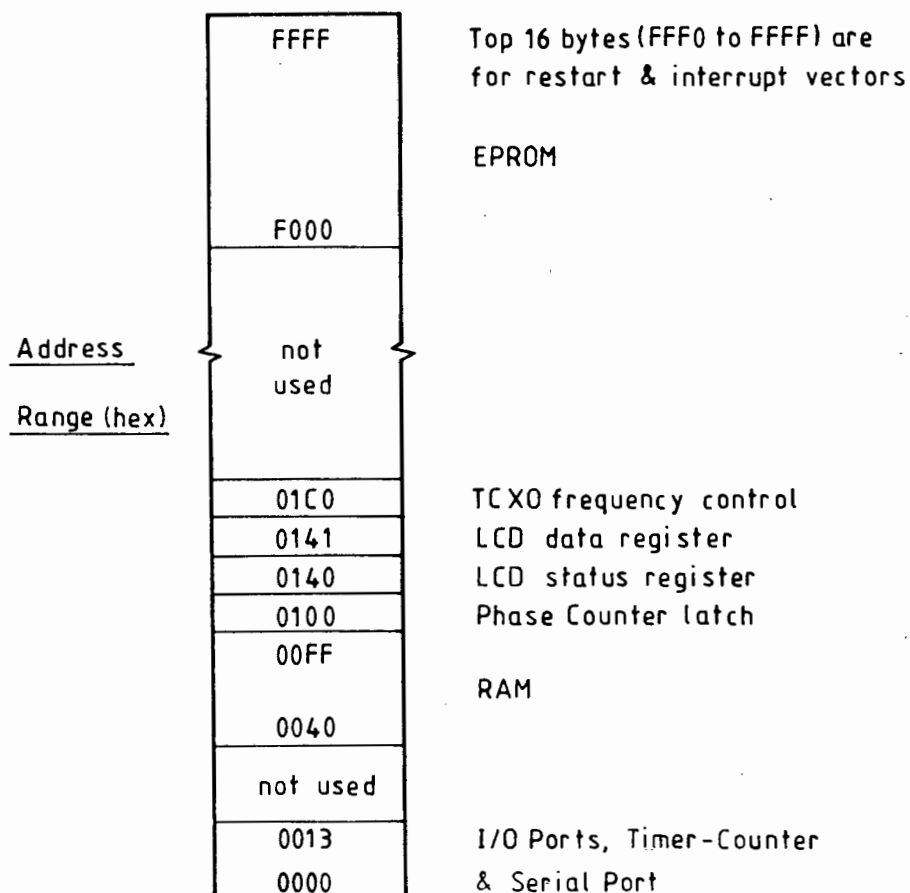
Such a change could be made if further commercial interest were shown in this design as a marketable product, and market-research were to suggest an increase in range was necessary.

## APPENDIX D

### Software Listing

The following assembled software listing is the latest version of the Micromin program, written in assembly language. The processor used is a Hitachi 63701VOC; the microprocessor hardware and software is described in Chapter 5.

The memory map of the microprocessor is shown in Fig.D-1.



**Fig.D-1, Memory Map of the Microprocessor**

LOCATION OBJECT CODE LINE SOURCE LINE

```

1 "6801"
2
3 * *****
4 * *
5 * * Author    Mark Marsden
6 * * Title     Micromin
7 * * Issue     1.00
8 * * Date      September 1987
9 * *
10 * *
11 * *****
12 *
13 *
14 * set interrupt vectors
15
16     ORG    OFFFH
17     FDB    RESTRT    keyboard int
18     FDB    LONGTM    timer overflow
19     FDB    OCI       timer output compare
20     FDB    RESTRT    timer input compare
21     FDB    IRQ       irq
22     FDB    RESTRT    swi
23     FDB    NMI       nmi
24     FDB    RESTRT    reset
25
26 *     memory mapped devices
27
28     <01C0> 28 DTOA    EQU    1C0H    tcxo
29     <0100> 29 PHSCNT  EQU    100H    phase counter latch
30     <0140> 30 STATUS  EQU    140H    lcd status
31     <0141> 31 LCD     EQU    141H    lcd data
32     <0180> 32 SYNEN  EQU    180H    synthesiser enable data strobe
33
34
35     ORG    0
36
37     0000   37 DDR1    RMB    1        data direction reg 1
38     0001   38 DDR2    RMB    1        data direction reg 2
39     0002   39 PORT1   RMB    1        port 1
40     0003   40 PORT2   RMB    1        port 2
41     0004   41 DDR3    RMB    1        data direction reg 3
42     0005   42 DDR4    RMB    1        data direction reg 4
43     0006   43 PORT3   RMB    1        port 3
44     0007   44 PORT4   RMB    1        port 4
45     0008   45 TCSR    RMB    1        timer con/stat reg
46     0009   46 CNTR    RMB    2        counter
47     000B   47 DCR     RMB    2        output compare reg
48     000D   48 ICR     RMB    3        input capture reg
49     0010   49 RMCR    RMB    1        rate/mode cont reg
50     0011   50 TRCSR   RMB    1        tx/rx con & stat reg

```

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE		
0012	52	RXDATA	RMB	1		rx data reg	
0013	53	TXDATA	RMB	1		tx data reg	
	54						
	55	ORG		40H			
	56						
0040	57	XTEMP	RMB	2		temp store for x reg	
0042	58	COUNT	RMB	2		temp store for counter	
0044	59	XTEMP1	RMB	2		temp store for x reg	
0046	60	ERROR0	RMB	1		error flag for phase measurement	
0047	61	COUNTR	RMB	1		counter/flag for measurement routines	
0048	62	PHSTOT	RMB	2		partial result from PATFAS	
004A	63	DELPHS	RMB	2		slip measured in PATFAS	
004C	64	STRDL1	RMB	2		location for saving 1st straddle patt phase	
004E	65	DIFPHS	RMB	2		location for saving difference patt phase	
0050	66	STRDL2	RMB	2		location for saving 2nd straddle patt phase	
0052	67	PRVPHS	RMB	2		location for saving previous phase	
0054	68	REMST1	RMB	2		for master to store remote st1-ref phase	
0056	69	REMST2	RMB	2		for master to store remote st2-ref phase	
0058	70	PATPHS	RMB	2		location for resultant pattern phase in meas	
	71	* patphs is used as 3 bytes in AVERAG spilling over into ADDHLF					
005A	72	ADDHLF	RMB	2		counter for phase ambiguity correction	
005C	73	SUBHLF	RMB	2		counter for phase ambiguity correction	
005E	74	DIST	RMB	5		distance (or phase)	
0063	75		RMB	3		3 bytes for dhifting NEWDST into	
0066	76	SPEED	RMB	5		speed (or phase change in 1/8 s)	
006B	77	PATCNT	RMB	1		pattern counter	
006C	78	FINALP	RMB	1		final pattern	
006D	79	SYNC	RMB	1		sync flag, set every time an OCI occurs	
006E	80	SYNCH	RMB	2		used with SYNC to store time derived from CNTR	
0070	81	TEMPER	RMB	1		temp storage of ERROR0 count	
0071	82	SIDSLP	RMB	1		# places RANGE is shifted left	
0072	83		RMB	3		space to shift RANGE left	
0075	84	RANGE	RMB	5		range as measured in this breakout	
007A	85	AMBIGF	RMB	1		ambiguity flag used in AUDIST	
007B	86	CHKSUM	RMB	1		holds checksum for data tx/rx'd	
007C	87	MEASKY	RMB	1		key code entered during measurement	
007D	88	MANUAL	RMB	1		manual meas flag - no breakout if <>0	
007E	89	BROKEN	RMB	1		flag set <> 0 if b'kout completed in stake	
007F	90	RELREG	RMB	3		ram area if MANT is called from eprom	
0082	91	MANT	RMB	3		mantissa	
0085	92	EXP	RMB	1		exponent	
0086	93	SIGN	RMB	1		sign of mantissa	
0087	94	IXP	RMB	2		index register pointer	
	95	INTBIN	SET	MANT		int part of fixed point number	
	96	FRBIN	SET	EXP		frac part	
0089	97	SAVEX3	RMB	2		temp storage for X reg	
008B	98	SAVEX2	RMB	2		" " " "	
008D	99		RMB	2		" " " "	
008F	100		RMB	2		" " " "	
0091	101	COUNT1	RMB	3			
0094	102	DBUF1	RMB	11		usually dispaly data	

```

LOCATION OBJECT CODE LINE      SOURCE LINE

009F          104 DPNT1 RMB      1      1st point associated with DBUF1
00A0          105 DPNT2 RMB      1      2nd " " " "
00A1          106 STAKEF RMB      1      flag set to indicate stakeout mode
00A2          107 STPCNT RMB      1      number of measurements on this pattern
00A3          108 LIST RMB      32     list of pattern phases on repeated readings
00C3          109 LNGTIM RMB      1      timer extension
00C4          110 SYNREG RMB      5      holds data loaded into synth
111
112          ORG      0F000H
113
114 *          *****
115 *          SYNTHESIZER DATA TABLE
116 *          *****
117
118 * reference pattern data
119
F000 A000A000 120 INITSY FCB      0A0H,0,0A0H,0      20,000 MHz mod-off
F004 1FF9200928 121 PATTAB FCB      01FH,0F9H,020H,009H,028H 20-M+2k44
F009 1FFC200C28 122          FCB      01FH,0FCH,020H,00CH,028H 20-M+9k76
F00E 2008201828 123          FCB      020H,008H,020H,018H,028H 20-M+39K06
F013 2038204828 124          FCB      020H,038H,020H,048H,028H 20-M+156k25
F018 20F8210828 125          FCB      020H,0F8H,021H,008H,028H 20-M+625k
F01D 21F8220828 126          FCB      021H,0F8H,022H,008H,028H 20-M+1M25
F022 1FF820082C 127          FCB      01FH,0F8H,020H,008H,02CH 10-M+10M
F027 1FF8200830 128          FCB      01FH,0F8H,020H,008H,030H 20-M
129
130 * straddle pattern data
131
F02C 1FF82008 132          FCB      01FH,0F8H,020H,008H      20-M
F030 5FF06010 133          FCB      05FH,0F0H,060H,010H      10-M
F034 20081FF8 134          FCB      020H,008H,01FH,0F8H      20+M
135
136 *          constants for measuring routines
137
138 * |_MSTTIM_|_PHSTIM_|_PHSTIM_|_RXTIM_____|_CYCTIM_|
139 * !rx,synth!straddl1!cent-phs!straddl2,,rx-data,calc.!
140 * 0 20 49,2 113,2 177,2 !237,2 300 ms
141 * !latest start
142 * !of 2nd rx byte
143
144 * times in E-cycles (1,0 us) till/between-
<C350> 145 MSTIM1 EQU 50000 phase can be measured in M 69,2 ms
<4800> 146 MSTIM2 EQU 19200
147 * 69,2 = 48,6(rem) + 20(data-lead-in) + 0,6(propogation delay)
<B0D8> 148 REMTIM EQU 48600 phase can be measured in R 48,6 ms
<FA00> 149 PHSTIM EQU 64000 phase measurements (64 ms)
<EA60> 150 RXTIM EQU 60000 rx phase data return from rem 60ms
<A730> 151 CYCTIM EQU 42800 beginning of next frame 42,8ms
152
<0050> 153 PATCOM EQU 050H command to tx patterns
154 * (ls 4 bits hold pattern number)

```

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		156	
		157 *	*****
		158 *	SUBROUTINE NMI,IRQ,OCI
		159 *	*****
		160	
		161 *	routine services timer output compare ints
F038 9608	OCI	LDAA 08H	dummy read of TCSR
F03A DC08	LD	LD 0BH	& dummy write to OCR
F03C DD0B	STD	STD 0BH	to clear OCF flag
F03E 7A006D	DEC	DEC SYNC	SET SYNC FLAG
F041	NMI		
F041 3B	IRQ	RTI	return
		168	
		169 *	*****
		170 *	SUBROUTINE LONGTM
		171 *	*****
		172	
		173 *	timer overflow int routine increments LONGTIM which
		174 *	forms an 8-bit extension to the timer (period=16,77 s @ 4 MHz)
		175	
F042 9608	LONGTM	LDAA 08H	dummy read TCSR & counter
F044 DC09	LD	LD 09H	to reset Timer Overflow Flag
F046 7C00C3	INC	INC LONGTIM	increment LONGTIM when timer overflows
F049 3B	RTI		
		180	
		181 *	*****
		182 *	SUBROUTINE RESTRT
		183 *	*****
		184	
		185 *	init system
		186	
F04A 8E00FF	RESTRT	LDS #0FFH	init stack pointer
F04D 867E	LDAA	LDAA #7EH	
F04F 9700	STAA	STAA DDR1	port1 I/O direction
F051 864E	LDAA	LDAA #4EH	
F053 9702	STAA	STAA PORT1	init port1
F055 86C1	LDAA	LDAA #0C1H	1,2,3,4,& 5 as inputs
F057 9705	STAA	STAA DDR4	
F059 8614	LDAA	LDAA #014H	
F05B 9701	STAA	STAA DDR2	timer, clock, serial data output
F05D 8609	LDAA	LDAA #09H	
F05F 9710	STAA	STAA RMCR	nrz; clock = 7812 Hz
F061 861A	LDAA	LDAA #1AH	
F063 9711	STAA	STAA TRCSR	tx/rx enabled
F065 860C	LDAA	LDAA #0CH	
F067 9708	STAA	STAA TCSR	tof enabled
		202 *	init tcxo to centre of range
F069 8664	LDAA	LDAA #100	
F06B F601C0	TCXO_1	LDAB D0A	read 100 times
F06E 4A	DECA		
F06F 26FA	BNE	BNE TCXO_1	

LOCATION	OBJECT CODE	LINE	SOURCE LINE
F071	8632	208	LDAA #50
F073	F701C0	209	TCXO_2 STAB DTOA write 50 times
F076	4A	210	DECA
F077	26FA	211	BNE TCXO_2
		212	
		213	* init synth
F079	CEF000	214	LDX #INITSY
F07C	BDF87D	215	JSR SYNTH
		216	
		217	* if we are a master then init the datalink
F07F	9602	218	LDAA PORT1
F081	8480	219	ANDA #80H
F083	271D	220	BEQ REMOTE
F085	9602	221	LDAA PORT1
F087	84FD	222	ANDA #0FDH P11 low
F089	9702	223	STAA PORT1
		224	
		225	* init the lcd
F08B	CEF1A7	226	LDX #LCDSET
F08E	C604	227	LDAB #4
F090	A600	228	NEXT LDAA X
F092	B70140	229	STAA STATUS
F095	BDF50C	230	JSR WORM_W
F098	08	231	INX
F099	5A	232	DECB
F09A	26F4	233	BNE NEXT
		234	
		235	* display introductory message on lcd
F09C	CEF197	236	LDX #MESSG1
F09F	BDF1AB	237	JSR LCDMSG
		238	
		239	* wait for 1 second
F0A2	8604	240	REMOTE LDAA #4
F0A4	CE0000	241	LDX #0
F0A7	09	242	WAIT2 DEX
F0A8	26FD	243	BNE WAIT2
F0AA	4A	244	DECA
F0AB	26FA	245	BNE WAIT2
		246	
		247	* switch off the synth to conserve battery
F0AD	9602	248	LDAA PORT1
F0AF	84BF	249	ANDA #0BFH P16 low
F0B1	9702	250	STAA PORT1
		251	* dummy reads
F0B3	9611	252	LDAA TRCSR
F0B5	9612	253	LDAA RXDATA
		254	* init distance display to 'no dist'
F0B7	86FF	255	LDAA #0FFH
F0B9	975E	256	STAA DIST
		257	* clear the interrupt mask
F0BB	0E	258	CLI

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		260	* link monitor routine LINK
		261	
F0BC	9602	262	LINK LDAA PORT1
F0BE	8480	263	ANDA #80H
F0C0	2744	264	BEQ RLINK
		265	
		266	* master:
		267	* enable the datalink
		268	
F0C2	9602	269	MLINK LDAA PORT1
F0C4	8A04	270	ORAA #04H P12 trdata high
F0C6	84FD	271	ANDA #0FDH P11 muteda low
F0C8	9702	272	STAA PORT1
		273	* IF the test line is low THEN do test
F0CA	9607	274	LDAA PORT4
F0CC	8420	275	ANDA #20H
F0CE	2603	276	BNE NOTEST
F0D0	BDF1BF	277	JSR TEST
		278	* IF the meas line is low THEN
F0D3	9607	279	NOTEST LDAA PORT4
F0D5	8402	280	ANDA #02H P41
F0D7	2625	281	BNE SYNOFF
		282	* .contact debounce for 20 ms
F0D9	CE1388	283	LDX #5000
F0DC	09	284	D_BNC DEX
F0DD	26FD	285	BNE D_BNC
		286	* wait for meas to go high again
F0DF	9607	287	SW_UP LDAA PORT4
F0E1	8402	288	ANDA #02H
F0E3	27FA	289	BEQ SW_UP
		290	* IF the track line is low (Pin 27 of 6301) THEN.
F0E5	9607	291	LDAA PORT4
F0E7	8404	292	ANDA #04H
F0E9	2605	293	BNE TESTMS
		294	* .start stakeout
F0EB	BDF241	295	JSR STAKE
F0EE	200E	296	BRA SYNOFF
		297	* .ELSE IF the test line is low THEN
F0F0	9607	298	TESTMS LDAA PORT4
F0F2	8420	299	ANDA #20H
F0F4	2605	300	BNE STATMS
		301	* .start the manual breakout
F0F6	BDF25E	302	JSR VELCTY
F0F9	2003	303	BRA SYNOFF
		304	* ELSE start static meas
F0FB	BDF24F	305	STATMS JSR STATIC
		306	* ELSE switch off the synth
F0FE	9602	307	SYNOFF LDAA PORT1
F100	84BF	308	ANDA #0BFH P16 low
F102	9702	309	STAA PORT1
F104	20BC	310	BRA MLINK

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		312	* remote:
		313	* this routine listens for a message from the master
		314	* wait for data (pin 26, carrier detect falling)
		315	
F106	96C3	316	RLINK LDAA LNGETIM init timer
F108	8B06	317	ADDA #6 (300 ms)
F10A	9791	318	STAA COUNT1
F10C	9602	319	RLOOP LDAA PORT1
F10E	8A02	320	ORAA #02H P11 high
F110	9702	321	STAA PORT1 ensure own datalink off
F112	CE0280	322	LDX #640 2,5 ms for data decay
F115	09	323	PATNCE DEX
F116	26FD	324	BNE PATNCE
F118	C608	325	LDAB #08H 08 while waiting for rising edge
		326	
		327	* IF the TEST line is low THEN do test
F11A	9607	328	EDGE LDAA PORT4
F11C	8520	329	BITA #20H
F11E	2603	330	BNE THROW
F120	BDF1BF	331	JSR TEST
F123	96C3	332	THROW LDAA LNGETIM time up?
F125	9191	333	CMFA COUNT1
F127	280C	334	BMI EDGE2
		335	
		336	* A timeout has occurred, the instruments are out of tune
		337	* or the measurement has finished. Switch off the synth.
F129	9602	338	LDAA PORT1
F12B	84BF	339	ANDA #0BFH P16 low
F12D	9702	340	STAA PORT1
F12F	96C3	341	LDAA LNGETIM restart the timer (200 ms)
F131	8B05	342	ADDA #5
F133	9791	343	STAA COUNT1
F135	9607	344	EDGE2 LDAA PORT4 look for the falling edge of CDET
F137	8408	345	ANDA #08H
F139	11	346	CBA
F13A	26DE	347	BNE EDGE
F13C	C008	348	SUBB #08H
F13E	27DA	349	BEQ EDGE eq hi detected, now wait for low
		350	
		351	* start the timer to time out audio mute
F140	96C3	352	LDAA LNGETIM
F142	8B06	353	ADDA #6
F144	9791	354	STAA COUNT1
		355	
		356	* IF the TEST line is low THEN do test
F146	9607	357	BYTCUM LDAA PORT4
F148	8520	358	BITA #20H
F14A	2603	359	BNE NO_TST
F14C	BDF1BF	360	JSR TEST

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		362	* rx the data, wait for the falling edge of rxdata
F14F	9607	363	NO_TST LDAA PORT4
F151	8410	364	ANDA #10H RX DATA pin 25?
F153	270E	365	BEQ GOT_IT
F155	96C3	366	LDAA LNGTIM has the timer timed out yet?
F157	9191	367	CMPA COUNT1
F159	26EB	368	BNE BYTCUM no, carry on
F15B	9602	369	LDAA PORT1 yes, switch off the synth
F15D	84BF	370	ANDA #0BFH
F15F	9702	371	STAA PORT1 P16 low
F161	20E3	372	BRA BYTCUM
		373	
F163	DC09	374	GOT_IT LDD CNTR
F165	0D6E	375	STD SYNCH
F167	7F0046	376	CLR ERROR0
F16A	BDF9E3	377	JSR RXINFO
F16D	7D0046	378	TST ERROR0
F170	2703	379	BEQ OKTOGO
F172	7EF10C	380	JMP RLOOP if data error - keep waiting
F175	17	381	OKTOGO TBA
		382	
		383	
		384	* IF data was command to measure THEN note pattern no.
		385	* & start measure task
F176	84F0	386	ANDA #0F0H top bits define command
F178	8150	387	CMPA #PATCOM
F17A	2618	388	BNE DONTMS
F17C	C40F	389	ANDB #0FH save pattern number
F17E	D76B	390	STAB PATCNT
		391	* switch off the remote datalink
F180	9602	392	LDAA PORT1
F182	8A02	393	ORAA #02H P11 high
F184	9702	394	STAA PORT1
		395	* switch on the synth
F186	9602	396	LDAA PORT1
F188	8A40	397	ORAA #40H P16 high
F18A	9702	398	STAA PORT1
F18C	CEF000	399	LDX #INITSY
F18F	BDF87D	400	JSR SYNTH
F192	8D77	401	BSR REM
F194	7EF106	402	DONTMS JMP RLINK
		403	
F197	2A2A2A204D	404	MESSG1 ASC "*** MICROMIN ***"
F1A7	34060C01	405	LCDSET FCB 34H,6,0CH,1

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE
			407	*	*****
			408	*	SUBROUTINE LDCMSG
			409	*	*****
			410		
			411	*	The 16 ascii character message is pointed to by
			412	*	the index register; display it on the lcd.
			413		
F1A8	8601		414	LDCMSG LDAA	#1
F1AD	B70140		415	STAA	STATUS
F1B0	C610		416	LDAB	#16
F1B2	BDF50C		417	DSP_1 JSR	WORM_W
F1B5	A600		418	LDAA	X
F1B7	B70141		419	STAA	LCD
F1BA	08		420	INX	
F1BB	5A		421	DECB	
F1BC	26F4		422	BNE	DSP_1
F1BE	39		423	RTS	
			424		
			425	*	*****
			426	*	SUBROUTINE TEST
			427	*	*****
			428		
			429	*	switch on the synth & the modulation
F1BF	9602		430	TEST LDAA	PORT1
F1C1	8A40		431	ORAA	#40H
F1C3	84F7		432	ANDA	#0F7H
F1C5	9702		433	STAA	PORT1
			434		
			435	*	init PATCNT to 0
F1C7	7F006B		436	TESTRT CLR	PATCNT
			437		
			438	*	wait for the falling edge of the test line
F1CA	9607		439	TSTDN LDAA	PORT4
F1CC	8420		440	ANDA	#20H
F1CE	26FA		441	BNE	TSTDN
			442		
			443	*	debounce for 40 ms
F1D0	CE2710		444	LDX	#10000
F1D3	09		445	TSTBNC	DEX
F1D4	26FD		446	BNE	TSTBNC
			447		
			448	*	wait for the rising edge of the test line
F1D6	9607		449	TSTUP LDAA	PORT4
F1D8	8420		450	ANDA	#20H
F1DA	27FA		451	BEQ	TSTUP
			452	*	calculate the address of the synth data
F1DC	CEF004		453	LDX	#PATTAB
F1DF	8605		454	LDAA	#5
F1E1	D66B		455	LDAB	PATCNT
F1E3	3D		456	MUL	
F1E4	3A		457	ABX	

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		459	* IF we are on patt 7 THEN
F1E5	8607	460	LDA #7
F1E7	916B	461	CMPA PATCNT
F1E9	2603	462	BNE USUAL
		463	
		464	* the reference of patt 7 is the same as patt 6
		465	* so use this opportunity to test the 10 MHz
		466	* straddle for patt 6
F1EB	C609	467	LDAB #9
F1ED	3A	468	ABX
		469	
		470	* ELSE load the synth
F1EE	BDF87D	471	USUAL JSR SYNTH
		472	
		473	* wait for 100 ms
F1F1	CE61A8	474	LDX #25000
F1F4	09	475	SYNFIN DEX
F1F5	26FD	476	BNE SYNFIN
		477	
		478	* IF master THEN display the pattern #
F1F7	9602	479	LDA PORT1
F1F9	8580	480	BITA #80H
F1FB	2703	481	BEQ WRONG1
F1FD	BDF4F5	482	JSR WORM
		483	
		484	* increment the pattern #, (rollover to 0 after 7)
F200	966B	485	WRONG1 LDA PATCNT
F202	4C	486	INCA
F203	8107	487	CMPA #FINEP
F205	2EC0	488	BGT TESTRT
F207	976B	489	STAA PATCNT
F209	20BF	490	BRA TSTDN
		491	
		492	* *****
		493	* SUBROUTINE REM
		494	* *****
		495	
		496	* If the instrument is a remote,
		497	* it will execute this routine on command from the
		498	* MEAS routine running in the master
		499	
		500	* set up the OCR so that SYNC will be set at the right time
F20B	DC6E	501	REM LDD SYNCH
F20D	C3BDD8	502	ADD #REMTIM
F210	DD6E	503	STD SYNCH
F212	DD0B	504	STD OCR
F214	7F006D	505	CLR SYNC
		506	* load pattern number
F217	966B	507	LDA PATCNT
F219	840F	508	ANDA #0FH
F21B	976B	509	STAA PATCNT

LOCATION	OBJECT CODE LINE	SOURCE LINE
		511 * measure phase of this pattern
F210 BDF70D	512	JSR PHASE
		513 * transmit phase to master
F220 964C	514	LDAA STRDL1 ms 8 bits of ST1-REF
F222 BDF982	515	JSR TXPLUS
F225 9650	516	LDAA STRDL2 ms 8 bits of ST2-REF
F227 BDF99C	517	JSR TXINFO
F22A 964D	518	LDAA STRDL1+1 pack ls 2 bits ST1-REF..
F22C 84C0	519	ANDA #0C0H
F22E D651	520	LDAB STRDL2+1 ls 2 bits of ST2-REF..
F230 57	521	ASRB
F231 57	522	ASRB
F232 C430	523	ANDB #30H
F234 1B	524	ABA
F235 9A6B	525	ORAA PATCNT & pattern number
F237 BDF99C	526	JSR TXINFO transmit the data &
F23A 9602	527	LDAA PORT1 then mute the datalink
F23C 8A02	528	ORAA #02H P11 high
F23E 9702	529	STAA PORT1
F240 39	530	RTS
	531	
	532 FINEP SET	7 finest pattern (20 MHz) number
	533	
	534 *	*****
	535 *	SUBROUTINE STAKE
	536 *	*****
	537	
	538 *	This is the entry point for stakeout
	539 *	The routine simply sets STAKEF & starts MEAS
	540	
F241 8601	541 STAKE LDAA	#1
F243 97A1	542 STAA	STAKEF (to steer averaging)
F245 8607	543 LDAA	#FINEP select '7' as final pattern
F247 7F007C	544 CLR	MEASKY
F24A 7F007D	545 CLR	MANUAL
F24D 200B	546 BRA	STAT4
	547	
	548 *	*****
	549 *	SUBROUTINE STATIC
	550 *	*****
	551	
	552 *	This is the entry point for STATIC
	553 *	This routine simply clears STAKEF & starts MEAS
	554	
F24F 7F00A1	555 STATIC CLR	STAKEF
F252 7F007D	556 CLR	MANUAL clear MANUAL flag
F255 7F007C	557 CLR	MEASKY
F258 8607	558 STAT3 LDAA	#FINEP
F25A 976C	559 STAT4 STAA	FINALP
F25C 2009	560 BRA	MEAS

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		562 *	*****
		563 *	SUBROUTINE VELCTY
		564 *	*****
		565	
		566 *	FOR TESTING this is a manual measure (angles)
		567 *	no breakout is incorporated
		568	
F25E	86FF	569	VELCTY LDAA #0FFH set MANUAL flag
F260	977D	570	STAA MANUAL
F262	7F00A1	571	CLR STAKEF
F265	20F1	572	BRA STAT3
		573	
		574 *	*****
		575 *	SUBROUTINE MEAS
		576 *	*****
		577	
		578 *	This is the entry point for MEAS. STATIC & STAKE both
		579 *	come here after clear/set-ing STAKEF to show
		580 *	which function is required
		581	
		582 *	home the cursor
F267	8602	583	MEAS LDAA #2
F269	B70140	584	STAA STATUS
F26C	BDF50C	585	JSR WORM_W
		586 *	switch on the synth
F26F	9602	587	LDAA PORT1
F271	8A40	588	ORAA #40H P16 high
F273	9702	589	STAA PORT1
F275	CEF000	590	LDX #INITSY
F278	BDF87D	591	JSR SYNTH
		592	
		593 *	init SYNCH & OCR for frame timing
F27B	DC09	594	LDD CNTR read counter
F27D	C361A8	595	ADD #25000 to start in 25 ms
F280	DD6E	596	STD SYNCH save value
F282	DD0B	597	STD OCR set up OCR
F284	7F006D	598	CLR SYNC clear SYNC flag
F287	7F007E	599	CLR BROKEN clear 'breakout completed'
F28A	CE005E	600	LDX #DIST get address of distance
F28D	6F00	601	INITRG CLR 0,X clear location
F28F	08	602	INX clear dist,speed,
F290	8C006B	603	CPX #PATCNT patcnt.
F293	23F8	604	BLS INITRG
F295	86FF	605	LDAA #-1 accum count=-1 to cause 2 patt 0's
F297	97A2	606	STAA STPCNT
F299	7C0046	607	INC ERROR0 fake error (prevent speed 1st time)
F29C	7F006D	608	CLR SYNC just in case that took too long
		609	

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		611	* FOR all patterns or UNTIL aborted DO.
		612	* IF the switch has been pressed THEN we must stop the meas
F29F	9607	613	ADINF LDAA PORT4
F2A1	8402	614	ANDA #02H P41 low ?
F2A3	265F	615	BNE AUTOBR
		616	* debounce for 5 ms
F2A5	CE1388	617	LDX #5000
F2A8	09	618	DE_BNC DEX
F2A9	26FD	619	BNE DE_BNC
		620	
		621	* put on datalink to prevent falling out of tune
F2AB	9602	622	LDAA PORT1
F2AD	8A04	623	ORAA #04H P12 high
F2AF	84FD	624	ANDA #0FDH P11 low
F2B1	9702	625	STAA PORT1
		626	
		627	* wait for the MEAS line to go high
F2B3	9607	628	GO_HI LDAA PORT4
F2B5	8402	629	ANDA #02H P41 low ?
F2B7	27FA	630	BEQ GO_HI
		631	* THEN exit
F2B9	7EF453	632	JMP MEAOUT
		633	
		634	* IF manual breakout THEN wait here till next instruction
F2BC	7D007D	635	TST MANUAL
F2BF	2743	636	BEQ AUTOBR
		637	* 1st time in so wait for the rising edge of TEST line
F2C1	9607	638	TESTU LDAA PORT4
F2C3	8520	639	BITA #20H
F2C5	27FA	640	BEQ TESTU
		641	* debounce for 20 ms
F2C7	CE1388	642	LDX #5000
F2CA	09	643	DBNITS DEX
F2CB	26FD	644	BNE DBNITS
		645	* init the datalink
F2CD	9602	646	WOTNXT LDAA PORT1
F2CF	8A04	647	ORAA #04H
F2D1	84FD	648	ANDA #0FDH
F2D3	9702	649	STAA PORT1
		650	
		651	* manual breakout, wait for falling edge of test line
F2D5	9607	652	TESTDN LDAA PORT4
F2D7	8520	653	BITA #20H
F2D9	2706	654	BEQ DBNTST
F2DB	8502	655	BITA #02H
F2DD	2719	656	BEQ DBNMES
F2DF	20F4	657	BRA TESTDN

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		659	* debounce for 20 ms
F2E1	CE1388	660	DBNTST LDX #5000
F2E4	09	661	TST_BN DEX
F2E5	26FD	662	BNE TST_BN
		663	* wait for the test line to go high again
F2E7	9607	664	TESTUP LDAA PORT4
F2E9	8420	665	ANDA #20H
F2EB	27FA	666	BEQ TESTUP
		667	
		668	* go to the next pattern but not beyond FINEP
F2ED	966B	669	LDAA PATCNT
F2EF	4C	670	INCA
F2F0	8107	671	CMPA #FINEP
F2F2	2E10	672	BGT AUTOBR
F2F4	976B	673	STAA PATCNT
F2F6	200C	674	BRA AUTOBR
		675	
		676	* debounce for 20 ms
F2F8	CE1388	677	DBNTST LDX #5000
F2FB	09	678	MES_BN DEX
F2FC	26FD	679	BNE MES_BN
		680	
		681	* wait for the MEAS line to go high again
F2FE	9607	682	MESUP LDAA PORT4
F300	8502	683	BITA #02H
F302	27FA	684	BEQ MESUP
		685	
		686	* transfer DIST to RANGE
F304	DC60	687	AUTOBR LDD DIST+2
F306	DD77	688	STD RANGE+2
F308	DC5E	689	LDD DIST
F30A	DD75	690	STD RANGE
		691	* .measure new DIST
F30C	9646	692	LDAA ERROR0 remember error count
F30E	9770	693	STAA TEMPER
F310	BDF589	694	JSR MASTPH
F313	BDF4F5	695	JSR WORM display the pattern number
F316	70007D	696	TST MANUAL ok to display <0 deg on pat0 in manual
F319	260D	697	BNE AWD
F31B	70006B	698	TST PATCNT any reading > 60 km is an error
F31E	2608	699	BNE AWD
F320	9658	700	LDAA PATPHS
F322	84E0	701	ANDA #0E0H
F324	81E0	702	CMPA #0E0H
F326	27DC	703	BEQ AUTOBR retry if the phase is < 0 (ie-359) to prevent
		704	* 60 km readings at short range
F328	9646	705	AWD LDAA ERROR0 if any errors then try again
F32A	9170	706	CMPA TEMPER
F32C	2708	707	BEQ INTUNE

LOCATION	OBJECT CODE	LINE	SOURCE LINE
F32E 70006D	709	RETUNE TST	SYNC wait till remote is finished
F331 27FB	710	BEQ	RETUNE
F333 7EF29F	711	JMP	ADINF
	712		
F336 BDF842	713	INTUNE JSR	TCXD
	714		
	715	* .IF in manual mode THEN display the result in degrees	
F339 70007D	716	TST	MANUAL
F33C 277C	717	BEQ	NOTMAN
F33E DC58	718	LDD	PATPHS get phase
F340 D082	719	STD	MANT
F342 7F0084	720	CLR	MANT+2
F345 7F0086	721	CLR	SIGN
F348 7F0085	722	CLR	EXP
F34B CEF3B5	723	LDX	#DEGREE in float point degrees
F34E BDF842	724	JSR	MULT
F351 C600	725	LDAB	#0
F353 BDFC6F	726	JSR	DFLOAT
F356 8601	727	LDAA	#1 clear the display & reset the cursor
F358 B70140	728	STAA	STATUS
F35B BDF50C	729	JSR	WORM_W
	730		
	731	* display the angle with the 1st 2 leading 0's suppressed	
F35E 9698	732	LDAA	DBUF1+4
F360 840F	733	ANDA	#0FH
F362 2707	734	BEQ	YES0
F364 8A30	735	ORAA	#30H
F366 BDF515	736	JSR	WORM_N
F369 200E	737	BRA	KEIN0
F36B BDF513	738	YES0 JSR	WORM_S
F36E 9699	739	LDAA	DBUF1+5
F370 840F	740	ANDA	#0FH
F372 2605	741	BNE	KEIN0
F374 BDF513	742	JSR	WORM_S
F377 2009	743	BRA	BUF1_6
F379 9699	744	KEIN0 LDAA	DBUF1+5
F37B 840F	745	ANDA	#0FH
F37D 8A30	746	ORAA	#30H
F37F BDF515	747	JSR	WORM_N
F382 969A	748	BUF1_6 LDAA	DBUF1+6
F384 840F	749	ANDA	#0FH
F386 8A30	750	ORAA	#30H
F388 BDF515	751	JSR	WORM_N
	752		
	753	* display "'_on_patt_"	
F38B CEF3AB	754	LDX	#DEGSON
F38E C60A	755	LDAB	#10
F390 A600	756	THRU LDAA	X
F392 BDF515	757	JSR	WORM_N
F395 08	758	INX	

LOCATION	OBJECT CODE	LINE	SOURCE LINE
F396	5A	760	DECB
F397	26F7	761	BNE THRU
		762	
		763	* then the pattern \$__
F399	966B	764	LDA PATCNT
F39B	840F	765	ANDA #0FH
F39D	8A30	766	ORAA #30H
F39F	BDF515	767	JSR WORM_N
F3A2	BDF513	768	JSR WORM_S
F3A5	BDF513	769	JSR WORM_S
		770	
		771	* wait for the next pattern-measure instruction
F3A8	7EF2CD	772	JMP WOTNXT
		773	
F3A8	DF	774	DEGSON FCB 0DFH      ascii for degrees sign
F3AC	206F6E2070	775	ASC " on patt "
F3B5	B400000900	776	DEGREE FCB 0B4H,0,0,9,0   360 in flp
		777	
		778	* .END (ELSE)
F3BA	BDF454	779	NOTMAN JSR WINDOW   scale RANGE for this pattern
F3BD	96A2	780	LDA STPCNT   skip test if first measure
F3BF	4C	781	INCA
F3C0	2729	782	BEQ PHSOK
F3C2	DC75	783	LDD RANGE   get old distance bits
F3C4	9358	784	SUBD PATPHS   subtract the new ones (msb = 180 deg)
		785	
		786	*       static
F3C6	8B40	787	ADDA #040H   if msb's = 11XXH or 00XXH then ok
F3C8	8580	788	BITA #080H   else error > 90 deg
F3CA	271F	789	BEQ PHSOK
		790	
		791	* ..dec average counter, if zero then
		792	*   dec counter, but not below 0
		793	
F3CC	7A00A2	794	BADPHS DEC STPCNT
F3CF	2F03	795	BLE TOOFAR
F3D1	7EF29F	796	JMP ADINF
F3D4	7A006B	797	TOOFAR DEC PATCNT
F3D7	2E05	798	BGT BAKPAT
F3D9	2709	799	BEQ BACK2
F3DB	7C006B	800	INC PATCNT
F3DE	7F00A2	801	BAKPAT CLR STPCNT
F3E1	7EF29F	802	JMP ADINF
F3E4	86FF	803	BACK2 LDAA #-1   pat 0: count=-1 to prevent averaging
F3E6	97A2	804	STAA STPCNT
F3E8	7EF29F	805	JMP ADINF
		806	* .ELSE
		807	* ..RANGE = RANGE so far with low bits from this measurement
F3EB	96A2	808	PHSOK LDA STPCNT   inc average count to max of 16
F3ED	8110	809	CMPA #16

LOCATION	OBJECT CODE	LINE	SOURCE LINE
F3EF	2703	811	BEQ GETON
F3F1	4C	812	INCA
F3F2	97A2	813	STAA STPCNT
F3F4	BDF693	814	GETON JSR USEPH
F3F7	BDF481	815	JSR BLIND normalise RANGE
		816	
		817	* ..increment pattern count, but not above FINALP
		818	* (pattern 0 to be repeated twice)
F3FA	966B	819	LDAA PATCNT
F3FC	916C	820	CMPA FINALP
F3FE	270A	821	BEQ CALCSP
F400	9BA2	822	ADDA STPCNT 1st time on pattern 0?
F402	2706	823	BEQ CALCSP
F404	7C006B	824	INC PATCNT
F407	7F00A2	825	CLR STPCNT clearer counts of measurements on this pattern
		826	* ..calculate new speed (2's complement)
F40A	7D0046	827	CALCSP TST ERROR0 if any errors timing disturbed
F40D	260E	828	BNE CLRERR so keep old speed
F40F	DC77	829	LDD RANGE+2 get 1s bytes of new distance
F411	9360	830	SUBD DIST+2 subtract previous distance
F413	DD68	831	STD SPEED+2 2 1s bytes of speed
F415	DC75	832	LDD RANGE get 2 ms bytes
F417	D25F	833	SBCB DIST+1 subtract with carry 3rd byte
F419	925E	834	SBCA DIST subtract with carry ms byte
F41B	DD66	835	STD SPEED ms bytes of speed
F41D	7F0046	836	CLRERR CLR ERROR0
		837	
		838	* ..display the pattern number
F420	0F	839	SEI
F421	DC75	840	LDD RANGE
F423	DD5E	841	STD DIST
F425	DC77	842	LDD RANGE+2
F427	DD60	843	STD DIST+2
F429	0E	844	CLI
F42A	BDF49E	845	JSR DEBUG
		846	* .END
		847	* REP
		848	* never end if in stakeout mode
F42D	966B	849	LDAA PATCNT if final pattern..
F42F	916C	850	CMPA FINALP
F431	260B	851	BNE ADIINF
F433	7D00A1	852	TST STAKEF ..& not in stakeout mode
F436	2606	853	BNE ADIINF
F438	8610	854	LDAA #16 ..& done 16
F43A	91A2	855	CMPA STPCNT
F43C	2703	856	BEQ WRAPUP ..then display the reading
F43E	7EF29F	857	ADIINF JMP ADINF

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		859	* IF the breakout went to FINALP THEN
F441	966C	860	WRAPUP LDAA FINALP
F443	916B	861	CMPA PATCNT
F445	2E0C	862	BGT MEADUT
F447	B0F8CB	863	JSR ANSWER format the answer
		864	* put the datalink back on to stop falling out of tune
F44A	9602	865	LDAA PORT1
F44C	84FD	866	ANDA $\$0FDH$ P11 low
F44E	9702	867	STAA PORT1
F450	B0F523	868	JSR LCDRNG display the answer on the lcd
		869	
		870	* .display the result & get out
F453	39	871	MEADUT RTS
		872	
		873	* *****
		874	* SUBROUTINE WINDOW
		875	* *****
		876	
		877	* Shifts the data in RANGE so that bits
		878	* in 'window' (RANGE, RANGE+1) correspond to
		879	* bits in PATPHS
		880	* calc $\frac{1}{2}$ of times approx dist to be
		881	* shifted for comparison with phase (PATPHS)
F454	CEF479	882	WINDOW LDX $\$SLIDE$
F457	D66B	883	LDAB PATCNT
F459	3A	884	ABX
F45A	E600	885	LDAB 0,X
F45C	D771	886	STAB SIDSLP save $\frac{1}{2}$ of times to be shifted
		887	* shift approx dist left for comparison with measured phase
F45E	5A	888	SHIFTL DECB
F45F	2B17	889	BMI COMPAR if shifted enough, stop
F461	780078	890	ASL RANGE+3
F464	790077	891	ROL RANGE+2
F467	790076	892	ROL RANGE+1
F46A	790075	893	ROL RANGE
F46D	790074	894	ROL RANGE-1
F470	790073	895	ROL RANGE-2
F473	790072	896	ROL RANGE-3 shift left (max 18 times)
F476	20E6	897	BRA SHIFTL repeat
F478	39	898	COMPARE RTS
		899	* $\frac{1}{2}$ of times that RANGE must be shifted for
		900	* comparison with measured phase, PATPHS
F479	00	901	SLIDE FCB 0 2k44 effective pattern frequencies
F47A	02	902	FCB 2 9k76
F47B	04	903	FCB 4 39k06
F47C	06	904	FCB 6 156k
F47D	08	905	FCB 8 625k
F47E	09	906	FCB 9 1M25
F47F	0C	907	FCB 12 10M
F480	0E	908	FCB 14 40M

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		910 *	*****
		911 *	SUBROUTINE BLIND
		912 *	*****
		913	
		914 *	Shifts RANGE data back to where WINDOW
		915 *	found them. It assumes SIDSPL has been
		916 *	set by WINDOW
		917	
		918 *	Shift approx dist back to proper position
F481	D671	919	BLIND LDAB SIDSPL recover $\frac{1}{2}$ of times to be shifted
F483	5A	920	SHIFTR DECB
F484	2B17	921	BMI DRAWN if shifted enough stop
F486	770072	922	ASR RANGE-3
F489	760073	923	ROR RANGE-2
F48C	760074	924	ROR RANGE-1
F48F	760075	925	ROR RANGE
F492	760076	926	ROR RANGE+1
F495	760077	927	ROR RANGE+2
F498	760078	928	ROR RANGE+3 shift right (max 18 times)
F49B	20E6	929	BRA SHIFTR repeat
F49D	39	930	DRAWN RTS
		931	
		932	
		933 *	*****
		934 *	SUBROUTINE DEBUG
		935 *	*****
		936	
F49E	7D0046	937	DEBUG TST ERROR0 no display if an error has occurred
F4A1	2621	938	BNE FORGT
F4A3	7D00A1	939	TST STAKEF or in STATIC meas mode
F4A6	271C	940	BEQ FORGT
F4A8	966B	941	LDAA PATCNT STAKEOUT ,so show distance
F4AA	916C	942	CMPA FINALP are we on final pattern?
F4AC	2616	943	BNE FORGT
F4AE	96A2	944	LDAA STPCNT if so skip on the 1st one
F4B0	8101	945	CMPA #1
F4B2	2610	946	BNE FORGT
F4B4	86FF	947	LDAA #0FFH flag that we now have a breakout
F4B6	977E	948	STAA BROKEN
F4B8	7F00A2	949	CLR STPCNT clear the count of how long on this pattern
F4BB	BDF8CB	950	JSR ANSWER display the result
F4BE	BDF523	951	JSR LCDRNG
F4C1	7A006B	952	DEC PATCNT go back to patt #FINALP-1
F4C4	39	953	FORGT RTS
		954	
		955 *	messages
F4C5	2A2A2A2A2A	956	T01ERR ASC "*****ERROR1**"
F4D5	2A2A2A2A2A	957	T02ERR ASC "*****ERROR2**"
F4E5	2A2A2A2A2A	958	HSERR ASC "*****HS-ERR**"

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		960 *	*****
		961 *	SUBROUTINE WORM
		962 *	*****
		963	
		964 *	copy "_N_" into the first 6 positions of the lcd
		965 *	where N is the pattern number
		966	
F4F5 8D24		967 WORM	BSR WORM_R
F4F7 8D1A		968	BSR WORM_S
F4F9 8D18		969	BSR WORM_S
F4FB 966B		970	LDAA PATCNT
F4FD 840F		971	ANDA #0FH
F4FF 8A30		972	ORAA #30H
F501 8D12		973	BSR WORM_N
F503 8D0E		974	BSR WORM_S
F505 8D0C		975	BSR WORM_S
F507 8D0A		976	BSR WORM_S
F509 8D10		977	BSR WORM_R
F50B 39		978	RTS
		979	
F50C B60140		980 WORM_W	LDAA STATUS wait for BF
F50F 48		981	ASLA
F510 25FA		982	BCS WORM_W
F512 39		983	RTS
		984	
F513 8620		985 WORM_S	LDAA #20H space
F515 B70141		986 WORM_N	STAA LCD number
F518 8DF2		987	BSR WORM_W
F51A 39		988	RTS
		989	
F51B 8602		990 WORM_R	LDAA #2 reset cursor
F51D B70140		991	STAA STATUS
F520 8DEA		992	BSR WORM_W
F522 39		993	RTS

LOCATION	OBJECT CODE	LINE	SOURCE LINE	
		995 *	*****	
		996 *	SUBROUTINE LCDRNG	
		997 *	*****	
		998		
		999		
F523	8DF6	1000	LCDRNG BSR WORM_R	reset cursor
F525	8644	1001	LDAA #44H	D
F527	8DEC	1002	BSR WORM_N	
F529	8649	1003	LDAA #49H	I
F52B	8DE8	1004	BSR WORM_N	
F52D	8653	1005	LDAA #53H	S
F52F	8DE4	1006	BSR WORM_N	
F531	8654	1007	LDAA #54H	T
F533	8DE0	1008	BSR WORM_N	
F535	863D	1009	LDAA #3DH	=
F537	8DDC	1010	BSR WORM_N	
F539	8DD8	1011	BSR WORM_S	sp
F53B	7F0040	1012	CLR XTEMP	
F53E	9694	1013	LDAA DBUF1	
F540	8D33	1014	BSR SLZ	10000's
F542	8DD1	1015	BSR WORM_N	
F544	9695	1016	LDAA DBUF1+1	
F546	8D2D	1017	BSR SLZ	1000's
F548	8DCB	1018	BSR WORM_N	
F54A	9696	1019	LDAA DBUF1+2	
F54C	8D27	1020	BSR SLZ	100's
F54E	8DC5	1021	BSR WORM_N	
F550	9697	1022	LDAA DBUF1+3	
F552	8D21	1023	BSR SLZ	10's
F554	8DBF	1024	BSR WORM_N	
F556	9698	1025	LDAA DBUF1+4	
F558	8D23	1026	BSR REST	1's
F55A	8DB9	1027	BSR WORM_N	
F55C	862E	1028	LDAA #2EH	dp
F55E	8DB5	1029	BSR WORM_N	
F560	9699	1030	LDAA DBUF1+5	
F562	8D19	1031	BSR REST	dm
F564	8DAF	1032	BSR WORM_N	
F566	969A	1033	LDAA DBUF1+6	
F568	8D13	1034	BSR REST	cm
F56A	8DA9	1035	BSR WORM_N	
F56C	866D	1036	LDAA #6DH	m
F56E	8DA5	1037	BSR WORM_N	
F570	8DA1	1038	BSR WORM_S	sp
F572	8DA7	1039	BSR WORM_R	reset cursor
F574	39	1040	RTS	
		1041		

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		1043 *	*****
		1044 *	SUBROUTINE SLZ & REST
		1045 *	*****
		1046	
		1047 *	IF a digit has already been found THEN
F575	7D0040	1048 SLZ TST XTEMP	xtemp is a memory of the first occurrence
F578	2603	1049 BNE REST	of a non zero digit
F57A	4D	1050 TSTA	zero detected
F57B	2709	1051 BEQ LDZ	
		1052 *	.display zeroes as digits
F57D	840F	1053 REST ANDA #0FH	convert unpacked bcd to ascii
F57F	8A30	1054 ORAA #30H	return with ascii in ACCA
F581	C6FF	1055 LDAB #0FFH	
F583	D740	1056 STAB XTEMP	
F585	39	1057 RTS	
		1058 *	ELSE this is a zero string at the beginning of a number
F586	8620	1059 LDZ LDAA #020H	replace leading zero with space
F588	39	1060 RTS	
		1061	
		1062	
		1063 *	*****
		1064 *	SUBROUTINE MASTPH
		1065 *	*****
		1066	
		1067 *	This subroutine does all the necessary synth setting,
		1068 *	timing & data transfers required to obtain one
		1069 *	measurement on one phase when a master instrument
		1070	
		1071 *	Wait till command should be transmitted
F589	7D006D	1072 MASTPH TST SYNC	1st check that we're not late
F58C	270C	1073 BEQ COMTX1	
F58E	DC09	1074 LDD CNTR	too late..
F590	C30140	1075 ADDD #320	wait a further 320 us
F593	DD6E	1076 STD SYNCH	
F595	DD0B	1077 STD OCR	
F597	7F006D	1078 CLR SYNC	
F59A	7D006D	1079 COMTX1 TST SYNC	
F59D	27FB	1080 BEQ COMTX1	wait till command should be transmitted
		1081 *	tx command
F59F	9602	1082 LDAA PORT1	set the datalink to a 1 & enable
F5A1	8A04	1083 ORAA #04H	P12 high
F5A3	84FD	1084 ANDA #0FDH	P11 low
F5A5	9702	1085 STAA PORT1	
F5A7	966B	1086 LDAA PATCNT	get pattern #
F5A9	8A50	1087 ORAA #PATCOM	add measure command
F5AB	BDF982	1088 JSR TXPLUS	tx command

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		1090	* set up OCR to set SYNC at the right time
F5AE	DC6E	1091	LDD SYNC get prev value of SYNC time
F5B0	C3C350	1092	ADD #MSTIM1 + time till start of next wait period
F5B3	000B	1093	STD OCR set up OCR
F5B5	006E	1094	STD SYNC save time
F5B7	7F006D	1095	CLR SYNC clear SYNC flag
		1096	* turn datalink off (remote should tx phase data later)
F5BA	9602	1097	LDAA PORT1
F5BC	8A02	1098	ORAA #02H P11 high
F5BE	9702	1099	STAA PORT1
		1100	
		1101	* measure effective pattern phase (from 3 patterns)
F5C0	B0F70D	1102	JSR PHASE
		1103	* set up OCR to set SYNC at the right time
F5C3	DC6E	1104	LDD SYNC get prev value of SYNC time
F5C5	C3EA60	1105	ADD #RXTIM + time till the 2nd byte should be rx'd
F5C8	000B	1106	STD OCR set up OCR
F5CA	006E	1107	STD SYNC save time
F5CC	7F006D	1108	CLR SYNC clear SYNC flag
		1109	* rx phase data from remote
F5CF	CEF4C5	1110	WAITRX LDX #T01ERR wait for the falling edge of CDET
F5D2	7D006D	1111	TST SYNC
F5D5	2664	1112	BNE RERROR
F5D7	8608	1113	LDAA #08H P43 ?
F5D9	9507	1114	BITA PORT4
F5DB	26F2	1115	BNE WAITRX
		1116	* 1st byte
F5DD	CEF4D5	1117	RX1BYT LDX #T02ERR
F5E0	7D006D	1118	TST SYNC wait for start bit (falling edge of RXDATA)
F5E3	2656	1119	BNE RERROR
F5E5	8610	1120	LDAA #10H P44 ?
F5E7	9507	1121	BITA PORT4
F5E9	26F2	1122	BNE RX1BYT
F5EB	7F0046	1123	CLR ERROR0
F5EE	B0F9E3	1124	JSR RXINFO
F5F1	7D0046	1125	TST ERROR0
F5F4	2645	1126	BNE RERROR
F5F6	D754	1127	STAB REMST1 1st byte (STRADDLE1-REF)
		1128	* 2nd byte
F5FB	CEF4D5	1129	RX2BYT LDX #T02ERR
F5FB	7D006D	1130	TST SYNC must rx the start of this 2nd byte
F5FE	2638	1131	BNE RERROR before SYNC to avoid a timeout
F600	8610	1132	LDAA #10H P44 ?
F602	9507	1133	BITA PORT4
F604	26F2	1134	BNE RX2BYT
F606	7F0046	1135	CLR ERROR0
F609	B0F9E3	1136	JSR RXINFO
F60C	7D0046	1137	TST ERROR0
F60F	262A	1138	BNE RERROR
F611	D756	1139	STAB REMST2

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		1141	* 3rd byte
F613	8610	1142	RX3BYT LDAA #10H P44 ?
F615	9507	1143	BITA PORT4
F617	26FA	1144	BNE RX3BYT
F619	7F0046	1145	CLR ERROR0
F61C	BDF9E3	1146	JSR RXINFO
F61F	7D0046	1147	TST ERROR0
F622	2617	1148	BNE RERROR
		1149	
		1150	* 3rd byte rx'd. Check handshake nibble in the ls 4 bits
		1151	* of the 2nd byte, it should = pattern #
		1152	
F624	17	1153	TBA duplicate rx'd byte in acca
F625	C40F	1154	ANDB #0FH get handshake nibble
F627	CEF4E5	1155	LDX #HSERR
F62A	D16B	1156	CMFB PATCNT check if = pattern #
F62C	260D	1157	BNE RERROR if not then error
F62E	16	1158	TAB ls 2 bits of rem st1 & st2 in top nibble
F62F	84C0	1159	ANDA #0C0H get the 2 lsb's of rem's st1 & save
F631	9755	1160	STAA REMST1+1
F633	58	1161	ASLB get 2 lsb's of rem's st2
F634	58	1162	ASLB
F635	C4C0	1163	ANDB #0C0H
F637	D757	1164	STAB REMST2+1 & save
F639	200E	1165	BRA SETSNC synchronise
		1166	
		1167	* an error has occurred
F63B	7C0046	1168	RERROR INC ERROR0 inc error flag
F63E	BDF1AB	1169	JSR LCOMSG display the error message pointed
F641	D6C3	1170	LDAB LNGTIM to by the index register
F643	C803	1171	ADDB #3 to time 200 ms
F645	D1C3	1172	LETSEE CMFB LNGTIM
F647	2AFC	1173	BPL LETSEE
		1174	
		1175	* turn datalink off
F649	9602	1176	SETSNC LDAA PORT1
F64B	8A06	1177	ORAA #06H P11 & P12 high
F64D	9702	1178	STAA PORT1 tx a 1
		1179	* set up OCR to set SYNC at the proper time
F64F	7D006D	1180	SYNDEL TST SYNC
F652	27FB	1181	BEQ SYNDEL
F654	DC6E	1182	LDD SYNCH
F656	C3A730	1183	ADDD #CYCTIM
F659	DD6E	1184	STD SYNCH
F65B	DD0B	1185	STD OCR
F65D	7F006D	1186	CLR SYNC
		1187	* calculate the phase angle for this pattern
F660	7F007A	1188	CLR AMBIGF clear ambiguity flag
F663	DC4C	1189	LDD STROL1 get 1st straddle result
F665	9354	1190	SUBD REMST1
F667	DD4C	1191	STD STROL1 (10 bits are significant)

LOCATION	OBJECT CODE	LINE	SOURCE LINE
F669	DC50	1193	LDD STRDL2 2nd ditto
F66B	9356	1194	SUBD REMST2
F66D	D050	1195	STD STRDL2
F66F	934C	1196	SUBD STRDL1 now check for rollover
F671	46	1197	RORA test:(C XOR N)=1 if rollover
F672	8B40	1198	ADDA #040H
F674	2A04	1199	BPL NOROL
F676	8680	1200	LDA #080H set ambiguity flag
F678	977A	1201	STAA AMBIGF
F67A	DC4C	1202	NOROL LDD STRDL1 find av st1 & st2
F67C	D350	1203	ADD STRDL2
F67E	46	1204	RORA
F67F	56	1205	RORB
F680	9B7A	1206	ADDA AMBIGF correct for rollover ambiguity
F682	D058	1207	STD PATPHS
		1208	
		1209	* check for disagreement between straddles
F684	DC4C	1210	LDD STRDL1
F686	9350	1211	SUBD STRDL2
F688	2B01	1212	BMI ABSC
F68A	40	1213	NEGA
F68B	8110	1214	ABSC CMPA #010H
F68D	2003	1215	BLT LOKEPT
F68F	7C0046	1216	INC ERROR0
F692	39	1217	LOKEPT RTS
		1218	
		1219	* *****
		1220	* SUBROUTINE USEPH
		1221	* *****
		1222	
		1223	* IF enough readings have been taken on this pattern THEN
		1224	* use the result else add the result to the phase list
		1225	
		1226	* IF final pattern THEN
F693	966B	1227	USEPH LDA PATCNT
F695	916C	1228	CMPA FINALP
F697	262F	1229	BNE NOTFNL
		1230	* .add the result to the phase list
F699	CE00A3	1231	LDX #LIST
F69C	D6A2	1232	LDAB STPCNT
F69E	5A	1233	DECB
F69F	3A	1234	ABX
F6A0	3A	1235	ABX
F6A1	DC58	1236	LDD PATPHS
F6A3	ED00	1237	STD 0,X
		1238	* .IF in static mode THEN
F6A5	7D00A1	1239	TST STAKEF
F6A8	2610	1240	BNE STAKEM

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		1242	* ..IF 16 readings already THEN
F6AA	D6A2	1243	LDAB STPCNT
F6AC	C110	1244	CHPB #16
F6AE	2608	1245	BNE MOREPH
		1246	* ...average all of them
F6B0	C610	1247	LDAB #16
F6B2	BDF93A	1248	JSR AVERAG
		1249	* ...incorporate in answer
F6B5	BDF6CC	1250	JSR APPEND
		1251	* END
F6B8	200C	1252	MOREPH BRA KEEPON
		1253	* .ELSEIF in dynamic mode THEN
F6BA		1254	STAKEM RMB 0
		1255	* ..IF 1 reading THEN
F6BA	D6A2	1256	LDAB STPCNT
F6BC	C101	1257	CHPB #1
F6BE	2606	1258	BNE KEEPON
		1259	* ...average & incorporate them
F6C0	BDF93A	1260	JSR AVERAG
F6C3	BDF6CC	1261	JSR APPEND
		1262	* END
F6C6	2003	1263	KEEPON BRA AVOUT
		1264	* ELSE incorporate into measurement
F6C8	BDF6CC	1265	NOTFNL JSR APPEND
		1266	* END
F6CB	39	1267	AVOUT RTS
		1268	
		1269	
		1270	* *****
		1271	* SUBROUTINE APPEND
		1272	* *****
		1273	
		1274	* Replaces the low bits of DIST with the result
		1275	* for this pattern, (PATPHS)
		1276	* Range has been scaled for this pattern before entry
		1277	
		1278	* correct high bits for rollover & append new bits
F6CC	DC75	1279	APPEND LDD RANGE
F6CE	9358	1280	SUBD PATPHS
F6D0	2409	1281	BCC THUMP carry clear = new-dist < old-dist
F6D2	8580	1282	BITA #80H dec hi bits if net disturbance is less
F6D4	260C	1283	BNE JUMP
F6D6	BDF6E7	1284	JSR DECHI
F6D9	2007	1285	BRA JUMP
F6DB	8580	1286	THUMP BITA #80H inc hi bits if disturbance is less
F6DD	2703	1287	BEQ JUMP
F6DF	BDF6FA	1288	JSR INCHI
F6E2	DC58	1289	JUMP LDD PATPHS
F6E4	DD75	1290	STD RANGE
F6E6	39	1291	RTS

LOCATION	OBJECT CODE	LINE	SOURCE LINE
F6E7	9674	1293	DECHI LDAA RANGE-1 dec high bits
F6E9	8001	1294	SUBA #1
F6EB	9774	1295	STAA RANGE-1
F6ED	9673	1296	LDAA RANGE-2
F6EF	8200	1297	SBCA #0
F6F1	9773	1298	STAA RANGE-2
F6F3	9672	1299	LDAA RANGE-3
F6F5	8200	1300	SBCA #0
F6F7	9772	1301	STAA RANGE-3
F6F9	39	1302	RTS
		1303	
F6FA	9674	1304	INCHI LDAA RANGE-1 inc high bits
F6FC	8801	1305	ADDA #1
F6FE	9774	1306	STAA RANGE-1
F700	9673	1307	LDAA RANGE-2
F702	8900	1308	ADCA #0
F704	9773	1309	STAA RANGE-2
F706	9672	1310	LDAA RANGE-3
F708	8900	1311	ADCA #0
F70A	9772	1312	STAA RANGE-3
F70C	39	1313	RTS
		1314	
		1315 *	*****
		1316 *	SUBROUTINE PHASE
		1317 *	*****
		1318	
		1319 *	Measures the phase of the current pattern.
		1320 *	Measures the phases of the straddles & subtracts
		1321 *	them from the phase of the reference frequency to
		1322 *	give the partial results for each straddle.
		1323 *	(In the MEAS routine the phase at the master is subtracted
		1324 *	from the remote phase to give the final pattern phase.)
		1325	
		1326 *	Calculate addresses where synth data is stored in table
F70D	CEF004	1327	PHASE LDX #PATTAB get address of pattern table
F710	8605	1328	LDAA #5
F712	D66B	1329	LDAB PATCNT
F714	3D	1330	MUL offset address = 6 * pattern #
F715	3A	1331	ABX add offset to start of table
F716	DF44	1332	STX XTEMP1 save address of reference pattern
		1333 *	calculate address of straddle freq data
F718	E604	1334	LDAB 4,X get offset for straddle freq data
F71A	CEF004	1335	LDX #PATTAB
F71D	3A	1336	ABX get address of straddle freq
F71E	3C	1337	PSHX save for the 2nd straddle
		1338 *	set up the synth for the 1st straddle
F71F	BDF87D	1339	JSR SYNTH load synth
		1340 *	If remote then don't add delay
F722	9602	1341	LDAA PORT1
F724	8480	1342	ANDA #80H P17 ?
F726	2711	1343	BEQ NOWAIT

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		1345	* wait a little longer if master
F728	7D006D	1346	FRSTWT TST SYNC
F72B	27FB	1347	BEQ FRSTWT
F72D	DC6E	1348	LDD SYNCH
F72F	C34800	1349	ADD #MSTIM2
F732	DD6E	1350	STD SYNCH
F734	DD0B	1351	STD OCR
F736	7F006D	1352	CLR SYNC
		1353	
		1354	* calc phase of 1st straddle pattern
F739	4F	1355	NOWAIT CLRA clear phase slip
F73A	5F	1356	CLRB
F73B	DD4A	1357	STD DELPHS
F73D	BDF79E	1358	JSR PATFAS
F740	DC48	1359	LDD PHSTOT get straddle phase
F742	DD4C	1360	STD STRDL1 & save
		1361	* wait for 1 ms to ensure other inst has finished measuring
F744	CE00FA	1362	LDX #250
F747	09	1363	S1 DEX
F748	26FD	1364	BNE S1
		1365	* load synth with reference pattern
F74A	DE44	1366	LDX XTEMP1
F74C	BDF87D	1367	JSR SYNTH
		1368	* set up OCR to set SYNC at right time
F74F	DC6E	1369	LDD SYNCH get previous value of SYNC time
F751	C3FA00	1370	ADD #PHSTIM add time till start of next measurement
F754	DD0B	1371	STD OCR update OCR
F756	DD6E	1372	STD SYNCH update SYNC
F758	7F006D	1373	CLR SYNC clear SYNC flag
		1374	* calc phase of reference pattern
F75B	BDF79E	1375	JSR PATFAS
F75E	DC48	1376	LDD PHSTOT get average phase
F760	DD4E	1377	STD DIFPHS & save
		1378	* wait for 1 ms to ensure other inst has finished measuring
F762	CE00FA	1379	LDX #250
F765	09	1380	S2 DEX
F766	26FD	1381	BNE S2
		1382	* set up synth with 2nd straddle pattern
F768	38	1383	PULX
F769	BDF87D	1384	JSR SYNTH
		1385	* set up OCR to set SYNC at the right time
F76C	DC6E	1386	LDD SYNCH
F76E	C3FA00	1387	ADD #PHSTIM
F771	DD0B	1388	STD OCR
F773	DD6E	1389	STD SYNCH
F775	7F006D	1390	CLR SYNC
		1391	* calc phase of 2nd straddle pattern
F778	BDF79E	1392	JSR PATFAS
F77B	DC48	1393	LDD PHSTOT get average phase
F77D	DD50	1394	STD STRDL2 & save

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		1396	* wait for 1 ms to ensure other inst has finished measuring
F77F	CE00FA	1397	LDX #250
F782	09	1398	S3 DEX
F783	26FD	1399	BNE S3
		1400	* switch off the modulator
F785	CEF000	1401	LDX #INITSY
F788	BDF87D	1402	JSR SYNTH
		1403	* do the sums
F78B	DC4E	1404	LDD DIFPHS get ref - 1st straddle phase
F78D	934C	1405	SUBD STRDL1
F78F	05	1406	ASLD left justify
F790	05	1407	ASLD
F791	05	1408	ASLD
F792	DD4C	1409	STD STRDL1
F794	DC4E	1410	LDD DIFPHS get ref - 2nd straddle phase
F796	9350	1411	SUBD STRDL2
F798	05	1412	ASLD
F799	05	1413	ASLD
F79A	05	1414	ASLD
F79B	DD50	1415	STD STRDL2
F79D	39	1416	RTS
		1417	
		1418	* *****
		1419	* SUBROUTINE PATFAS
		1420	* *****
		1421	
		1422	* Measures phase of one pattern
		1423	* 2 * 128 samples are measured & the sum of the results
		1424	* is placed in PHSTOT.
		1425	* The slip between the 1st & 2nd samples is added
		1426	* to a running counter to be used later to lock tcxo's
		1427	* The routine starts at the 1st occurrence of SYNC being set
		1428	
F79E	966D	1429	PATFAS LDAA SYNC wait for SYNC flag
F7A0	27FC	1430	BEQ PATFAS
F7A2	7F006D	1431	CLR SYNC
F7A5	8680	1432	LDAA #128 # of samples
F7A7	BDF7E0	1433	JSR PHSMES measure the phase
F7AA	DE48	1434	LDX PHSTOT save
F7AC	DF50	1435	STX STRDL2 (use STRDL2 as scratch)
F7AE	8680	1436	LDAA #128 meas 2nd time
F7B0	BDF7E0	1437	JSR PHSMES
		1438	* The following will form SLIP1-SLIP2+SLIP3 after
		1439	* 3 calls of this subr if DELPHS is cleared
		1440	* before the 1st call (result in DELPHS)
		1441	* & corrects slip & phase for ambiguity between halves
		1442	
F7B3	DC48	1443	LDD PHSTOT
F7B5	9350	1444	SUBD STRDL2
F7B7	2A08	1445	BPL POSLIP PL: slip appears +ve
F7B9	8508	1446	BITA #08H is slip really -ve?

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE
F7BB	2618		1448	BNE NO_AMB	(ie. is ABS(slip) < pi?)
F7BD	8B10		1449	ADDA #10H	NO!, add 2*PI to make +ve
F7BF	2006		1450	BRA AMBIG	
F7C1	8508		1451	POSLIP BITA #08H	is slip really +ve?
F7C3	2710		1452	BEQ NO_AMB	(ie. is ABS(slip) < pi?)
F7C5	8010		1453	SUBA #10H	NO!, subt 2*PI to make -ve
F7C7	934A		1454	AMBIG SUBD DELPHS	DELPHS = -DELPHS + slip
F7C9	DD4A		1455	STD DELPHS	
F7CB	DC48		1456	LDD PHSTOT	correct PHSTOT
F7CD	8010		1457	SUBA #10H	(subtract 360 deg)
F7CF	D350		1458	ADD STRDL2	add 2nd half
F7D1	DD48		1459	STD PHSTOT	
F7D3	200A		1460	BRA PATOUT	
F7D5	934A		1461	NO_AMB SUBD DELPHS	DELPHS = -DELPHS + slip
F7D7	DD4A		1462	STD DELPHS	
F7D9	DC48		1463	LDD PHSTOT	add 1st & 2nd halves of reading
F7DB	D350		1464	ADD STRDL2	
F7DD	DD48		1465	STD PHSTOT	(now in 13 bits)
F7DF	39		1466	PATOUT RTS	
			1467		
			1468	*	*****
			1469	*	SUBROUTINE PHSMES
			1470	*	*****
			1471		
			1472	*	Routine to measure phase of one pattern.
			1473		
			1474	*	The synth should already be loaded.
			1475	*	The loop is synchronised to the falling edge of the
			1476	*	9,7656 kHz signal so as to take the phase values in step
			1477	*	with the transfer of the counter value to the latch.
			1478	*	The loop then sums (A-reg) readings of the counter
			1479	*	& corrects this sum for ambiguity by adding or subtracting
			1480	*	64 to the total depending on how many counts were made
			1481	*	after or before the rollover.
			1482		
F7E0	9747		1483	PHSMES STAA COUNTR	store # of samples required
F7E2	07		1484	TPA	save stsus (int mask in particular)
F7E3	36		1485	PSHA	
F7E4	0F		1486	SEI	do not disturb
F7E5	8620		1487	LDAA #020H	init previous phase to equal
F7E7	9752		1488	STAA PRUPHS	half of the maximum possible count
F7E9	CE0000		1489	LDX #0	init ACCX for summing phases
F7EC	4F		1490	CLRA	" ACCA (add-or-subtract flag)
F7ED	7F005A		1491	CLR ADDHLF	" ambiguity correction register
F7F0	7F005C		1492	CLR SUBHLF	" " " "
F7F3	C601		1493	LDAB #01H	wait for the falling edge of 9,7656 kHz
F7F5	D502		1494	UP19 BITB	PORT1
F7F7	26FC		1495	BNE UP19	

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE
				1497 * Loop to collect "COUNTR" phase readings.	
				1498 * COUNTR=128 if PHSMES is called from PATFAS (MEAS)	
				1499 * The value of each reading lies between 0 & 3FH.	
				1500	
				1501 * ! THE TIMING OF THIS LOOP MUST NOT BE CHANGED !	
				1502	
F7F9	C601	1503	LOOP	LDAB #01H	Wait for the falling edge of 9,76 kHz
F7FB	D502	1504	LATCH	BITB PORT1	this latches the counters value to
F7FD	27FC	1505		BEQ LATCH	the latch
F7FF	F60100	1506		LDAB PHSCNT	read the counter value
F802	D740	1507		STAB XTEMP	save in scratchpad for later
F804	3A	1508		ABX	add it to the running sum
F805	D052	1509		SUBB PRUPHS	subtract the previous phase value
F807	59	1510		ROLB	before shifting.....
F808	59	1511		ROLB	If msb's of diff=X10 then rollover..
F809	8900	1512		ADCA #0	..so inc ambiguity flag
F80B	59	1513		ROLB	If msb's of diff=X01 then rollunder..
F80C	8200	1514		SBCA #0	..so dec ambiguity flag
F80E	D640	1515		LDAB XTEMP	recover saved counter value
F810	D752	1516		STAB PRUPHS	to update previous phase register
F812	4D	1517		TSTA	check ambiguity flag
F813	2E0C	1518		BGT PH3	If +ve increment ADDHLF
F815	270D	1519		BEQ PH4	If 0 do not adjust
F817	7C005C	1520		INC SUBHLF	If -ve increment SUBHLF
F81A	7A0047	1521		DEC COUNTR	Finished yet?
F81D	26DA	1522		BNE LOOP	
F81F	2008	1523		BRA AU_RAG	
F821	7C005A	1524	PH3	INC ADDHLF	
F824	7A0047	1525	PH4	DEC COUNTR	decrement count until COUNTR phases read
F827	26D0	1526		BNE LOOP	ie, until COUNTR=0
				1527 *	
				1528 * This is the end of the phase reading loop. The x-reg	
				1529 * now contains the sum of COUNTR phase readings ,ADDHLF &	
				1530 * SUBHLF contain the # of readings that were different	
				1531 * by more than +32 or -32 respectively.	
				1532	
				1533	
F829	DF48	1534	AU_RAG	STX PHSTOT	store sum of phases
F82B	4F	1535		CLRA	form ADDHLF-SUBHLF in d-reg
F82C	D65A	1536		LDAB ADDHLF	
F82E	D05C	1537		SUBB SUBHLF	
F830	8200	1538		SBCA #0	(sign extend)
F832	05	1539		ASLD	times 64
F833	05	1540		ASLD	
F834	05	1541		ASLD	
F835	05	1542		ASLD	
F836	05	1543		ASLD	
F837	05	1544		ASLD	
F838	D348	1545		ADD PHSTOT	adjust sum
F83A	841F	1546		ANDA #1FH	preserve the 13 meaningful phase bits
F83C	04	1547		LSRD	scrap least bit, result in 12 bits

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE
F83D	DD48		1549	STD PHSTOT	store phase result
F83F	32		1550	PULA	restore status
F840	06		1551	TAP	
F841	39		1552	RTS	return from measurement
			1553		
			1554	*	*****
			1555	*	SUBROUTINE TCXO
			1556	*	*****
			1557		
			1558	*	this subroutine pulls the master tcxo
			1559		
			1560	*	get absolute value of phase difference
F842	DC4A	1561	TCXO	LDD DELPHS	DELPHS holds sum of 3
F844	05	1562	ASLD		readings of slip
F845	05	1563	ASLD		each of +/-11bits (+/- PI)
F846	CEF875	1564	LDX	#PATPUL	init the amount of pulling depending
F849	D66B	1565	LDAB	PATCNT	on what pattern we are currently on
F84B	C40F	1566	ANDB	#0FH	
F84D	3A	1567	ABX		
F84E	E600	1568	LDAB	0,X	
			1569		
F850	4D	1570	TSTA		
F851	2A02	1571	BPL	ABSA	
F853	40	1572	NEGA		change the direction of the tcxo pulling
F854	50	1573	NEGB		depending on the direction of the phase change
			1574		
F855	8102	1575	ABSA	CMPA #2	if the phase diff is less than the noise
F857	2D1B	1576	BLT	PULOUT	threshold (2) then don't pull tcxo
			1577		
			1578	*	from the pattern number decide the required direction of pulling
F859	966B	1579	LDAA	PATCNT	
F85B	840F	1580	ANDA	#0FH	mask off the higher nibble
F85D	8006	1581	SUBA	#6	diff patts (0-6) have opposite sense
F85F	2E01	1582	BGT	BUMP	to absolute patterns, so change the
F861	50	1583	NEGB		direction of pulling for pattern 7
			1584		
			1585	*	now pull the tcxo
F862	5D	1586	BUMP	TSTB	
F863	270F	1587	BEQ	PULOUT	
F865	2B07	1588	BMI	INCPOT	
F867	B701C0	1589	DECPOT	STAA DTOA	write to decrement pot
F86A	5A	1590	DECB		B times
F86B	26FA	1591	BNE	DECPOT	
F86D	39	1592	RTS		
F86E	B601C0	1593	INCPOT	LDAA DTOA	read to increment pot
F871	5C	1594	INCB		B times
F872	26FA	1595	BNE	INCPOT	
F874	39	1596	PULOUT	RTS	
			1597		
F875	0403030202	1598	PATPUL	FCB	4,3,3,2,2,1,1,1

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		1600 *	*****
		1601 *	SUBROUTINE SYNTH
		1602 *	*****
		1603	
		1604 *	Routine to load synth.
		1605 *	Address of data is in X-reg.
F87D	07	1606 SYNTH TPA	Remember the state of the I-mask
F87E	36	1607 PSHA	Save on stack
F87F	37	1608 PSHB	
F880	0F	1609 SEI	
		1610 *	IF remote THEN
F881	9602	1611 LDAA PORT1	
F883	8480	1612 ANDA #80H	
F885	2602	1613 BNE MSYN	
		1614 *	.inc X by 2 to get the remote freq data
F887	08	1615 INX	
F888	08	1616 INX	
		1617 *	ELSE get master freq data
F889	EC00	1618 MSYN LDD 0,X	save synth data for later ref
F88B	DDC4	1619 STD SYNREG	
F88D	8610	1620 LDAA #16	counter for 16 bits
F88F	9742	1621 STAA COUNT	
		1622	
F891	DCC4	1623 MORBIT LDD SYNREG	
F893	05	1624 ASLD	
F894	DDC4	1625 STD SYNREG	
F896	2406	1626 BCC ITSA0	
F898	9602	1627 LDAA PORT1	data out high
F89A	8A10	1628 ORAA #10H	P14
F89C	2004	1629 BRA CLOK	
		1630	
F89E	9602	1631 ITSA0 LDAA PORT1	data out low
F8A0	84EF	1632 ANDA #0EFH	
F8A2	9702	1633 CLOK STAA PORT1	
F8A4	9602	1634 LDAA PORT1	
F8A6	8A20	1635 ORAA #20H	clock pulse high
F8A8	9702	1636 STAA PORT1	P15
F8AA	9602	1637 LDAA PORT1	
F8AC	84DF	1638 ANDA #0DFH	clock pulse low
F8AE	9702	1639 STAA PORT1	
F8B0	7A0042	1640 DEC COUNT	
F8B3	26DC	1641 BNE MORBIT	
		1642	
F8B5	9602	1643 LDAA PORT1	clear synth data
F8B7	84CF	1644 ANDA #0CFH	clear synth clock
F8B9	9702	1645 STAA PORT1	P14,P15 low
		1646	
F8BB	B70180	1647 STAA SYNEN	strobe the data into the synth
F8BE	B70180	1648 STAA SYNEN	
F8C1	B70180	1649 STAA SYNEN	
F8C4	B70180	1650 STAA SYNEN	

LOCATION	OBJECT CODE	LINE	SOURCE LINE
F8C7	33	1652	PULB
F8C8	32	1653	PULA
F8C9	06	1654	TAP
F8CA	39	1655	RTS
		1656	
		1657	
		1658	
		1659 *	*****
		1660 *	SUBROUTINE ANSWER
		1661 *	*****
		1662	
		1663 *	Displays the range answer.
		1664 *	Prepares the result in locations DIST for display after
		1665 *	taking into account the met correction, & the units required.
		1666	
F8CB	965E	1667	ANSWER LDAA DIST
F8CD	84E0	1668	ANDA #0E0H if ms bits set then no dist
F8CF	81E0	1669	CMPA #0E0H
F8D1	2601	1670	BNE DISTIN
F8D3	39	1671	RTS
F8D4	4F	1672	DISTIN CLRA
F8D5	5F	1673	CLRB
F8D6	D075	1674	STD RANGE use top RANGE as scratch
F8D8	DC60	1675	LDD DIST+2
F8DA	9375	1676	SUBD RANGE
F8DC	D077	1677	STD RANGE+2
F8DE	DC5E	1678	LDD DIST
F8E0	C200	1679	SBCB #0
F8E2	8200	1680	SBCA #0
F8E4	D075	1681	STD RANGE
		1682	
		1683 *	Subtract coarse offset of 000 mm due to the horns.
		1684 *	(an offset of 14 cm is #1320H)
F8E6	DC77	1685	LDD RANGE+2
F8E8	830000	1686	SUBD #0000H msb =937 mm
F8EB	D077	1687	STD RANGE+2
F8ED	DC75	1688	LDD RANGE
F8EF	C200	1689	SBCB #0
F8F1	8200	1690	SBCA #0
F8F3	D075	1691	STD RANGE
		1692	
		1693 *	RANGE is 4 bytes long though the maths routines only
		1694 *	work in 3 bytes so left justify RANGE
		1695 *	(shift left up to 5 bits until msb is set)
F8F5	4F	1696	CLRA shift counter/exponent
F8F6	D675	1697	SC_LE LDAB RANGE test if msb is set
F8F8	2B12	1698	BMI PROD
F8FA	36	1699	PSHA
F8FB	DC77	1700	LDD RANGE+2 shift 1 bit
F8FD	05	1701	ASLD
F8FE	D077	1702	STD RANGE+2

LOCATION	OBJECT CODE	LINE	SOURCE LINE
F900	DC75	1704	LDD RANGE
F902	59	1705	ROLB
F903	49	1706	ROLA
F904	DD75	1707	STD RANGE
F906	32	1708	PULA recover shift counter
F907	4A	1709	DECA
F908	81FA	1710	CMFA #-6
F90A	26EA	1711	BNE SC_LE
F90C	5F	1712	PROD CLRB to clr sign of RANGE
F90D	DD78	1713	STD RANGE+3 save exp & sign of RANGE
		1714	
		1715	* range = range*met factor
F90F	CE0075	1716	LDX #RANGE
F912	BDFBB6	1717	JSR GET
F915	BDFB9B	1718	JSR NORM
F918	CEF930	1719	LDX #RIFACT
F91B	BDFB42	1720	JSR MULT
F91E	CE0075	1721	LDX #RANGE
F921	BDFBD8	1722	JSR SAVE
		1723	* mant = range*units factor
F924	CEF935	1724	LDX #CONVRT
F927	BDFB42	1725	JSR MULT
		1726	
		1727	* prepare for display
F92A	C602	1728	LDAB #2
F92C	BDFC6F	1729	JSR DFLOAT metric/static 2 dp acc (1 cm)
F92F	39	1730	RTS
		1731	
		1732	* Units conversion, (C= 299 792 500 m/s)
F930	800AA60100	1733	RIFACT FCB 080H,00AH,0A6H,001H,0 1,000325 (met)
F935	EFD5811000	1734	CONVRT FCB 0EFH,0D5H,081H,010H,0 Full scale metres
		1735	*CONVRT FCB 0C4H,0B6H,0BFH,012H,0 Full scale UK feet
		1736	*CONVRT FCB 0C4H,0B6H,0D8H,012H,0 Full scale US feet
		1737	
		1738	
		1739	* *****
		1740	* SUBROUTINE AVERAG
		1741	* *****
		1742	
		1743	* Averages (B-reg) pattern readings in LIST
		1744	* taking ambiguity correction into consideration
		1745	* returns result in PATPHS
		1746	
		1747	* B must be a power of 2 !
		1748	
		1749	* init
F93A	7F0058	1750	AVERAG CLR PATPHS
F93D	7F0059	1751	CLR PATPHS+1
F940	7F005A	1752	CLR PATPHS+2
F943	CE00A3	1753	LDX #LIST
F946	37	1754	PSHB

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		1803 *	*****
		1804 *	SUBROUTINE TXPLUS
		1805 *	*****
		1806	
		1807 *	Set TXDATA high for 20 ms then jump to TXINFO
F982	37	1808	TXPLUS PSHB
F983	3C	1809	PSHX
F984	36	1810	PSHA
F985	DC09	1811	LDD CNTR to time 20 ms
F987	C34E20	1812	ADD #20000
F98A	37	1813	PSHB
F98B	36	1814	PSHA
F98C	38	1815	PULX
F98D	D602	1816	LDAB PORT1 transmit a 1
F98F	CA04	1817	ORAB #04H P12 high trdata
F991	C4FD	1818	ANDB #0FDH P11 low muteda
F993	D702	1819	STAB PORT1
F995	9C09	1820	FIVEMS CPX CNTR
F997	2AFC	1821	BPL FIVEMS
F999	32	1822	PULA
F99A	2002	1823	BRA TXIN
		1824	
		1825 *	*****
		1826 *	SUBROUTINE TXINFO
		1827 *	*****
		1828	
		1829 *	Routine to tx info to another instrument
		1830 *	Format: start bit, 8 data bits, 2 checksum bits, stop bit
		1831 *	baud rate = 1200. Lsb is tx'd 1st
		1832 *	Output is high for a 1
		1833 *	Byte must be in ACCA. ACCB & X reg are not destroyed.
		1834 *	A bit is moved into the carry flag & then tx'd
		1835	
F99C	37	1836	TXINFO PSHB save ACCB
F99D	3C	1837	PSHX save X reg
F99E	D602	1838	TXIN LDAB PORT1 transmit a 1
F9A0	CA04	1839	ORAB #04H P12 high trdata
F9A2	C4FD	1840	ANDB #0FDH P11 low muteda
F9A4	D702	1841	STAB PORT1
F9A6	C601	1842	LDAB #1 init high bit counter
F9A8	D77B	1843	STAB CHKSUM (to 1 so all 0's not valid)
F9AA	C60C	1844	LDAB #12 # of bits to be tx'd
F9AC	D747	1845	STAB COUNTR
F9AE	DE09	1846	LDX CNTR get current value of counter
F9B0	0C	1847	CLC tx start bit = 0
		1848 *	Loop to tx 10 bits
F9B1	2508	1849	LOOPTX BCS TXONE tx one if carry set
		1850 *	Tx 0
F9B3	D602	1851	LDAB PORT1
F9B5	C4FB	1852	ANDB #0FBH P12 low
F9B7	D702	1853	STAB PORT1
F9B9	2009	1854	BRA BITWAT wait until next bit has to be tx'd

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE
			1856	* TX 1	
F9B8	D602		1857	TXONE LDAB	PORT1
F9B0	CA04		1858	ORAB	#04H P12 high
F9BF	D702		1859	STAB	PORT1
F9C1	7C007B		1860	INC	CHKSUM inc sum of bits
			1861	* Wait for 1 bit period	
F9C4	C6D0		1862	BITWAT LDAB	#0D0H (= 1/4 bit period)
F9C6	3A		1863	ABX	
F9C7	3A		1864	ABX	
F9C8	3A		1865	ABX	
F9C9	3A		1866	ABX	add period required to X reg (=832 E-cycles)
F9CA	9C09		1867	WATBIT CPX	CNTR
F9CC	2AFC		1868	BPL	WATBIT wait until end of period
			1869	* Check if end of transmission	
F9CE	7A0047		1870	DEC	COUNTR
F9D1	270D		1871	BEQ	ENDTX return if last bit has been tx'd
			1872	* If end of data THEN tx the checksum & stop bit	
F9D3	C603		1873	LDAB	#3
F9D5	D147		1874	CHPB	COUNTR
F9D7	2604		1875	BNE	NXTBIT
F9D9	967B		1876	LDA	CHKSUM ls 2 bits will be tx'd
F9DB	8A04		1877	ORAA	#4 insert stop bit
F9DD	46		1878	NXTBIT RORA	move next bit into carry flag
F9DE	20D1		1879	BRA	LOOPTX tx next bit
			1880	* Recover registers, END.	
F9E0	38		1881	ENDTX	PULX
F9E1	33		1882		PULB
F9E2	39		1883		RTS
			1884		
			1885		
			1886	*	*****
			1887	*	SUBROUTINE RXINFO
			1888	*	*****
			1889		
			1890	* Subroutine to rx info from another instrument	
			1891	* Format: 1 start bit ,8 data bits, 2 check bits,1 stop bits	
			1892	* Baud rate = 1200. Lsb is rx'd 1st	
			1893	* Input must be high for a 1.	
			1894	* Rx'd byte will be in ACCB. ACCA, X reg not destroyed	
			1895	* Subroutine must only be called after start bit detected	
			1896		
			1897	* Subroutine ends if rx'd start bit is < half period long	
			1898	* ERROR0 will be incremented if stop bit is not detected	
			1899	* or if check bits not correct or if bits not 'solid'	
			1900	* Rx'd bit sets or clears. Carry is shifted to give byte	
			1901		
			1902	* Init	
F9E3	3C		1903	RXINFO	PSHX
F9E4	36		1904		PSHA
F9E5	DE09		1905	LDX	CNTR set X to time at 3/8 bit
F9E7	C6FF		1906	LDAB	#0FFH

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE
F9E9	3A		1908	ABX	
F9EA	C639		1909	LDAB	#039H
F9EC	3A		1910	ABX	
F9ED	C60D		1911	LDAB	#13     init bit counter
F9EF	D747		1912	STAB	COUNTR
F9F1	4F		1913	CLRA	init bit rx'd
F9F2	36		1914	PSHA	to balance stack
F9F3	9F40		1915	STS	XTEMP     save cond of stack
F9F5	7F007B		1916	CLR	CHKSUM     start count of hi bits rx'd
F9F8	7C007B		1917	INC	CHKSUM     (@ 1 so all 0's not valid)
			1918		
			1919	* FOR all bits DO.	
F9FB	7A0047		1920	RXLOOP	DEC     COUNTR
F9FE	2F35		1921	BLE	RXSTOP
			1922		
			1923	* .add newest bit to bits rx'd so far, & update checksum	
FA00	33		1924	PULB	recover bits so far
FA01	4D		1925	TSTA	test new bit
FA02	2704		1926	BEQ	GOTO
FA04	7C007B		1927	INC	CHKSUM
FA07	0D		1928	SEC	
FA08	56		1929	GOTO	RORB
FA09	37		1930	PSHB	
			1931		
			1932	* .IF the 8 data bits have all been rx'd THEN	
			1933	* save the checksum. Prepare stack to rx	
			1934	* the tx'd checksum.	
FA0A	8603		1935	LDAA	#3
FA0C	9147		1936	CMPA	COUNTR
FA0E	2607		1937	BNE	ONEQ
FA10	967B		1938	LDAA	CHKSUM
FA12	8403		1939	ANDA	#3
FA14	36		1940	PSHA	
FA15	4F		1941	CLRA	
FA16	36		1942	PSHA	
			1943		
			1944	* .wait till 3/8 way through the current bit	
FA17	9C09		1945	ONEQ	CPX     CNTR
FA19	2AFC		1946	BPL	ONEQ
			1947		
			1948	* .read the rxdata line	
FA1B	9607		1949	LDAA	PORT4
FA1D	8410		1950	ANDA	#10H     P44 ?
FA1F	16		1951	TAB	
			1952		
			1953	* .IF the bit doesn't stay solid for 1/4 bit time THEN	
			1954	* GOTO error	
FA20	C60D		1955	LDAB	#0D0H     (=1/4 bit time)
FA22	3A		1956	ABX	
FA23	D607		1957	THREEQ	LDAB     PORT4
FA25	C410		1958	ANDB	#10H

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE
FA27	11		1960	CBA	
FA28	261A		1961	BNE	REROR
FA2A	9C09		1962	CPX	CNTR
FA2C	2AF5		1963	BPL	THREEQ
			1964		
			1965	* REP (1st set X-reg for 3/8 next bit time)	
FA2E	C6D0		1966	LDAB	#0D0H
FA30	3A		1967	ABX	
FA31	3A		1968	ABX	
FA32	3A		1969	ABX	
FA33	20C6		1970	BRA	RXLOOP
			1971		
			1972	* IF the stop bit isn't high THEN GOTO REROR	
FA35	4D		1973	RXSTOP	TSTA
FA36	270C		1974	BEQ	REROR
			1975		
			1976	* IF the calculated checksum is not = the rx'd	
			1977	* checksum THEN GOTO REROR	
FA38	32		1978	PULA	rx'd checksum
FA39	49		1979	ROLA	
FA3A	49		1980	ROLA	
FA3B	49		1981	ROLA	right justified
FA3C	33		1982	PULB	calc'd checksum
FA3D	11		1983	CBA	
FA3E	2604		1984	BNE	REROR
			1985		
			1986	* RETURN (result in B-reg)	
FA40	33		1987	RXOUT	PULB
FA41	32		1988	PULA	
FA42	38		1989	PULX	
FA43	39		1990	RTS	
			1991		
			1992	* Flag error, restore stack & exit	
FA44	7C0046		1993	REROR	INC ERROR0
FA47	9E40		1994	LDS	XTEMP
FA49	20F5		1995	BRA	RXOUT
			1996		
			1997		
			1998	* In the following subroutines involving 2	
			1999	* operands, the 1st operand consists of 5	
			2000	* contiguous locations with the following format;	
			2001	* MANT	m.s. byte of mantissa
			2002	* MANT+1	middle byte of mantissa
			2003	* MANT+2	l.s. byte of mantissa
			2004	* EXP	exponent
			2005	* SIGN	sign of mantissa
			2006	* The 2nd operand is index referenced in	
			2007	* the following way;	
			2008	* 0,X	m.s. byte of mantissa
			2009	* 1,X	middle byte of mantissa
			2010	* 2,X	l.s. byte of mantissa

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		2012 *	3,X exponent
		2013 *	4,X sign of mantissa
		2014 *	The result always overwrites the 1st operand
		2015 *	The 2nd operand remains unaltered
		2016	
		2017 *	*****
		2018 *	SUBROUTINE ADD
		2019 *	*****
		2020	
		2021 *	THE addend, the address of which is specified by
		2022 *	the X reg, is added to the augend in
		2023 *	MANT (3 bytes), EXP, SIGN
		2024	
FA48 A604		2025 ADD	LDA 4,X test sign of addend
FA4D 2A04		2026	BPL ADOP if sign is -ve then
FA4F BDFAC3		2027	JSR SUBP subtract addend
FA52 39		2028	RTS
FA53 DF87		2029 ADDP	STX IXP save X reg
FA55 BDFACD		2030	JSR ADJEXP adjust exponents
FA58 9682		2031	LDA MANT
FA5A 9A83		2032	ORA MANT+1
FA5C 9A84		2033	ORA MANT+2
FA5E 2607		2034	BNE A1 test if mantissa=0
FA60 BDFBB6		2035	JSR GET
FA63 7F0086		2036	CLR SIGN set sign to +ve
FA66 39		2037	RTS
FA67 9686		2038 A1	LDA SIGN test sign
FA69 2703		2039	BEQ L1
FA6B BDFAFB		2040	JSR COMPL complement mantissa
FA6E BDFB0D		2041 L1	JSR ADD1 add mantissas
FA71 250C		2042	BCS L2 check if overflow occurred
FA73 9686		2043	LDA SIGN test sign
FA75 2719		2044	BEQ OUT1
FA77 BDFAFB		2045	JSR COMPL complement mantissa
FA7A BDFA9B		2046	JSR NORM normalise result
FA7D 2011		2047	BRA OUT1
FA7F 9686		2048 L2	LDA SIGN test sign
FA81 2610		2049	BNE L3
FA83 0D		2050	SEC SHIFT in a "1"
FA84 760082		2051	ROR MANT
FA87 760083		2052	ROR MANT+1
FA8A 760084		2053	ROR MANT+2
FA8D 7C0085		2054	INC EXP
FA90 DE87		2055 OUT1	LDX IXP restore index value
FA92 39		2056	RTS
FA93 7F0086		2057 L3	CLR SIGN set sign to +ve
FA96 BDFA9B		2058	JSR NORM normalise result
FA99 20F5		2059	BRA OUT1

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE
			2061 *	*****	
			2062 *	SUBROUTINE NORM	
			2063 *	*****	
			2064		
FA9B	9682	2065	NORM LDAA	MANT	check if normalised
FA9D	2B15	2066	BMI	R2	
FA9F	8619	2067	LDAA	#25	
FAA1	4A	2068	L5	DECA	
FAA2	2718	2069	BEQ	L4	
FAA4	7A0085	2070	DEC	EXP	
FAA7	290C	2071	BUS	ZERO	check for 2's complement overflow
FAA9	780084	2072	ASL	MANT+2	shift mantissa left
FAAC	790083	2073	ROL	MANT+1	
FAAF	790082	2074	ROL	MANT	
FAB2	2AED	2075	BPL	L5	repeat if not yet normalised
FAB4	39	2076	R2	RTS	
			2077		
			2078 *	*****	
			2079 *	SUBROUTINE ZERO	
			2080 *	*****	
			2081		
FAB5	4F	2082	ZERO	CLRA	
FAB6	9782	2083	STAA	MANT	set mantissa =0
FAB8	9783	2084	STAA	MANT+1	
FABA	9784	2085	STAA	MANT+2	
FABC	9786	2086	L4	STAA	SIGN
FABE	8680	2087	LDAA	#080H	set exponent to largest
FAC0	9785	2088	STAA	EXP	...-ve # allowed
FAC2	39	2089		RTS	
			2090		
			2091 *	*****	
			2092 *	SUBROUTINE SUBP	
			2093 *	*****	
FAC3	730086	2094	SUBP	COM	SIGN change sign
FAC6	BDF453	2095	JSR	ADDP	add absolute value of subtrahend
FAC9	730086	2096	COM	SIGN	change sign of result
FACC	39	2097		RTS	
			2098		
			2099 *	*****	
			2100 *	SUBROUTINE ADJEXP	
			2101 *	*****	
			2102 *	Subroutine ADJEXP operates on the smaller of	
			2103 *	the 2 operands. Its mantissa is shifted right	
			2104 *	& its exponent increased until it is equal to	
			2105 *	the exponent of the larger operand.	
			2106		
FACD	A603	2107	ADJEXP	LDAA	3,X exponent of addend
FACF	9185	2108	CHPA	EXP	exponent of augend
FAD1	2712	2109	BEQ	RET1	test for equal exponents
FAD3	2D11	2110	BLT	RELOC	(3,X)<(EXP)

LOCATION	OBJECT	CODE	LINE	SOURCE	LINE
FA05	740082	2112	ADJ1	LSR	MANT shift mantissa to right &
FA08	760083	2113		ROR	MANT+1 ...increase exponent
FA0B	760084	2114		ROR	MANT+2
FA0E	7C0085	2115		INC	EXP
FAE1	9185	2116		CMPA	EXP
FAE3	26F0	2117		BNE	ADJ1
FAE5	39	2118	RET1	RTS	
		2119			
		2120	*		*****
		2121	*		SUBROUTINE RELOC
		2122	*		*****
		2123			
		2124	*		Subroutine RELOC is required in case the addend
		2125	*		is a constant in row. If its exponent is smaller
		2126	*		than that of the augend, it must be transferred to
		2127	*		row so that its mantissa can be shifted right &
		2128	*		its exponent increased until it equals the
		2129	*		exponent of the augend.
		2130			
FAE6	BDFBCB	2131	RELOC	JSR	GET1 copy mantissa into RELREG
FAE9	74007F	2132	ADJ2	LSR	RELREG shift mantissa to right &
FAEC	760080	2133		ROR	RELREG+1 ...increase exponent
FAEF	760081	2134		ROR	RELREG+2
FAF2	4C	2135		INCA	A contains exp of addend
FAF3	9185	2136		CMPA	EXP compare with exp of augend
FAF5	26F2	2137		BNE	ADJ2
FAF7	CE007F	2138		LDX	#RELREG point to RELREG
FAFA	39	2139		RTS	...of relocated addend.
		2140			
		2141	*		*****
		2142	*		SUBROUTINE COMPL
		2143	*		*****
		2144			
		2145	*		Subroutine COMPL forms the 2's complement of
		2146	*		the 3 byte word in MANT
		2147			
FAFB	4F	2148	COMPL	CLRA	
FAFC	9284	2149	COMPL1	SBCA	MANT+2
FAFE	9784	2150		STAA	MANT+2
FB00	8600	2151		LDAA	#00
FB02	9283	2152		SBCA	MANT+1
FB04	9783	2153		STAA	MANT+1
FB06	8600	2154		LDAA	#00
FB08	9282	2155		SBCA	MANT
FB0A	9782	2156		STAA	MANT
FB0C	39	2157		RTS	

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		1756	* FOR all (B) entries DO.
		1757	* .add phase to total
F947	37	1758	SUM PSHB (loop counter)
F948	EC00	1759	LDD X
F94A	D359	1760	ADD PATPHS+1
F94C	DD59	1761	STD PATPHS+1
F94E	9658	1762	LDAA PATPHS
F950	8900	1763	ADCA #0
		1764	
		1765	* .correct for ambiguity
F952	E600	1766	LDAB X
F954	DDA3	1767	SUBB LIST
F956	2406	1768	BCC BACKWD
F958	5D	1769	TSTB
F959	2807	1770	BMI NOAMB
F95B	4C	1771	INCA
F95C	2004	1772	BRA NOAMB
F95E	5D	1773	BACKWD TSTB
F95F	2A01	1774	BPL NOAMB
F961	4A	1775	DECA
F962	9758	1776	NOAMB STAA PATPHS
		1777	
		1778	* REP
F964	08	1779	INX
F965	08	1780	INX
F966	33	1781	PULB
F967	5A	1782	DECB
F968	26DD	1783	BNE SUM
		1784	
		1785	* now find average & normalise
F96A	33	1786	PULB
F96B	54	1787	SKALE LSRB
F96C	270F	1788	BEQ SCALED
F96E	37	1789	PSHB
F96F	DC58	1790	LDD PATPHS
F971	47	1791	ASRA
F972	56	1792	RORB
F973	DD58	1793	STD PATPHS
F975	965A	1794	LDAA PATPHS+2
F977	46	1795	RORA
F978	975A	1796	STAA PATPHS+2
F97A	33	1797	PULB
F97B	20EE	1798	BRA SKALE
F97D	DC59	1799	SCALED LDD PATPHS+1
F97F	DD58	1800	STD PATPHS
F981	39	1801	RTS

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		2159 *	*****
		2160 *	SUBROUTINE ADD1
		2161 *	*****
		2162	
		2163 *	Subroutine ADD1 adds the mantissa of the addend
		2164 *	at the address specified by the X reg to
		2165 *	that of the augend in MANT,EXP,SIGN &
		2166 *	stores the result in MANT,EXP,SIGN
		2167	
FB0D 4F		2168 ADD1	CLRA
FB0E 9684		2169 ADD2	LDA MANT+2
FB10 A902		2170	ADCA 2,X
FB12 9784		2171	STAA MANT+2
FB14 9683		2172	LDA MANT+1
FB16 A901		2173	ADCA 1,X
FB18 9783		2174	STAA MANT+1
FB1A 9682		2175	LDA MANT
FB1C A900		2176	ADCA 0,X
FB1E 9782		2177	STAA MANT
FB20 39		2178	RTS
		2179	
		2180 *	*****
		2181 *	SUBROUTINE SUB1
		2182 *	*****
		2183	
		2184 *	Subroutine SUB1 subtracts the mantissa of the
		2185 *	subtrahend at the address specified by the X reg
		2186 *	from that of the minuend in
		2187 *	MANT,EXP,SIGN & stores the result in MANT,EXP,SIGN
		2188	
FB21 4F		2189 SUB1	CLRA
FB22 9684		2190	LDA MANT+2
FB24 A202		2191	SBCA 2,X
FB26 9784		2192	STAA MANT+2
FB28 9683		2193	LDA MANT+1
FB2A A201		2194	SBCA 1,X
FB2C 9783		2195	STAA MANT+1
FB2E 9682		2196	LDA MANT
FB30 A200		2197	SBCA 0,X
FB32 9782		2198	STAA MANT
FB34 39		2199	RTS

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		2201 *	*****
		2202 *	SUBROUTINE MOVE
		2203 *	*****
		2204	
		2205 *	Subroutine MOVE transfers the 3 bytes at
		2206 *	RELREG to MANT.
		2207	
FB35	967F	2208 MOVE	LDAA RELREG
FB37	9782	2209	STAA MANT
FB39	9680	2210	LDAA RELREG+1
FB3B	9783	2211	STAA MANT+1
FB3D	9681	2212	LDAA RELREG+2
FB3F	9784	2213	STAA MANT+2
FB41	39	2214	RTS
		2215	
		2216 *	*****
		2217 *	SUBROUTINE MULT
		2218 *	*****
		2219	
		2220 *	The multiplicand at MANT,EXP,SIGN is
		2221 *	multiplied by the multiplier, the address of which
		2222 *	is specified by the X reg.
		2223	
FB42	A604	2224 MULT	LDAA 4,X test sign of multiplier
FB44	2A03	2225	BPL MULTP
FB46	730086	2226	COM SIGN change sign
FB49	BDFBAC	2227 MULTP	JSR ZTST test if multiplicand=0
FB4C	5F	2228	CLRB
FB4D	077F	2229	STAB RELREG clear RELREG
FB4F	D780	2230	STAB RELREG+1
FB51	0781	2231	STAB RELREG+2
FB53	C618	2232	LDAB #24 B contains shift count
FB55	740082	2233	LSR MANT shift mantissa of multiplicand
FB58	760083	2234	ROR MANT+1 ...to right 1 bit with
FB5B	760084	2235	ROR MANT+2 ...ls bit into carry
FB5E	2412	2236 M1	BCC SHFT carry=1?
FB60	A602	2237	LDAA 2,X Yes, add mantissa of
FB62	9B81	2238	ADDA RELREG+2 ...multiplier to form partial result
FB64	9781	2239	STAA RELREG+2
FB66	A601	2240	LDAA 1,X
FB68	9980	2241	ADCA RELREG+1
FB6A	9780	2242	STAA RELREG+1
FB6C	A600	2243	LDAA 0,X
FB6E	997F	2244	ADCA RELREG
FB70	977F	2245	STAA RELREG
FB72	76007F	2246 SHFT	ROR RELREG No, shift mantissa of partial
FB75	760080	2247	ROR RELREG+1 ...result & multiplicand
FB78	760081	2248	ROR RELREG+2 ...to right 1 bit
FB7B	760082	2249	ROR MANT
FB7E	760083	2250	ROR MANT+1

LOCATION	OBJECT CODE	LINE	SOURCE LINE
FB81	760084	2252	ROR MANT+2
FB84	5A	2253	DECB continue until shift count=0
FB85	2607	2254	BNE M1
FB87	A603	2255	LDAA 3,X
FB89	9885	2256	ADDA EXP add exponents
FB8B	2926	2257	BVS Z1 check for 2's compliment overflow
FB8D	9785	2258	STAA EXP
FB8F	967F	2259	LDAA RELREG test if result is normalised
FB91	2B11	2260	BMI M2
FB93	790082	2261	ROL MANT rotate left to normalise
FB96	790081	2262	ROL RELREG+2
FB99	790080	2263	ROL RELREG+1
FB9C	79007F	2264	ROL RELREG
FB9F	7A0085	2265	DEC EXP
FBA2	290F	2266	BVS Z1 check for 2's complement overflow
FBA4	BDFB35	2267 M2	JSR MOVE transfer mantissa of result
FBA7	9682	2268	LDAA MANT to locations MANT
FBA9	2708	2269	BEQ Z1 check if result=0
FBAB	39	2270	RTS
		2271	
		2272 *	*****
		2273 *	SUBROUTINE ZTST
		2274 *	*****
		2275	
		2276 *	Subroutine ZTST tests if the 1st operand=0
		2277 *	in which case the operation (multiplication,
		2278 *	division, or square root, is bypassed & the
		2279 *	result is left as 0
		2280	
FBAC	9682	2281 ZTST	LDAA MANT
FBAE	2602	2282	BNE R1
FBB0	31	2283	INS
FBB1	31	2284	INS
FBB2	39	2285 R1	RTS
FBB3	7EFAB5	2286 Z1	JMP ZERO

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		2288 *	*****
		2289 *	SUBROUTINE GET
		2290 *	*****
		2291	
		2292 *	Transfers 5 bytes of data from
		2293 *	locations specified by the X reg, to
		2294 *	MANT,EXP,SIGN
		2295	
FBB6	A600	2296 GET	LDAA 0,X
FBB8	9782	2297	STAA MANT
FBBA	A601	2298	LDAA 1,X
FBBC	9783	2299	STAA MANT+1
FBBE	A602	2300	LDAA 2,X
FBC0	9784	2301	STAA MANT+2
FBC2	A603	2302	LDAA 3,X
FBC4	9785	2303	STAA EXP
FBC6	A604	2304	LDAA 4,X
FBC8	9786	2305	STAA SIGN
FBCA	39	2306	RTS
		2307	
		2308 *	*****
		2309 *	SUBROUTINE GET1
		2310 *	*****
		2311	
		2312 *	Transfers 3 bytes of data from location specified
		2313 *	by the X reg to RELREG.
		2314	
FBCB	E600	2315 GET1	LDAB 0,X
FBCD	D77F	2316	STAB RELREG
FBCF	E601	2317	LDAB 1,X
FBD1	D780	2318	STAB RELREG+1
FBD3	E602	2319	LDAB 2,X
FBD5	D781	2320	STAB RELREG+2
FBD7	39	2321	RTS

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		2323 *	*****
		2324 *	SUBROUTINE SAVE
		2325 *	*****
		2326	
		2327 *	Transfers 4 bytes of data
		2328 *	from MANT,EXP to locations specified
		2329 *	by the X reg.
FBDB	9682	2330	SAVE LDAA MANT
FBDA	A700	2331	STAA 0,X
FBDC	9683	2332	LDAA MANT+1
FBDE	A701	2333	STAA 1,X
FBE0	9684	2334	LDAA MANT+2
FBE2	A702	2335	STAA 2,X
FBE4	9685	2336	LDAA EXP
FBE6	A703	2337	STAA 3,X
FBE8	9686	2338	LDAA SIGN
FBEA	A704	2339	STAA 4,X
FBEC	39	2340	RTS
		2341	
		2342 *	*****
		2343 *	SUBROUTINE FLFPXD
		2344 *	*****
		2345	
		2346 *	Floating to fixed point conversion.
		2347 *	The floating point # is at MANT,EXP,SIGN.
		2348 *	The fixed point variable consists of an integer
		2349 *	part at INTBIN,(3 bytes), followed by a fractional
		2350 *	part at FRBIN,(3 bytes). The format is INTBIN.FRBIN.
		2351 *	The exponent of the floating point word is to be
		2352 *	less than or equal to 24.
FBED	B0FA9B	2353	FLFPXD JSR NORM normalise
FBF0	D685	2354	LDAB EXP
FBF2	4F	2355	CLRA clear fractional part
FBF3	9785	2356	STAA FRBIN of the fixed point
FBF5	9786	2357	STAA FRBIN+1 variable
FBF7	9787	2358	STAA FRBIN+2
FBF9	C180	2359	CMPB #080H small flp value?
FBFB	2719	2360	BEQ FLP2 yes, stop conversion
FBFD	C018	2361	SUBB #24 B fixes the # of right
FBFF	2715	2362	BEQ FLP2 rotations
FC01	740082	2363	FLP1 LSR INTBIN
FC04	760083	2364	ROR INTBIN+1
FC07	760084	2365	ROR INTBIN+2
FC0A	760085	2366	ROR FRBIN
FC0D	760086	2367	ROR FRBIN+1
FC10	760087	2368	ROR FRBIN+2
FC13	5C	2369	INCB
FC14	26EB	2370	BNE FLP1
FC16	39	2371	FLP2 RTS

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		2373 *	*****
		2374 *	SUBROUTINE BINBCD
		2375 *	*****
		2376	
		2377 *	A 3 byte binary word is to be converted
		2378 *	to a maximum 7 byte bcd word
		2379 *	Binary word stored in INTBIN (3 bytes)
		2380 *	SAVEX2 stores the pointer for the bcd destination
		2381 *	string.
		2382 *	1st byte in the bcd string (the ms byte) can
		2383 *	be a digit, a blank (code 0F), or a
		2384 *	-ve sign (code 0A)
		2385	
		2386 *	SAVEX3 stores the pointer for the conversion constants
		2387 *	If converting an integer, the X reg should be
		2388 *	loaded with CNST6 & ACCB with 7 before entering
		2389 *	the subroutine.
		2390	
		2391 *	If converting a binary fractional value the X reg
		2392 *	should be loaded with CNST01 &
		2393 *	ACCB with 4 before entering the subroutine.
		2394	
FC17 DF89		2395 BINBCD STX	SAVEX3 save pointer for constants
FC19 D791		2396 STAB	COUNT1
FC1B 5F		2397 BINC2 CLRB	
FC1C DE89		2398 LDX	SAVEX3
FC1E 5C		2399 BINC1 INCB	
FC1F BDFB21		2400 JSR	SUB1 binary=(binary)-constant
FC22 24FA		2401 BCC	BINC1 binary>constant
FC24 5A		2402 DECB	
FC25 BDFB0D		2403 JSR	ADD1 restore binary
FC28 08		2404 INX	point to next constant
FC29 08		2405 INX	
FC2A 08		2406 INX	
FC2B DF89		2407 STX	SAVEX3 save pointer
FC2D DE8B		2408 LDX	SAVEX2 pointer for bcd variable
FC2F E700		2409 STAB	0,X store bcd in destination string
FC31 7A0091		2410 DEC	COUNT1
FC34 2705		2411 BEQ	BINC3 if zero conversion finished
FC36 08		2412 INX	point to next bcd string
FC37 DF8B		2413 STX	SAVEX2 & save pointer
FC39 20E0		2414 BRA	BINC2 repeat
FC3B 39		2415 BINC3 RTS	
		2416	
		2417 *	these constants are used by BINBCD
		2418	
FC3C 0F4240		2419 CNST6 FCB	00FH,042H,040H 1000,000
FC3F 0186A0		2420 CNST5 FCB	001H,086H,0A0H 100,000
FC42 002710		2421 CNST4 FCB	000H,027H,010H 10,000
FC45 0003EB		2422 CNST3 FCB	000H,003H,0EBH 1,000

LOCATION	OBJECT CODE	LINE	SOURCE LINE
FC48	000064	2424	CNST2 FCB 000H,000H,064H 100
FC48	00000A	2425	CNST1 FCB 000H,000H,00AH 10
FC4E	000001	2426	CNST0 FCB 000H,000H,001H 1
FC51	199999	2427	CNST01 FCB 019H,099H,099H 0,1
FC54	028F5C	2428	CNST02 FCB 002H,08FH,05CH 0,01
FC57	004189	2429	CNST03 FCB 000H,041H,089H 0,001
FC5A	00068D	2430	CNST04 FCB 000H,006H,08DH 0,0001
		2431	
		2432 *	*****
		2433 *	SUBROUTINE STRING
		2434 *	*****
		2435	
		2436 *	Transfers blocks of data
		2437 *	from a source to a destination string.
		2438 *	SAVEX2 stores the pointer of source string
		2439 *	SAVEX3 stores the pointer of destination string
		2440 *	ACCB dictates # of bytes to be transferred.
		2441 *	The above registers are initialised before
		2442 *	entering this routine.
		2443	
FC5D	DE8B	2444	STRING LDX SAVEX2
FC5F	A600	2445	LDA 0,X source data
FC61	08	2446	INX
FC62	DF8B	2447	STX SAVEX2
FC64	DE89	2448	LDX SAVEX3 transferred to destination
FC66	A700	2449	STAA 0,X string data
FC68	08	2450	INX
FC69	DF89	2451	STX SAVEX3
FC6B	5A	2452	DECB dec counter
FC6C	26EF	2453	BNE STRING
FC6E	39	2454	RTS !
		2455	
		2456 *	*****
		2457 *	SUBROUTINE DFLOAT
		2458 *	*****
		2459	
		2460 *	Auto ranges & prepares a flp number for display
		2461 *	Number must be in range -999999,+9999999 (-10^6 to 10^7)
		2462 *	entry; number in MANT,EXP,SIGN
		2463 *	ACCB contains max # d.places to be displayed
		2464 *	exit; bcd DBUF1, DPNT1 set up, DPNT2 switched off
		2465	
		2466 *	Set left most dec point
FC6F	7F009F	2467	DFLOAT CLR DPNT1
FC72	D7A0	2468	STAB DPNT2 (scratch!)
		2469	
		2470 *	WHILE max d.places not exceeded & -
FC74	D6A0	2471	SCALE LDAB DPNT2
FC76	D09F	2472	SUBB DPNT1
FC78	2F1B	2473	BLE NOMORE

LOCATION	OBJECT CODE	LINE	SOURCE LINE
		2475	* AND WHILE value*10 < full scale DO.
FC7A	CEFCF3	2476	LDX #FLP6
FC7D	7D0086	2477	TST SIGN
FC80	2703	2478	BEQ DECIDE
FC82	CEFCF8	2479	LDX #FLP5 (1 less dig available IF-)
FC85	BDFCDA	2480	DECIDE JSR CMPARE
FC88	2408	2481	BHS NOMORE
		2482	
		2483	* .shift d.point left & multiply value by ten
FC8A	7C009F	2484	INC DPNT1
FC8D	CEFD02	2485	LDX #TEN
FC90	BDFB42	2486	JSR MULT
		2487	
		2488	* REP
FC93	20DF	2489	BRA SCALE
FC95	86FF	2490	NOMORE LDAA #0FFH clear 2nd point
FC97	97A0	2491	STAA DPNT2
FC99	9686	2492	LDAA SIGN save the sign
FC9B	36	2493	PSHA
		2494	
		2495	* now round & display the ranged result
FC9C	9682	2496	LDAA MANT IF any danger of overflow.
FC9E	8118	2497	CMPA #24
FCA0	2C09	2498	BGE NOROND ..THEN don't round (error 10E-6)
FCA2	CEFCFD	2499	LDX #CP5
FCA5	7F0086	2500	CLR SIGN
FCA8	BDF448	2501	JSR ADD ..ELSE round
FCA8	BDFBED	2502	NOROND JSR FLPPFXD convert to binary...
FCAE	CE0094	2503	LDX #DBUF1 ...THEN to bcd
FCB1	DF88	2504	STX SAVEX2
FCB3	CEFC3C	2505	LDX #CNST6
FCB6	C607	2506	LDAB #7
FCB8	BDFC17	2507	JSR BINBCD
		2508	
		2509	* IF -ve THEN include '-'
FCB8	32	2510	PULA
FCBC	4D	2511	TSTA
FCBD	271A	2512	BEQ DFLOUT
FCBF	8606	2513	LDAA #6 place '-' just before 1st dig
FCC1	CE0094	2514	LDX #DBUF1
FCC4	4A	2515	FIND DECA
FCC5	919F	2516	CMPA DPNT1 only 1 dig before point?
FCC7	270C	2517	BEQ PUTINX
FCC9	6D01	2518	TST 1,X is next dig a 0?
FCCB	2608	2519	BNE PUTINX
FCCD	8C0099	2520	CPX #DBUF1+5 only 1 more dig in buffer?
FCD0	2703	2521	BEQ PUTINX
FCD2	08	2522	INX
FCD3	20EF	2523	BRA FIND
FCD5	8640	2524	PUTINX LDAA #040H
FCD7	A700	2525	STAA 0,X
FCD9	39	2526	DFLOUT RTS

LOCATION	OBJECT CODE LINE	SOURCE LINE
	2528	* Local SUBROUTINE CMPARE
	2529	
	2530	* Compare MANT,EXP with (X-reg) - both normalised
FCDA 9685	2531	CMPARE LDAA EXP
FCDC A103	2532	CMPA 3,X
FCE0 2608	2533	BNE MODIFY
FCE0 DC82	2534	LOD MANT
FCE2 A300	2535	SUBD 0,X
FCE4 2604	2536	BNE CMPD
FCE6 9684	2537	LDAA MANT+2
FCE8 A102	2538	CMPA 2,X
FCEA 39	2539	CMPD RTS
FCEB 2E03	2540	MODIFY BGT BIGGER modify so unsigned test may be used (BMS)
FCE0 0D	2541	SEC
FCEE 20FA	2542	BRA CMPD
FCF0 0C	2543	BIGGER CLC
FCF1 20F7	2544	BRA CMPD
	2545	
FCF3 F424001400	2546	FLP6 FCB 0F4H,024H,000H,014H,0 1000000
FCF8 C350001100	2547	FLP5 FCB 0C3H,050H,000H,011H,0 100000
FCFD 8000000000	2548	CPS FCB 080H,000H,000H,000H,0 0,50
FD02 A000000400	2549	TEN FCB 0A0H,000H,000H,004H,0 10,00
	2550	
	2551	END

Errors= 0